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**DAC3484** 

SLAS749E - MARCH 2011 - REVISED NOVEMBER 2015

# DAC3484 Quad-Channel, 16-Bit, 1.25 GSPS Digital-to-Analog Converter (DAC)

#### 1 Features

- Very Low Power: 1.27 W at 1.25 GSPS, Full Operating Conditions
- Multi-DAC Synchronization
- Selectable 2x, 4x, 8x, 16x Interpolation Filter
  - Stop-Band Attenuation > 90 dBc
- Flexible On-chip Complex Mixing
  - Two Independent Fine Mixers with 32-Bit NCOs
  - Power Saving Coarse Mixers: ± nxFs/8
- High Performance, Low Jitter Clock Multiplying PLL
- · Digital I and Q Correction
  - Gain, Phase, Offset, and Group Delay Correction
- · Digital Inverse Sinc Filter
- Flexible 16-Bit LVDS Input Data Bus
  - 8 Sample Input FIFO
  - Data Pattern Checker
  - Parity Check
  - GC5330 Compatible
- Temperature Sensor
- Differential Scalable Output: 10 mA to 30 mA
- Multiple Package Options: 88-Pin 9x9mm WQFN and 196-Ball 12mmx12mm NFBGA (GREEN / Pb-Free)

## 2 Applications

- Cellular Base Stations
- Diversity Transmit
- · Wideband Communications

### 3 Description

The DAC3484 is a very low power, high dynamic range, quad-channel, 16-bit digital-to-analog converter (DAC) with a sample rate as high as 1.25 GSPS.

The device includes features that simplify the design of complex transmit architectures: 2x to 16x digital interpolation filters with over 90dB of stop-band attenuation simplify the data interface reconstruction filters. Independent complex mixers allow flexible carrier placement. A high-performance low jitter clock multiplier simplifies clocking of the device without significant impact on the dynamic range. The digital Quadrature Modulator Correction (QMC) enables complete IQ compensation for gain, offset, phase and group delay between channels in direct up-conversion applications.

Digital data is input to the device through a 16-bit LVDS data bus with on-chip termination. The device includes a FIFO, data pattern checker and parity test to ease the input interface. The interface also allows full synchronization of multiple devices.

The device is characterized for operation over the entire industrial temperature range of -40°C to 85°C and is available in a very-small 88-pin 9x9mm WQFN package or 196-ball 12x12mm NFBGA package.

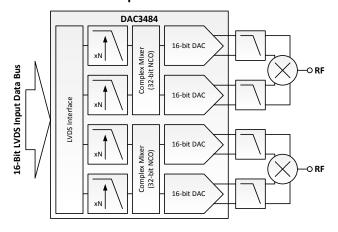
Very low power, small size, superior crosstalk, high dynamic range and features of the DAC3484 are an ideal fit for systems with multiple transmit channels.

### **Device Information**(1)

| PART NUMBER | PACKAGE     | BODY SIZE (NOM)     |  |  |
|-------------|-------------|---------------------|--|--|
| DAC2494     | WQFN (88)   | 9.00 mm x 9.00 mm   |  |  |
| DAC3484     | NFBGA (196) | 12.00 mm x 12.00 mm |  |  |

(1) For all available packages, see the orderable addendum at the end of the data sheet

#### **Simplified Schematic**





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### 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

### Changes from Revision D (September 2015) to Revision E

**Page** 

Added ESD Ratings table. Feature Description section. Device Functional Modes. Application and Implementation

#### Changes from Revision C (August 2012) to Revision D

Page

|   | section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section.  | 1    |
|---|---|------|
| • | Added 196-ball 12x12mm BGA package to Description   | 1    |
| • | Added additional operation requirement for SLEEP pin if SLEEP pin is set to logic HIGH before and during device power up and initialization.                            | 7    |
| • | Added additional circuit configuration for unused terminals - IOUTAP/N, IOUTBP/N, IOUTCP/N, IOUTDP/N  | 9    |
| • | Added additional operation requirement for SLEEP pin if SLEEP pin is set to logic HIGH before and during device power up and initialization.                            | . 10 |
| • | Changed DACCLKP/N Differential voltage TYP value from 1.0 V to 0.8 V  | . 14 |
| • | Changed the parameter name Single-Ended Swing Level to Single-Ended Input Level to better reflect the specification for minimum recommended single-ended voltage level. | . 14 |
| • | Changed OSTRP/N Differential voltage TYP value from 1.0 V to 0.8 V  | . 14 |
|   |   |      |

Changed the parameter name Single-Ended Swing Level to Single-Ended Input Level to better reflect the

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|---|---|----|---|---|---|

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|----|--|---------|
| •  | Added Note to Input FIFO section   | 33      |
| •  | Added LMK0480x family to Input FIFO section  | 33      |
| •  | Changed text in Single Sync Source Mode to clarify the latency limitation of Single Sync Source Mode   |         |
| •  | Added the effect of bypassing the FIFO in the Bypass Mode section to clarify the operation of the FIFO, LVDS FRAME, and LVDS SYNC in FIFO Bypass Mode. |         |
| •  | Added package information for LPF pin in PLL Mode section  |         |
| •  | Changed table reference in FIR Filters section   |         |
| •  | Added text to Data Pattern Checker section with additional operating recommendations   |         |
| •  | Added reference to application report in DAC3484 Alarm Monitoring section  |         |
| •  | Added note to Figure 80  |         |
| •  | Added Unused LVDS Port Termination section   |         |
| •  | Changed information to Multi-Device Operation: Single Sync Source mode section to clarify the latency limitation of Single Sync Source Mode.           |         |
| •  | Changed Figure 90 to clarify the latency limitation of Single Sync Source Mode   |         |
| •  | Changed the NCO setting description in the Example Start-up Sequence Section to reflect the example register write                                     |         |
| •  | Added A32 to A32 for DAC3484IRKD and N9 for DAC3484IZAY in register config3 bit 0 description  |         |
| •  | Changed alarm_lparity to alarm_fparity in register config7   | 72      |
| •  | Changed QMC offset registers to QMC correction registers in register config16  |         |
| •  | Added SLEEP pin information to register config27 bit 11  |         |
| •  | Changed 1.2VDIG to DIGVDD in register config27 bits 5:0  |         |
| •  | Changed 1.2VCLK to CLKVDD in register config27 bits 5:0  | 77      |
| •  | Added pin description for both packages in register config35   | 80      |
| •  | Added reference to Digital Input Timing Specifications Table in register config36  | 80      |
| •  | Added text to register config45 bit 0 description  | 81      |
| CI | hanges from Revision B (February) to Revision C  | Page    |
| •  | Deleted T <sub>J</sub> row from top of thermal table   | 2       |
| •  | Added thermal information to the Absolute Maximum Ratings table  | 11      |
| •  | Added Recommended Operating Conditions table   | 11      |
| •  | Deleted T <sub>J</sub> row from top of thermal table   | 12      |
| •  | Deleted OPERATING RANGE section from bottom of Electrical Characteristics – DC Specifications table  | 13      |
|    |  |         |
| CI | hanges from Revision A (July 2011) to Revision B   | Page    |
| •  | Changed the revision from A, July 2011 to B, June 2012   | 1       |
| •  | Changed Package options in FEATURES  | 1       |
| •  | Added ZAY package information to Thermal Information   | 2       |
| •  | Added ZAY package  | 8       |
| •  | Added ZAY pin functions  | 9       |
| •  | Added ZAY package information to Thermal Information   |         |
| •  | Added Input Common Mode max value of 1.6V  |         |
| •  | Added information to CLOCK INPUT (DACCLKP/N) in Electrical Characteristics - Digital Specifications  | 14      |
| •  | Added information to OUTPUT STROBE (OSTRP/N) in Electrical Characteristics - Digital Specifications  | 14      |
| •  | Changed Electrical Characteristics – AC Specifications AC Performance information  | 15      |
| •  | Changed Figure 21  |         |
| •  | Changed Figure 22  | 20      |
| _  | Changed Figure 22  | 20      |
| •  | Changed Figure 23  | 20      |



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|----|---|------------|
| •  | Added Figure 48   | 24         |
|    | Added Figure 49   |            |
|    | Changed config 3 to config9 in Input FIFO section   |            |
|    | Added information for double-charge-pump current to PLL MODE section  |            |
|    | Changed Figure 71   |            |
|    | Changed +3.75 to -3.75 degrees in 1024 steps to +26.5 to -26.5 degrees in 4096 steps in GAIN AND PHASE CORRECTION section |            |
| •  | Added dual channel mode enable information to POWER-UP SEQUENCE step 6  | 62         |
| •  | Changed config1, bit 8 in Table 11  | 66         |
| •  | Changed config16, bits 13:12 in Table 11  | 66         |
| •  | Changed register config1, bit8 from Reserved to quad_ena  | 69         |
| •  | Changed register config16, bits 13:12 from reserved to dual_ena (1:0)   | 74         |
|    |   |            |
| CI | hanges from Original (March 2011) to Revision A   | Page       |
| •  | Changed from PRODUCT PREVIEW to PRODUCTION DATA   | 1          |



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## 5 Pin Configuration and Functions

**RKD Package** 88-Pin WQFN **Top View** C4 6 A 39 A38 A37 A36 A35 A35 A35 A35 A35 A35 A35 A40 B39 B35 LPF A33 [ **BIASJ** B30 **PLLAVDD RESETB OSTRP** A32 **TXENABLE** B2 **OSTRN** B29 **ALARM** DACCLKP **SCLK** A3 A31 DACCLKN □ B3 B28 **SDENB** SDIO **CLKVDD** ☐ A4 A30 [ **VFUSE** B27 SDO **SYNCP PARITYN** A5 A29 **SYNCN** B26 **PARITYP DAC3484** DIGVDD \_ A6 A28 DIGVDD 88-WQFN 9mm x 9mm IOVDD IOVDD B6 B25 D15P Α7 D0N A27 D15N □ B7 D<sub>0</sub>P B24 D14P D1N Α8 A26 [ D14N □ B8 D1P B23 **DIGVDD** Α9 **DIGVDD** A25 D13P ■ B9 B22 D2N D13N A10 A24 D2P ☐ B10 D12P B21 D3N \_\_ A11 D12N A23 D3P 15 B14 B12 B16 B18 **B** В **B B** СЗ C2 FRAMEN D7P D7N D6P D6N D5N D5N D9P D9N D8P D8N DATACLKP IOVDD DATACLKN FRAMEP

### **Pin Functions - WQFN**

| P      | PIN  |     | PIN   |  | DECORIDATION |  |  |  |  |
|--------|--|-----|---|--|--------------|--|--|--|--|
| NAME   | NO.  | 1/0 | DESCRIPTION   |  |              |  |  |  |  |
| AVDD   | A36, A37,<br>A38, A40,<br>A41, A42,<br>B31 | 1   | Analog supply voltage. (3.3 V)  |  |              |  |  |  |  |
| ALARM  | B29  | 0   | CMOS output for ALARM condition. The ALARM output functionality is defined through the <i>config7</i> register. Default polarity is active high, but can be changed to active low via <i>config0 alarm_out_pol</i> control bit. |  |              |  |  |  |  |
| BIASJ  | A33  | 0   | Full-scale output current bias. For 30-mA full-scale output current, connect 1.28 k $\Omega$ to ground. Change the full-scale output current through $coarse\_dac(3:0)$ in $config3$ , $bit<15:12>$                             |  |              |  |  |  |  |
| CLKVDD | A4   | I   | Internal clock buffer supply voltage. (1.2 V) It is recommended to isolate this supply from DIGVDD and DACVDD.  |  |              |  |  |  |  |

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### Pin Functions - WQFN (continued)

| Р        | IN  |     | Fill Fullctions - Wat N (continued)   |  |  |  |  |  |
|----------|---|-----|---|--|--|--|--|--|
| NAME NO. |   | 1/0 | DESCRIPTION   |  |  |  |  |  |
|          | A7, A8, B9,<br>B10, A12,  |     | LVDS positive input data bits 0 through 15. Internal 100-Ω termination resistor. Data format relative to DATACLKP/N clock is Double Data Rate (DDR).  |  |  |  |  |  |
| D[150]P  | A13, A14,<br>A15, B17,<br>B18, B19,   | I   | D15P is most significant data bit (MSB)  D0P is least significant data bit (LSB)  |  |  |  |  |  |
|          | B20, A23,<br>A24, B23,<br>B24   |     | The order of the bus can be reversed via config2 revbus bit.  |  |  |  |  |  |
| D[150]N  | B7, B8, A10,<br>A11, B11,<br>B12, B13,<br>B14, A19,<br>A20, A21,<br>A22, B21,<br>B22, A26,<br>A27 | I   | LVDS negative input data bits 0 through 15. (See D[15:0]P description above)  |  |  |  |  |  |
| DACCLKP  | А3  | - 1 | Positive external LVPECL clock input for DAC core with a self-bias.   |  |  |  |  |  |
| DACCLKN  | В3  | I   | Complementary external LVPECL clock input for DAC core. (see the DACCLKP description)   |  |  |  |  |  |
| DACVDD   | A35, A39,<br>A43  | I   | DAC core supply voltage. (1.2 V). It is recommended to isolate this supply from CLKVDD and DIGVDD.  |  |  |  |  |  |
| DATACLKP | A16   | I   | LVDS positive input data clock. Internal 100 $\Omega$ termination resistor. Input data D[15:0]P/N is latched on both edges of DATACLKP/N (Double Data Rate).  |  |  |  |  |  |
| DATACLKN | B15   | I   | LVDS negative input data clock. (See DATACLKP description)  |  |  |  |  |  |
| DIGVDD   | A6, A9, A25,<br>A28   | I   | Digital supply voltage. (1.2 V). It is recommended to isolate this supply from CLKVDD and DACVDD.   |  |  |  |  |  |
| EXTIO    | A34   | I/O | Used as external reference input when internal reference is disabled through <i>config27</i> extref_ena = 1b. Used as internal reference output when <i>config27</i> extref_ena = 0b (default). Requires a 0.1-µF decoupling capacitor to AGND when used as reference output.   |  |  |  |  |  |
| FRAMEP   | B16   | I   | LVDS frame indicator positive input. Internal 100-Ω termination resistor.  The main functions of this input are to reset the FIFO pointer or to be used as a syncing source. These two functions are captured with the rising edge of DATACLKP/N. The signal captured by the falling edge of DATACLKP/N can be used as a block parity bit. The FRAMEP/N signal should be edge-aligned with D[15:0]P/N.  Additionally it is used to indicate the beginning of the frame. |  |  |  |  |  |
| FRAMEN   | A18   | ı   | LVDS frame indicator negative input. (See the FRAMEP description)   |  |  |  |  |  |
| GND      | C1, C2, C3,<br>C4, Thermal<br>Pad   | I   | These pins are ground for all supplies.   |  |  |  |  |  |
| IOUTAP   | B39   | 0   | A-Channel DAC current output. Connect directly to ground if unused.   |  |  |  |  |  |
| IOUTAN   | B38   | 0   | A-Channel DAC complementary current output. Connect directly to ground if unused.   |  |  |  |  |  |
| IOUTBP   | B36   | 0   | B-Channel DAC current output. Connect directly to ground if unused.   |  |  |  |  |  |
| IOUTBN   | B37   | 0   | B-Channel DAC complementary current output. Connect directly to ground if unused.   |  |  |  |  |  |
| IOUTCP   | B35   | 0   | C-Channel DAC current output. Connect directly to ground if unused.   |  |  |  |  |  |
| IOUTCN   | B34   | 0   | C-Channel DAC complementary current output. Connect directly to ground if unused.   |  |  |  |  |  |
| IOUTDP   | B32   | 0   | D-Channel DAC current output. Connect directly to ground if unused.   |  |  |  |  |  |
| IOUTDN   | B33   | 0   | D-Channel DAC complementary current output. Connect directly to ground if unused.   |  |  |  |  |  |
| IOVDD    | B6, A17, B25  | I   | Supply voltage for all digital I/O. (3.3 V)   |  |  |  |  |  |
| LPF      | A1  | I/O | PLL loop filter connection. If not using the clock multiplying PLL, the LPF pin can be left unconnected   |  |  |  |  |  |
| OSTRP    | A2  | I   | LVPECL output strobe positive input. This positive/negative pair is captured with the rising edge of DACCLKP/N. It is used for multiple DAC synchronization. If unused it can be left unconnected.  |  |  |  |  |  |
| OSTRN    | B2  | I   | LVPECL output strobe negative input. (See the OSTRP description)  |  |  |  |  |  |
| PARITYP  | B26   | I   | Optional LVDS positive input parity bit. The PARITYP/N LVDS pair has an internal 100 $\Omega$ termination resistor. If unused it can be left unconnected.   |  |  |  |  |  |
| PARITYN  | A29   | I   | Optional LVDS negative input parity bit.  |  |  |  |  |  |
| PLLAVDD  | B1  | I   | PLL analog supply voltage. (3.3 V)  |  |  |  |  |  |

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### Pin Functions - WQFN (continued)

| PIN      |     | - 1/0 | DESCRIPTION  |  |  |  |  |
|----------|-----|-------|--|--|--|--|--|
| NAME     | NO. | 1/0   | DESCRIPTION  |  |  |  |  |
| SCLK     | A31 | I     | Serial interface clock. Internal pull-down.  |  |  |  |  |
| SDENB    | B28 | I     | Active low serial data enable, always an input to the DAC3484. Internal pull-up.   |  |  |  |  |
| SDIO     | A30 | I/O   | Serial interface data. Bi-directional in 3-pin mode (default) and uni-directional 4-pin mode. Internal pull-down.  |  |  |  |  |
| SDO      | B27 | 0     | Uni-directional serial interface data in 4-pin mode. The SDO pin is tri-stated in 3-pin interface mode (default).  |  |  |  |  |
| SLEEP    | B40 | I     | Active high asynchronous hardware power-down input. Internal pull-down. If SLEEP pin is set to logic HIGH before and during device power-up and initialization, the fuse_sleep bit in register 0x1B, bit 11 must be written after register 0x23 during device initialization register setup.   |  |  |  |  |
| SYNCP    | A5  | I     | Optional LVDS SYNC positive input. The SYNCP/N LVDS pair has an internal 100-Ω termination resistor. If unused it can be left unconnected.   |  |  |  |  |
| SYNCN    | B5  | I     | Optional LVDS SYNC negative input.   |  |  |  |  |
| RESETB   | B30 | I     | Active low input for chip RESET, which resets all the programming registers to their default state. Internal pull-up.  |  |  |  |  |
| TXENABLE | A32 | I     | Transmit enable active high input. Internal pull-down.  To enable analog output data transmission, set <i>sif_txenable</i> in register <i>config3</i> to 1b <b>or</b> pull CMOS TXENABLE pin to high.  To disable analog output, set <i>sif_txenable</i> to 0b <b>and</b> pull CMOS TXENABLE pin to low. The DAC output is forced to midscale. |  |  |  |  |
| TESTMODE | A44 | I     | This pin is used for factory testing. Internal pull-down. Leave unconnected for normal operation.  |  |  |  |  |
| VFUSE    | B4  | I     | Digital supply voltage. This supply pin is also used for factory fuse programming. Connect to DACVDD for normal operation.   |  |  |  |  |



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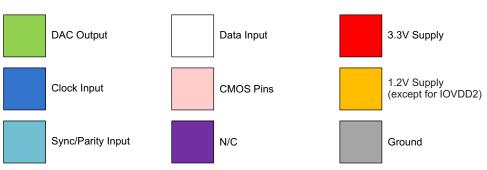
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#### ZAY Package 196-Pin NFBGA Top View

|    | Α            | В          | С           | D           | Е          | F          | G            | Н          | J          | K          | L          | М          | N            | Р           |
|----|--------------|------------|-------------|-------------|------------|------------|--------------|------------|------------|------------|------------|------------|--------------|-------------|
| 14 | GND          | IOUT<br>AP | IOUT<br>AN  | GND         | IOUT<br>BN | IOUT<br>BP | GND          | GND        | IOUT<br>CP | IOUT<br>CN | GND        | IOUT<br>DN | IOUT<br>DP   | GND         |
| 13 | GND          | GND        | GND         | GND         | GND        | GND        | GND          | GND        | GND        | GND        | GND        | GND        | GND          | GND         |
| 12 | DAC<br>CLKP  | GND        | CLK<br>VDD  | LPF         | GND        | GND        | EXTIO        | BIASJ      | GND        | N/C        | N/C        | GND        | ALARM        | SDO         |
| 11 | DAC<br>CLKN  | GND        | PLL<br>AVDD | PLL<br>AVDD | AVDD       | AVDD       | AVDD         | AVDD       | AVDD       | AVDD       | N/C        | GND        | N/C          | SDIO        |
| 10 | GND          | GND        | GND         | AVDD        | DAC<br>VDD | DAC<br>VDD | DAC<br>VDD   | DAC<br>VDD | DAC<br>VDD | DAC<br>VDD | AVDD       | GND        | RESET<br>B   | SDENB       |
| 9  | OS<br>TRP    | OS<br>TRN  | GND         | DAC<br>VDD  | DAC<br>VDD | GND        | GND          | GND        | GND        | DAC<br>VDD | DAC<br>VDD | GND        | TX<br>ENABLE | SCLK        |
| 8  | TEST<br>MODE | SLEEP      | GND         | GND         | GND        | GND        | GND          | GND        | GND        | GND        | GND        | GND        | N/C          | N/C         |
| 7  | N/C          | N/C        | GND         | VFUSE       | DIG<br>VDD | GND        | GND          | GND        | GND        | DIG<br>VDD | N/C        | GND        | N/C          | N/C         |
| 6  | N/C          | N/C        | GND         | IO<br>VDD   | DIG<br>VDD | GND        | GND          | GND        | GND        | DIG<br>VDD | IO<br>VDD  | GND        | N/C          | N/C         |
| 5  | SYNCP        | SYNCN      | GND         | IO<br>VDD   | DIG<br>VDD | DIG<br>VDD | IO<br>VDD    | IO<br>VDD  | DIG<br>VDD | DIG<br>VDD | IO<br>VDD  | GND        | PARITY<br>P  | PARITY<br>N |
| 4  | D15P         | D15N       | N/C         | N/C         | N/C        | N/C        | N/C          | N/C        | N/C        | N/C        | N/C        | N/C        | D0P          | D0N         |
| 3  | D14P         | D14N       | N/C         | N/C         | N/C        | N/C        | N/C          | N/C        | N/C        | N/C        | N/C        | N/C        | D1P          | D1N         |
| 2  | D13P         | D13N       | D11P        | D10P        | D9P        | D8P        | DATA<br>CLKP | FRAME<br>P | D7P        | D6P        | D5P        | D4P        | D2P          | D2N         |
| 1  | D12P         | D12N       | D11N        | D10N        | D9N        | D8N        | DATA<br>CLKN | FRAME<br>N | D7N        | D6N        | D5N        | D4N        | D3P          | D3N         |
| ,  |              |            |             |             |            |            |              |            |            |            |            |            |              |             |



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#### **Pin Functions - NFBGA**

|          | PIN   |     | FIII FUIICIIOIIS - NFBGA  |  |  |  |  |
|----------|---|-----|---|--|--|--|--|
| NAME NO. |   | 1/0 | DESCRIPTION   |  |  |  |  |
| AVDD     | D10, E11, F11, G11,<br>H11, J11, K11, L10   | I   | Analog supply voltage. (3.3 V)  |  |  |  |  |
| ALARM    | N12   | 0   | CMOS output for ALARM condition. The ALARM output functionality is defined through the config7 register. Default polarity is active low, but can be changed to active high via config0 alarm_out_pol control bit.   |  |  |  |  |
| BIASJ    | H12   | 0   | Full-scale output current bias. For 30-mA full-scale output current, connect 1.28 kΩ to ground. Change the full-scale output current through <i>coarse_dac(3:0)</i> in <i>config3</i> , <i>bit</i> <15:12>  |  |  |  |  |
| CLKVDD   | C12   | ı   | Internal clock buffer supply voltage. (1.2 V) It is recommended to isolate this supply from DIGVDD and DACVDD.  |  |  |  |  |
| D[150]P  | N4, N3, N2, N1, M2, L2,<br>K2, J2, F2, E2, D2, C2,<br>A1, A2, A3, A4  | I   | LVDS positive input data bits 0 through 15. Internal 100-Ω termination resistor. Data format relative to DATACLKP/N clock is Double Data Rate (DDR).  D15P is most significant data bit (MSB)  D0P is least significant data bit (LSB)  |  |  |  |  |
| D[150]N  | P4, P3, P2, P1, M1, L1,<br>K1, J1, F1, E1, D1, C1,<br>B1, B2, B3, B4  | I   | The order of the bus can be reversed via <i>config2 revbus</i> bit.  LVDS negative input data bits 0 through 15. (See D[15:0]P description above)   |  |  |  |  |
| DACCLKP  | A12   | I   | Positive external LVPECL clock input for DAC core with a self-bias.   |  |  |  |  |
| DACCLKN  | A11   | I   | Complementary external LVPECL clock input for DAC core. (see the DACCLKP description)   |  |  |  |  |
| DACVDD   | D9, E9, E10, F10, G10,<br>H10, J10, K9, K10, L9   | I   | DAC core supply voltage. (1.2 V). It is recommended to isolate this supply from CLKVE and DIGVDD.   |  |  |  |  |
| DATACLKP | G2  | I   | LVDS positive input data clock. Internal 100-Ω termination resistor. Input data D[15:0]P/N is latched on both edges of DATACLKP/N (Double Data Rate).   |  |  |  |  |
| DATACLKN | G1  | I   | LVDS negative input data clock. (See DATACLKP description)  |  |  |  |  |
| DIGVDD   | E5, E6, E7, F5, J5, K5,<br>K6, K7   | I   | Digital supply voltage. (1.2 V). It is recommended to isolate this supply from CLKVDD and DACVDD.   |  |  |  |  |
| EXTIO    | G12   | I/O | Used as external reference input when internal reference is disabled through <i>config27</i> extref_ena = 1b. Used as internal reference output when <i>config27</i> extref_ena = 0b (default). Requires a 0.1-µF decoupling capacitor to AGND when used as reference output.   |  |  |  |  |
| FRAMEP   | H2  | I   | LVDS frame indicator positive input. Internal 100-Ω termination resistor. The main functions of this input are to reset the FIFO pointer or to be used as a syncing source. These two functions are captured with the rising edge of DATACLKP/N. The signal captured by the falling edge of DATACLKP/N can be used as a block parity bit. The FRAMEP/N signal should be edge-aligned with D[15:0]P/N. Additionally it is used to indicate the beginning of the frame. |  |  |  |  |
| FRAMEN   | H1  | I   | LVDS frame indicator negative input. (See the FRAMEP description)   |  |  |  |  |
| GND      | A10, A13, A14, B10, B11, B12, B13, C5, C6, C7, C8, C9, C10, C13, D8, D13, D14, E8, E12, E13, F6, F7, F8, F9, F12, F13, G6, G7, G8, G9, G13, G14, H6, H7, H8, H9, H13, H14, J6, J7, J8, J9, J12, J13, K8, K13, L8, L13, L14, M5, M6, M7, M8, M9, M10, M11, M12, M13, N13, P13, P14 | I   | These pins are ground for all supplies.   |  |  |  |  |
| IOUTAP   | B14   | 0   | A-Channel DAC current output. Connect directly to ground if unused.   |  |  |  |  |
| IOUTAN   | C14   | 0   | A-Channel DAC complementary current output. Connect directly to ground if unused.   |  |  |  |  |
| IOUTBP   | F14   | 0   | B-Channel DAC current output. Connect directly to ground if unused.   |  |  |  |  |
| IOUTBN   | E14   | 0   | B-Channel DAC complementary current output. Connect directly to ground if unused.   |  |  |  |  |
| IOUTCP   | J14   | 0   | C-Channel DAC current output. Connect directly to ground if unused.   |  |  |  |  |

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### **Pin Functions - NFBGA (continued)**

|          | PIN                    | ./0 | DECODINE   |
|----------|------------------------|-----|--|
| NAME     | NO.                    | 1/0 | DESCRIPTION  |
| IOUTCN   | K14                    | 0   | C-Channel DAC complementary current output. Connect directly to ground if unused.  |
| IOUTDP   | N14                    | 0   | D-Channel DAC current output. Connect directly to ground if unused.  |
| IOUTDN   | M14                    | 0   | D-Channel DAC complementary current output. Connect directly to ground if unused.  |
| IOVDD    | D5, D6, G5, H5, L5, L6 | I   | Supply voltage for all digital I/O. (3.3 V)  |
| LPF      | D12                    | I   | PLL loop filter connection. If not using the clock multiplying PLL, the LPF pin can be left unconnected.   |
| OSTRP    | A9                     | I   | LVPECL output strobe positive input. This positive/negative pair is captured with the rising edge of DACCLKP/N. It is used for multiple DAC synchronization. If unused it can be left unconnected.   |
| OSTRN    | B9                     | I   | LVPECL output strobe negative input. (See the OSTRP description)   |
| PARITYP  | N5                     | I   | Optional LVDS positive input parity bit. The PARITYP/N LVDS pair has an internal $100-\Omega$ termination resistor. If unused it can be left unconnected.  |
| PARITYN  | P5                     | - 1 | Optional LVDS negative input parity bit.   |
| PLLAVDD  | C11, D11               | I   | PLL analog supply voltage. (3.3 V)   |
| SCLK     | P9                     | I   | Serial interface clock. Internal pull-down.  |
| SDENB    | P10                    | Ι   | Active low serial data enable, always an input to the DAC3484. Internal pull-up.   |
| SDIO     | P11                    | I/O | Serial interface data. Bi-directional in 3-pin mode (default) and 4-pin mode. Internal pull-down.  |
| SDO      | P12                    | 0   | Uni-directional serial interface data in 4-pin mode. The SDO pin is three-stated in 3-pin interface mode (default).  |
| SLEEP    | B8                     | ı   | Active high asynchronous hardware power-down input. Internal pull-down. If SLEEP pin is set to logic HIGH before and during device power-up and initialization, the fuse_sleep bit in register 0x1B, bit 11 must be written after register 0x23 during device initialization register setup.   |
| SYNCP    | A5                     | I   | Optional LVDS SYNC positive input. The SYNCP/N LVDS pair has an internal $100-\Omega$ termination resistor. If unused it can be left unconnected.  |
| SYNCN    | B5                     | I   | LVDS SYNC negative input.  |
| RESETB   | N10                    | I   | Active low input for chip RESET, which resets all the programming registers to their default state. Internal pull-up.  |
| TXENABLE | N9                     | ı   | Transmit enable active high input. Internal pull-down.  To enable analog output data transmission, set <i>sif_txenable</i> in register <i>config3</i> to 1b <b>or</b> pull CMOS TXENABLE pin to high.  To disable analog output, set <i>sif_txenable</i> to 0b <b>and</b> pull CMOS TXENABLE pin to low. The DAC output is forced to midscale. |
| TESTMODE | A8                     | 0   | This pin is used for factory testing. Internal pull-down. Leave unconnected for normal operation.  |
| VFUSE    | D7                     | I   | Digital supply voltage. This supply pin is also used for factory fuse programming. <b>Connect to DACVDD for normal operation.</b>  |

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## **Specifications**

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

|                                  |  | MIN         | MAX          | UNIT |
|----------------------------------|--|-------------|--------------|------|
|                                  | DACVDD, DIGVDD, CLKVDD   | -0.5        | 1.5          | V    |
| Supply voltage                   | VFUSE  | -0.5        | 1.5          | V    |
| range <sup>(2)</sup>             | IOVDD  | -0.5        | 4            | V    |
|                                  | AVDD, PLLAVDD  | -0.5        | 4            | V    |
|                                  | D[150]P/N, DATACLKP/N, FRAMEP/N, PARITYP/N, SYNCP/N                        | -0.5        | IOVDD + 0.5  | V    |
|                                  | DACCLKP/N, OSTRP/N   | -0.5        | CLKVDD + 0.5 | V    |
| Pin voltage range <sup>(2)</sup> | ALARM, SDO, SDIO, SCLK, SDENB, SLEEP, RESETB, TESTMODE, TXENABLE -0.5 IOVD | IOVDD + 0.5 | V            |      |
| 0 0                              | IOUTAP/N, IOUTBP/N, IOUTCP/N, IOUTDP/N                                     | -1.0        | AVDD + 0.5   | V    |
|                                  | EXTIO, BIASJ   | -0.5        | AVDD + 0.5   | V    |
|                                  | LPF  | 0.5         | PLLAVDD+0.5V | V    |
| Peak input current (an           | ny input)  |             | 20           | mA   |
| Peak total input currer          | nt (all inputs)  |             | -30          | mA   |
| Operating free-air tem           | perature range, T <sub>A</sub> : DAC3484                                   | -40         | 85           | °C   |
| Absolute maximum jui             | nction temperature, T <sub>J</sub>   |             | 150          | °C   |
| Storage temperature r            | range  | -65         | 150          | °C   |

Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 6.2 ESD Ratings

| <u> </u>          |                         |   |       |      |
|-------------------|-------------------------|---|-------|------|
|                   |                         |   | VALUE | UNIT |
|                   |                         | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)              | ±2000 |      |
| V <sub>(ESD</sub> | Electrostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 (2) | ±500  | V    |

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

#### 6.3 Recommended Operating Conditions

|       |   | MIN | NOM | MAX | UNIT |
|-------|---|-----|-----|-----|------|
| _     | Recommended operating junction temperature                  |     |     | 105 | 9    |
| IJ    | Maximum rated operating junction temperature <sup>(1)</sup> | 125 |     |     |      |
| $T_A$ | Recommended free-air temperature                            | -40 | 25  | 85  | °C   |

<sup>(1)</sup> Prolonged use at this junction temperature may increase the device failure-in-time (FIT) rate.

Measured with respect to GND.



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#### 6.4 Thermal Information

|                    |  | DAC              |                |      |
|--------------------|--|------------------|----------------|------|
|                    | THERMAL METRIC <sup>(1)</sup>                | RKD<br>(WQFN-MR) | ZAY<br>(NFBGA) | UNIT |
|                    |  | 88 PINS          | 196 BALLS      |      |
| $R_{\theta JA}$    | Junction-to-ambient thermal resistance       | 22.1             | 37.6           | °C/W |
| $R_{\theta JCtop}$ | Junction-to-case (top) thermal resistance    | 7.1              | 6.8            | °C/W |
| $R_{\theta JCbot}$ | Junction-to-case (bottom) thermal resistance | 0.6              | N/A            | °C/W |
| $\theta_{JB}$      | Junction-to-board thermal resistance         | 4.7              | 16.8           | °C/W |
| $\Psi_{JT}$        | Junction-to-top characterization parameter   | 0.1              | 0.2            | °C/W |
| $\Psi_{JB}$        | Junction-to-board characterization parameter | 4.6              | 16.4           | °C/W |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report (SPRA953).

## 6.5 Electrical Characteristics – DC Specifications<sup>(1)</sup>

over recommended operating free-air temperature range, nominal supplies, IOUT<sub>FS</sub> = 20 mA (unless otherwise noted)

|                    | PARAMETER                               | TEST CONDITIONS                             | MIN  | TYP    | MAX  | UNIT   |
|--------------------|---|---|------|--------|------|--------|
| Resolution         | n                                       |   | 16   |        |      | Bits   |
| DC ACCL            | JRACY                                   |   | ·    |        |      |        |
| DNL                | Differential nonlinearity               | 4.1.00 10117 /016                           |      | ±2     |      | LSB    |
| INL                | Integral nonlinearity                   | 1 LSB = IOUT <sub>FS</sub> /2 <sup>16</sup> |      | ±4     |      | LSB    |
| ANALOG             | OUTPUT                                  |   |      |        |      |        |
|                    | Coarse gain linearity                   |   |      | ±0.04  |      | LSB    |
|                    | Offset error                            | Mid code offset                             |      | ±0.001 |      | %FSR   |
|                    | Coin orror                              | With external reference                     |      | ±2     |      | %FSR   |
|                    | Gain error                              | With internal reference                     |      | ±2     |      | %FSR   |
|                    | Gain mismatch                           | With internal reference                     |      | ±2     |      | %FSR   |
|                    | Full scale output current               |   | 10   | 20     | 30   | mA     |
|                    | Output compliance range                 |   | -0.5 |        | 0.6  | V      |
|                    | Output resistance                       |   |      | 300    |      | kΩ     |
|                    | Output capacitance                      |   |      | 5      |      | pF     |
| REFEREN            | NCE OUTPUT                              |   | ·    |        |      |        |
| $V_{REF}$          | Reference output voltage                |   |      | 1.2    |      | V      |
|                    | Reference output current <sup>(2)</sup> |   |      | 100    |      | nA     |
| REFEREN            | NCE INPUT                               |   |      |        |      |        |
| $V_{\text{EXTIO}}$ | Input voltage range                     | External Reference Mode                     | 0.6  | 1.2    | 1.25 | V      |
|                    | Input resistance                        | External Reference Mode                     |      | 1      |      | МΩ     |
|                    | Small signal bandwidth                  |   |      | 472    |      | kHz    |
|                    | Input capacitance                       |   |      | 100    |      | pF     |
| TEMPERA            | ATURE COEFFICIENTS                      |   | ·    |        |      |        |
|                    | Offset drift                            |   |      | ±1     |      | ppm/°C |
|                    | Gain drift                              | with external reference                     |      | ±15    |      | ppm/°C |
|                    | Gain Unit                               | with internal reference                     |      | ±30    |      | ppm/°C |
|                    | Reference voltage drift                 |   |      | ±8     |      | ppm/°C |
|                    |   |   |      |        |      |        |

<sup>(1)</sup> Measured differentially across IOUTP/N with 25  $\Omega$  each to GND.

<sup>(2)</sup> Use an external buffer amplifier with high impedance input to drive any external load.



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# Electrical Characteristics – DC Specifications<sup>(1)</sup> (continued)

over recommended operating free-air temperature range, nominal supplies, IOUT<sub>ES</sub> = 20 mA (unless otherwise noted)

|                       | PARAMETER                            | TEST CONDITIONS  | MIN  | TYP  | MAX  | UNIT   |
|-----------------------|--------------------------------------|--|------|------|------|--------|
| POWER SU              | UPPLY <sup>(3)</sup>                 |  |      |      |      |        |
|                       | AVDD, IOVDD, PLLAVDD                 | All Conditions   | 3.14 | 3.3  | 3.46 | V      |
|                       | DIGVDD                               | All Conditions   | 1.14 | 1.2  | 1.32 | V      |
|                       | CLKVDD, DACVDD                       | F <sub>DAC</sub> Sampling Rate ≤ 1.25 GSPS, PLL OFF<br>F <sub>DAC</sub> Sampling Rate ≤ 1 GSPS, PLL ON | 1.14 | 1.2  | 1.32 | V      |
|                       |                                      | F <sub>DAC</sub> Sampling Rate > 1 GSPS, PLL ON  | 1.25 | 1.29 | 1.32 |        |
| PSRR                  | Power Supply Rejection Ratio         | DC tested  |      | ±0.2 |      | %FSR/V |
| POWER CO              | ONSUMPTION                           |  |      |      |      |        |
| I <sub>(AVDD)</sub>   | Analog supply current <sup>(4)</sup> |  |      | 123  | 135  | mA     |
| I <sub>(DIGVDD)</sub> | Digital supply current               | MODE 1   |      | 595  | 650  | mA     |
| I <sub>(DACVDD)</sub> | DAC supply current                   | f <sub>DAC</sub> = 1.25 GSPS, 4x interpolation, Mixer on, QMC on, invsinc on, PLL enabled, 20-mA FS    |      | 35   | 50   | mA     |
| I <sub>(CLKVDD)</sub> | Clock supply current                 | output, IF = 200 MHz   |      | 90   | 100  | mA     |
| P                     | Power dissipation                    |  |      | 1270 | 1320 | mW     |
| I <sub>(AVDD)</sub>   | Analog supply current <sup>(4)</sup> |  |      | 107  |      | mA     |
| I <sub>(DIGVDD)</sub> | Digital supply current               | MODE 2   |      | 595  |      | mA     |
| I <sub>(DACVDD)</sub> | DAC supply current                   | f <sub>DAC</sub> = 1.25 GSPS, 4x interpolation, Mixer on,  |      | 38   |      | mA     |
| I <sub>(CLKVDD)</sub> | Clock supply current                 | QMC on, invsinc on, PLL disabled, 20-mA FS output, IF = 200 MHz  |      | 71   |      | mA     |
| P                     | Power dissipation                    |  |      | 1198 |      | mW     |
| I <sub>(AVDD)</sub>   | Analog supply current <sup>(4)</sup> |  |      | 107  |      | mA     |
| I <sub>(DIGVDD)</sub> | Digital supply current               | MODE 3   |      | 282  |      | mA     |
| I <sub>(DACVDD)</sub> | DAC supply current                   | f <sub>DAC</sub> = 625 MSPS, 2x interpolation, Mixer on,   |      | 20   |      | mA     |
| I <sub>(CLKVDD)</sub> | Clock supply current                 | - QMC on, invsinc off, PLL disabled, 20-mA FS output, IF = 200 MHz                                     |      | 41   |      | mA     |
| P                     | Power dissipation                    |  |      | 765  |      | mW     |
| I <sub>(AVDD)</sub>   | Analog supply current <sup>(4)</sup> |  |      | 35   |      | mA     |
| I <sub>(DIGVDD)</sub> | Digital supply current               | MODE 4   |      | 595  |      | mA     |
| I <sub>(DACVDD)</sub> | DAC supply current                   | f <sub>DAC</sub> = 1.25 GSPS, 4x interpolation, Mixer on,  |      | 38   |      | mA     |
| I <sub>(CLKVDD)</sub> | Clock supply current                 | QMC on, invsinc on, PLL enabled, Channels A/B/C/D output sleep, IF = 200 MHz,                          |      | 90   |      | mA     |
| P                     | Power dissipation                    | 7 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6  |      | 984  |      | mW     |
| I <sub>(AVDD)</sub>   | Analog supply current <sup>(4)</sup> |  |      | 20   |      | mA     |
| I <sub>(DIGVDD)</sub> | Digital supply current               | Mode 5   |      | 10   |      | mA     |
| I <sub>(DACVDD)</sub> | DAC supply current                   | Power-Down mode: No clock,  DAC on sleep mode (clock receiver sleep),                                  |      | 4    |      | mA     |
| I <sub>(CLKVDD)</sub> | Clock supply current                 | Channels A/B/C/D output sleep, static data   |      | 10   |      | mA     |
| P                     | Power Dissipation                    | pattern  |      | 95   |      | mW     |
| I <sub>(AVDD)</sub>   | Analog supply current <sup>(4)</sup> |  |      | 107  |      | mA     |
| I <sub>(DIGVDD)</sub> | Digital supply current               | Mode 6   |      | 333  |      | mA     |
| I <sub>(DACVDD)</sub> | DAC supply current                   | f <sub>DAC</sub> = 1 GSPS, 8x interpolation, Mixer off,  |      | 35   |      | mA     |
| I <sub>(CLKVDD)</sub> | Clock supply current                 | QMC on, invsinc off, PLL enabled, 20-mA FS output, IF = 200 MHz  |      | 60   |      | mA     |
| P (CLKVDD)            | Power dissipation                    | - Josephi, II – 200 WII IZ   |      | 867  |      | mW     |
| I <sub>(AVDD)</sub>   | Analog supply current <sup>(4)</sup> |  |      | 123  |      | mA     |
|                       | Digital supply current               | Mode 7   |      | 323  |      | mA     |
| I(DIGVDD)             | DAC supply current                   | f <sub>DAC</sub> = 737.28 MSPS, 4x interpolation, Mixer on,  |      | 23   |      | mA     |
| I(DACVDD)             | Clock supply current                 | QMC on, invsinc off, PLL enabled, 20-mA FS   |      | 69   |      | mA     |
| I <sub>(CLKVDD)</sub> | Power dissipation                    | output, IF = 150 MHz   |      | 904  |      | mW     |

To ensure power supply accuracy and to account for power supply filter network loss at operating conditions, the use of the ATEST function in register config27 to check the internal power supply nodes is recommended. Includes AVDD, PLLAVDD, and IOVDD



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### 6.6 Electrical Characteristics - Digital Specifications

over operating free-air temperature range (unless otherwise noted)

|                     | PARAMETER                                       | TEST CONDITIONS                             | MIN            | TYP | MAX   | UNIT |
|---------------------|---|---|----------------|-----|-------|------|
| LVDS IN             | PUTS: D[15:0]P/N, DATACLKP/N                    | FRAMEP/N, SYNCP/N, PARITYP/N <sup>(1)</sup> |                |     |       |      |
| $V_{A,B+}$          | Logic high differential input voltage threshold |   | 200            |     |       | mV   |
| $V_{A,B-}$          | Logic low differential input voltage threshold  |   |                |     | -200  | mV   |
| V <sub>COM</sub>    | Input Common Mode                               |   | 1.0            | 1.2 | 1.6   | V    |
| Z <sub>T</sub>      | Internal termination                            |   | 85             | 110 | 135   | Ω    |
| C <sub>L</sub>      | LVDS Input capacitance                          |   |                | 2   |       | pF   |
| f <sub>INTERL</sub> | Interleaved LVDS data transfer rate             |   |                |     | 1250  | MSPS |
| f <sub>DATA</sub>   | Input data rate                                 |   |                |     | 312.5 | MSPS |
| CLOCK I             | INPUT (DACCLKP/N)                               |   |                |     | •     |      |
|                     | Differential voltage (2)                        | DACCLKP - DACCLKN                           | 0.4            | 0.8 |       | V    |
|                     | Internally biased common-<br>mode voltage       |   |                | 0.2 |       | V    |
|                     | Single-ended input level (3)                    |   | -0.4           |     |       | V    |
| OUTPUT              | STROBE (OSTRP/N)                                |   |                |     | •     |      |
|                     | Differential voltage                            | OSTRP - OSTRN                               | 0.4            | 8.0 |       | V    |
|                     | Internally biased common-<br>mode voltage       |   |                | 0.2 |       | V    |
|                     | Single-ended input level (3)                    |   | -0.4           |     |       | V    |
| CMOS IN             | NTERFACE: ALARM, SDO, SDIO,                     | SCLK, SDENB, SLEEP, RESETB, TXENABLE        | ·              |     |       |      |
| V <sub>IH</sub>     | High-level input voltage                        |   | 2              |     |       | V    |
| $V_{IL}$            | Low-level input voltage                         |   |                |     | 0.8   | V    |
| I <sub>IH</sub>     | High-level input current                        |   | -40            |     | 40    | μA   |
| I <sub>IL</sub>     | Low-level input current                         |   | -40            |     | 40    | μA   |
| Cı                  | CMOS Input capacitance                          |   |                | 2   |       | pF   |
| V <sub>OH</sub>     | ALARM, SDO, SDIO                                | $I_{load} = -100 \ \mu A$                   | IOVDD –<br>0.2 |     |       | V    |
|                     |   | $I_{load} = -2 \text{ mA}$                  | 0.8 x IOVDD    |     |       | V    |
| V                   | ALARM, SDO, SDIO                                | $I_{load} = 100 \mu A$                      |                |     | 0.2   | V    |
| $V_{OL}$            | ALAKIVI, SDO, SDIO                              | I <sub>load</sub> = 2 mA                    |                |     | 0.5   | V    |

See *LVDS Inputs* section for terminology. Standard high swing LVPECL clock signal should be applied for best performance.

Indicates the minimum voltage that can be applied to the DACCLK and OSTR differential pins in single-ended fashion.

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### 6.7 Electrical Characteristics - AC Specifications

over recommended operating free-air temperature range, nominal supplies, IOUT<sub>FS</sub> = 20mA (unless otherwise noted)

|   | PARAMETER                                       | TEST CONDITIONS  | MIN TYP MAX | UNIT   |  |
|---|---|--|-------------|--------|--|
| ANALOG OUTPUT <sup>(1)</sup> $f_{DAC} \qquad \text{Maximum DAC rate} \qquad \qquad 1250 \qquad \text{MS}$ AC PERFORMANCE <sup>(2)</sup> $SFDR \qquad \begin{array}{c} \text{Spurious free dynamic range} \\ (0 \text{ to } f_{DAC}/2) \text{ Tone at } 0 \text{ dBFS} \end{array} \qquad \begin{array}{c} f_{DAC} = 1.25 \text{ GSPS, } f_{OUT} = 20 \text{ MHz} \\ f_{DAC} = 1.25 \text{ GSPS, } f_{OUT} = 50 \text{ MHz} \end{array} \qquad \begin{array}{c} 82 \\ 77 \\ f_{DAC} = 1.25 \text{ GSPS, } f_{OUT} = 50 \text{ MHz} \end{array} \qquad \begin{array}{c} 77 \\ 72 \\ 72 \\ 73 \\ 74 \\ 75 \\ 75 \\ 75 \\ 75 \\ 75 \\ 75 \\ 75$ |   |  |             |        |  |
| f <sub>DAC</sub>  | Maximum DAC rate                                |  | 1250        | MSPS   |  |
|   |   |  |             |        |  |
|   |   | f <sub>DAC</sub> = 1.25 GSPS, f <sub>OUT</sub> = 20 MHz          | 82          |        |  |
| SFDR  |   | $f_{DAC} = 1.25 \text{ GSPS}, f_{OUT} = 50 \text{ MHz}$          | 77          | dBc    |  |
|   | (o to 10ACZ) Folio at o abi o                   | $f_{DAC} = 1.25 \text{ GSPS}, f_{OUT} = 70 \text{ MHz}$          | 72          |        |  |
|   |   | $f_{DAC} = 1.25 \text{ MSPS}, f_{OUT} = 30 \pm 0.5 \text{ MHz}$  | 81          |        |  |
| IMD3  |   | $f_{DAC} = 1.25 \text{ GSPS}, f_{OUT} = 50 \pm 0.5 \text{ MHz}$  | 79          | dBc    |  |
|   | Educations at 12 dbi 6                          | $f_{DAC} = 1.25 \text{ GSPS}, f_{OUT} = 100 \pm 0.5 \text{ MHz}$ | 77.5        |        |  |
| NCD   | Noise Spectral Density                          | $f_{DAC} = 1.25 \text{ GSPS}, f_{OUT} = 10 \text{ MHz}$          | 160         | dBa/Uz |  |
| NSD   | Tone at 0dBFS                                   | f <sub>DAC</sub> = 1.25 GSPS, f <sub>OUT</sub> = 80 MHz          | 155         | ubc/HZ |  |
|   | Adjacent channel leakage ratio single carrier   | f <sub>DAC</sub> = 1.2288 GSPS, f <sub>OUT</sub> = 30.72 MHz     | 77          |        |  |
| ACLR <sup>(3)</sup>   | Adjacent channel leakage ratio, single carrier  | f <sub>DAC</sub> = 1.2288 GSPS, f <sub>OUT</sub> = 153.6 MHz     | 74          | dD.a   |  |
| ACLR  | Alternate channel leakage ratio, single carrier | f <sub>DAC</sub> = 1.2288 GSPS, f <sub>OUT</sub> = 30.72 MHz     | 82          | dBc    |  |
|   | Alternate Charmer leakage ratio, Single Carrier | f <sub>DAC</sub> = 1.2288 GSPS, f <sub>OUT</sub> = 153.6 MHz     | 80          |        |  |
|   | Channel Isolation                               | f <sub>DAC</sub> = 1.25 GSPS, f <sub>OUT</sub> = 10 MHz          | 84          | dBc    |  |

- (1) Measured single ended into 50- $\Omega$  load. (2) 4:1 transformer output termination, 50  $\Omega$  doubly terminated load.
- Single carrier, W-CDMA with 3.84-MHz BW, 5-MHz spacing, centered at IF, PAR = 12dB. TESTMODEL 1, 10 ms

### 6.8 Timing Requirements – Digital Specifications

|                      |                                    |   |                      |           | MIN  | NOM | MAX                                | UNIT |
|----------------------|------------------------------------|---|----------------------|-----------|------|-----|------------------------------------|------|
| CLOCK IN             | PUT (DACCLKP/N)                    |   |                      |           |      |     |                                    |      |
|                      | Duty cycle                         |   |                      |           | 40%  |     | 60%                                |      |
|                      | DACCLKP/N input f                  | requency  |                      |           |      |     | 1250                               | MHz  |
| OUTPUT S             | STROBE (OSTRP/N)                   |   |                      | <u> </u>  |      |     | <u> </u>                           |      |
| f <sub>OSTR</sub>    | Frequency                          | f <sub>OSTR</sub> = f <sub>DACCLK</sub> / (n x 8 x Interp) where r<br>integer, f <sub>DACCLK</sub> is DACCLK frequency ir | n is any po<br>n MHz | sitive    |      |     | f <sub>DACCLK</sub> / (8 x interp) | MHz  |
|                      | Duty cycle                         |   |                      |           |      | 50% |                                    |      |
| DIGITAL II           | NPUT TIMING SPECIFIC               | ATIONS  |                      |           |      |     | ,                                  |      |
| Timing LV            | DS inputs: D[15:0]P/N,             | FRAMEP/N, SYNCP/N, PARITYP/N, dou   | ıble edge            | latching  |      |     |                                    |      |
|                      |                                    |   | Config36             | S Setting |      |     |                                    |      |
|                      |                                    |   | datadly              | clkdly    |      |     |                                    |      |
|                      |                                    |   | 0                    | 0         | 150  |     |                                    |      |
|                      |                                    |   | 0                    | 1         | 100  |     |                                    |      |
|                      |                                    |   | 0                    | 2         | 50   |     |                                    |      |
|                      |                                    |   | 0                    | 3         | 0    |     |                                    |      |
|                      | Setup time,                        |   | 0                    | 4         | -50  |     |                                    |      |
|                      | D[15:0]P/N,<br>FRAMEP/N,           | FRAMEP/N reset and frame indicator latched on rising edge of  | 0                    | 5         | -100 |     |                                    |      |
| t <sub>s(DATA)</sub> | SYNCP/N and                        | DATACLKP/N.   | 0                    | 6         | -150 |     |                                    |      |
|                      | PARITYP/N, valid to either edge of | FRAMEP/N parity bit latched on falling edge of DATACLKP/N.  | 0                    | 7         | -200 |     |                                    | ps   |
|                      | DATACLKP/N                         | eage of DATACERT /N.  | 1                    | 0         | 200  |     |                                    |      |
|                      |                                    |   | 2                    | 0         | 250  |     |                                    |      |
|                      |                                    |   | 3                    | 0         | 300  |     |                                    |      |
|                      |                                    |   | 4                    | 0         | 350  |     |                                    |      |
|                      |                                    |   | 5                    | 0         | 400  |     |                                    |      |
|                      |                                    |   | 6                    | 0         | 450  |     |                                    |      |
|                      |                                    |   | 7                    | 0         | 500  |     |                                    |      |



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### Timing Requirements – Digital Specifications (continued)

|                           |  |  |          |           | MIN                     | NOM | MAX | UNIT |
|---------------------------|--|--|----------|-----------|-------------------------|-----|-----|------|
|                           |  |  | Config36 | 6 Setting |                         |     |     |      |
|                           |  |  | datadly  | clkdly    |                         |     |     |      |
|                           |  |  | 0        | 0         | 350                     |     |     |      |
|                           |  |  | 0        | 1         | 400                     |     |     |      |
|                           |  |  | 0        | 2         | 450                     |     |     |      |
|                           |  |  | 0        | 3         | 500                     |     |     |      |
|                           | Hold time,                             |  | 0        | 4         | 550                     |     |     |      |
|                           | D[15:0]P/N,<br>FRAMEP/N,               | FRAMEP/N reset and frame indicator latched on rising edge of | 0        | 5         | 600                     |     |     |      |
| t <sub>h(DATA)</sub>      | SYNCP/N and                            | DATACLKP/N.  | 0        | 6         | 650                     |     |     | ps   |
|                           | PARITYP/N, valid after either edge of  | FRAMEP/N parity bit latched on falling edge of DATACLKP/N.   | 0        | 7         | 700                     |     |     |      |
|                           | DATACLKP/N                             |  | 1        | 0         | 300                     |     |     |      |
|                           |  |  | 2        | 0         | 250                     |     |     |      |
|                           |  |  | 3        | 0         | 200                     |     |     |      |
|                           |  |  | 4        | 0         | 150                     |     |     |      |
|                           |  |  | 5        | 0         | 100                     |     |     |      |
|                           |  |  | 6        | 0         | 50                      |     |     |      |
|                           |  |  | 7        | 0         | 0                       |     |     |      |
| t <sub>(FRAME_SYNC)</sub> | FRAMEP/N and<br>SYNCP/N pulse<br>width | f <sub>DATACLK</sub> is DATACLK frequency in MHz             |          |           | 1/2f <sub>DATACLK</sub> |     |     | ns   |
| TIMING OUTF               | PUT STROBE INPUT                       | : DACCLKP/N rising edge LATCHING <sup>(1)</sup>              | )        |           |                         |     |     |      |
| t <sub>s(OSTR)</sub>      |  | /N valid to rising edge of DACCLKP/N                         |          |           | 0                       |     |     | ps   |
| t <sub>h(OSTR)</sub>      | Hold time, OSTRP/N                     | N valid after rising edge of DACCLKP/N                       |          |           | 300                     |     |     | ps   |
|                           | INPUT: DACCLKP/                        | N rising edge LATCHING <sup>(2)</sup>                        |          |           | 11                      |     |     |      |
| t <sub>s(SYNC_PLL)</sub>  | Setup time, SYNCP                      | /N valid to rising edge of DACCLKP/N                         |          |           |                         | 200 |     | ps   |
| t <sub>h(SYNC_PLL)</sub>  | Hold time, SYNCP/N                     | N valid after rising edge of DACCLKP/N                       |          |           |                         | 300 |     | ps   |
| TIMING SERI               | AL PORT                                |  |          |           |                         |     |     |      |
| t <sub>s(SDENB)</sub>     | Setup time, SDENB                      | to rising edge of SCLK                                       |          |           | 20                      |     |     | ns   |
| t <sub>s(SDIO)</sub>      | Setup time, SDIO va                    | alid to rising edge of SCLK                                  |          |           | 10                      |     |     | ns   |
| t <sub>h(SDIO)</sub>      | Hold time, SDIO val                    | id to rising edge of SCLK                                    |          |           | 5                       |     |     | ns   |
|                           | Daria da f COLIC                       | Register config6 read (temperature sens                      | or read) |           | 1                       |     |     | μs   |
| t(SCLK)                   | Period of SCLK                         | All other registers  |          |           | 100                     |     |     | ns   |
| t <sub>d(Data)</sub>      | Data output delay a                    | fter falling edge of SCLK                                    |          |           |                         | 10  |     | ns   |
| t <sub>RESET</sub>        | Minimum RESETB                         | oulse width  |          |           |                         | 25  |     | ns   |

<sup>(1)</sup> OSTR is required in Dual Sync Sources mode. In order to minimize the skew it is recommended to use the same clock distribution device such as Texas Instruments CDCE62005 or LMK0480x family to provide the DACCLK and OSTR signals to all the DAC3484 devices in the system. Swap the polarity of the DACCLK outputs with respect to the OSTR ones to establish proper phase relationship.

<sup>(2)</sup> SYNC is required to synchronize the PLL circuit in multiple devices. The SYNC signal must meet the timing relationship with respect to the reference clock (DACCLKP/N) of the on-chip PLL circuit.



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### 6.9 Switching Characteristics - AC Specifications

over recommended operating free-air temperature range, nominal supplies, IOUT<sub>FS</sub> = 20 mA (unless otherwise noted)

|                      | PARAMETER                    | TEST CONDITIONS   | MIN | TYP  | MAX | UNIT         |
|----------------------|------------------------------|---|-----|------|-----|--------------|
| ANALOG (             | OUTPUT <sup>(1)</sup>        |   |     |      |     |              |
| t <sub>s(DAC)</sub>  | Output settling time to 0.1% | Transition: Code 0x0000 to 0xFFFF   |     | 10   |     | ns           |
| t <sub>pd</sub>      | Output propagation delay     | DAC outputs are updated on the falling edge of DAC clock. Does not include Digital Latency (see below). |     | 2    |     | ns           |
| t <sub>r(IOUT)</sub> | Output rise time 10% to 90%  |   |     | 220  |     | ps           |
| t <sub>f(IOUT)</sub> | Output fall time 90% to 10%  |   |     | 220  |     | ps           |
|                      |                              | No interpolation, FIFO on, Mixer off, QMC off, Inverse sinc off   |     | 128  |     |              |
|                      |                              | 2x Interpolation  |     | 216  |     |              |
|                      |                              | 4x Interpolation  |     | 376  |     | DAC          |
|                      | Digital latency              | 8x Interpolation  |     | 726  |     | DAC<br>clock |
|                      | ,                            | 16x Interpolation   |     | 1427 |     | cycles       |
|                      |                              | Fine mixer  |     | 24   |     |              |
|                      |                              | QMC   |     | 32   |     |              |
|                      |                              | Inverse sinc  |     | 36   |     |              |
| Power-up             | DAC wake-up time             | IOUT current settling to 1% of IOUT <sub>FS</sub> from output sleep                                     |     | 2    |     |              |
| Time                 | DAC sleep time               | IOUT current settling to less than 1% of IOUT <sub>FS</sub> in output sleep                             |     | 2    |     | μs           |

<sup>(1)</sup> Measured single ended into  $50-\Omega$  load.

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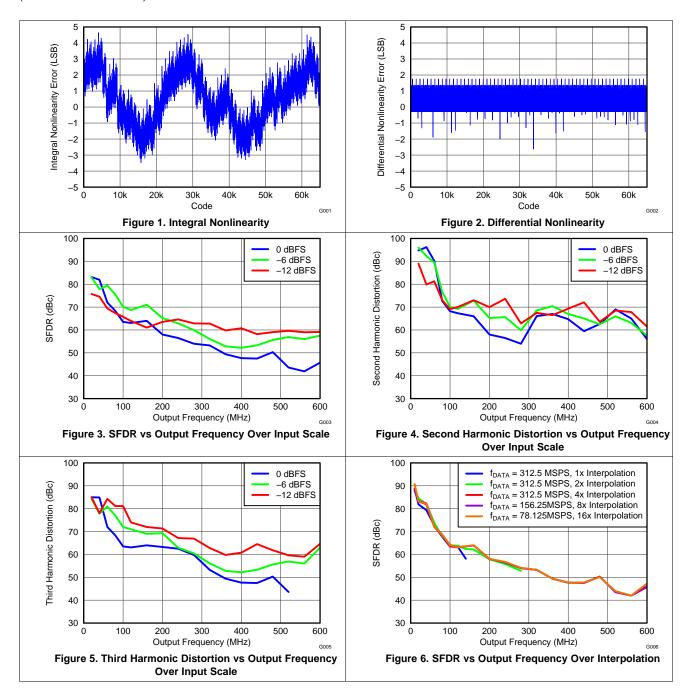
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### 6.10 Typical Characteristics

All plots are at 25°C, nominal supply voltage,  $f_{DAC}$  = 1250 MSPS, 4x interpolation, NCO enabled, Mixer Gain disabled, QMC enabled with gain set at 1446 for both I/Q channels, 0 dBFS digital input, 20-mA full-scale output current with 4:1 transformer (unless otherwise noted)



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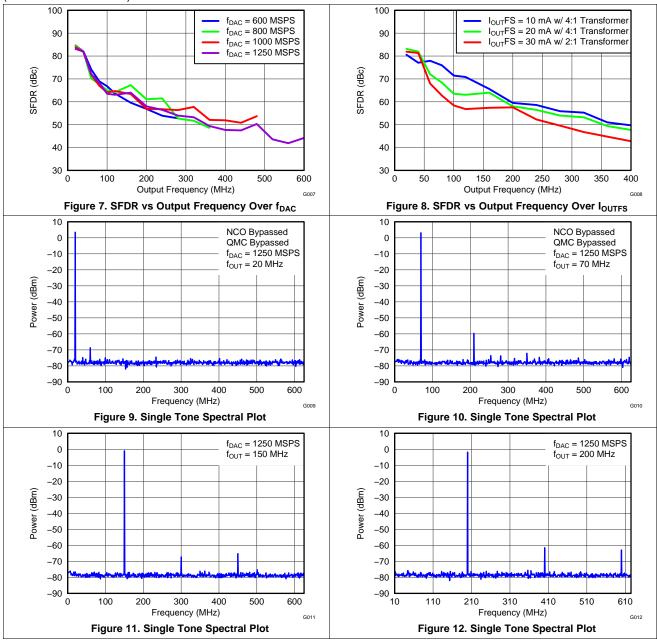


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# Typical Characteristics (continued)

All plots are at 25°C, nominal supply voltage,  $f_{DAC}$  = 1250 MSPS, 4x interpolation, NCO enabled, Mixer Gain disabled, QMC enabled with gain set at 1446 for both I/Q channels, 0 dBFS digital input, 20-mA full-scale output current with 4:1 transformer (unless otherwise noted)



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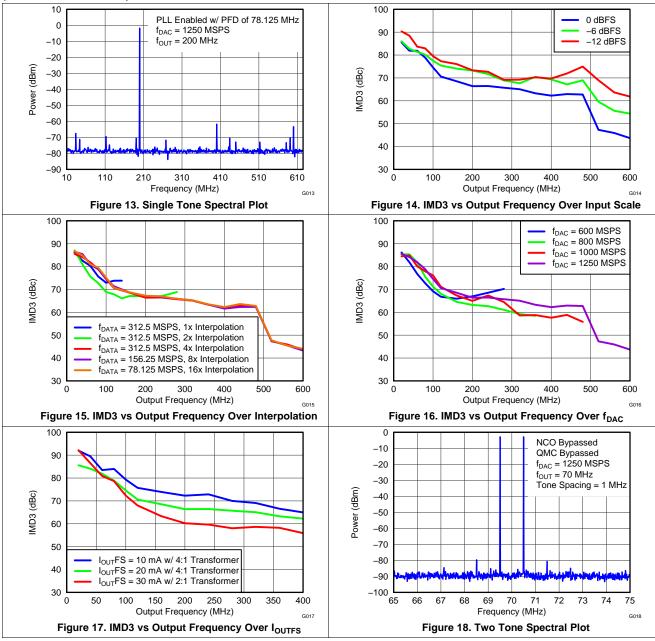
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### **Typical Characteristics (continued)**

All plots are at 25°C, nominal supply voltage, f<sub>DAC</sub> = 1250 MSPS, 4x interpolation, NCO enabled, Mixer Gain disabled, QMC enabled with gain set at 1446 for both I/Q channels, 0 dBFS digital input, 20-mA full-scale output current with 4:1 transformer (unless otherwise noted)



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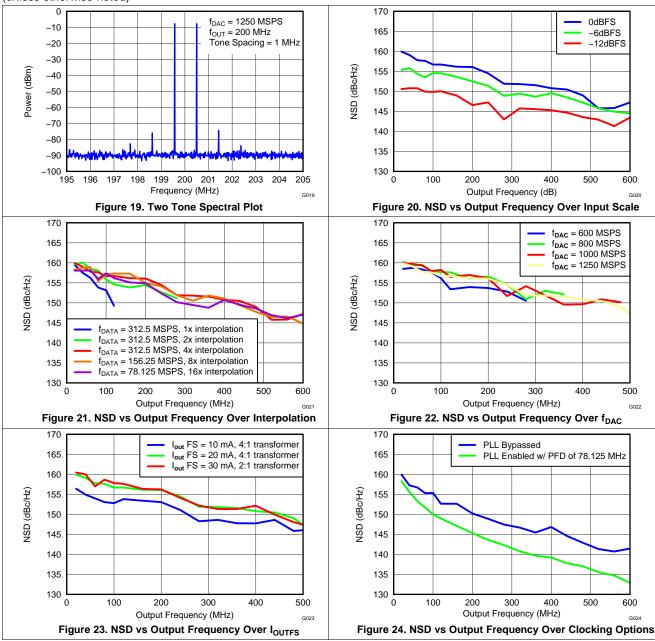
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### **Typical Characteristics (continued)**

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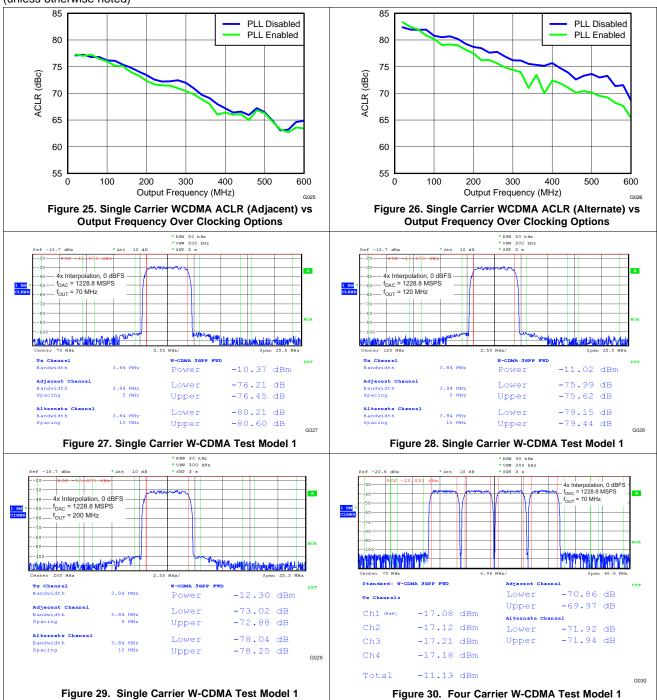
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### **Typical Characteristics (continued)**

All plots are at 25°C, nominal supply voltage,  $f_{DAC}$  = 1250 MSPS, 4x interpolation, NCO enabled, Mixer Gain disabled, QMC enabled with gain set at 1446 for both I/Q channels, 0 dBFS digital input, 20-mA full-scale output current with 4:1 transformer (unless otherwise noted)



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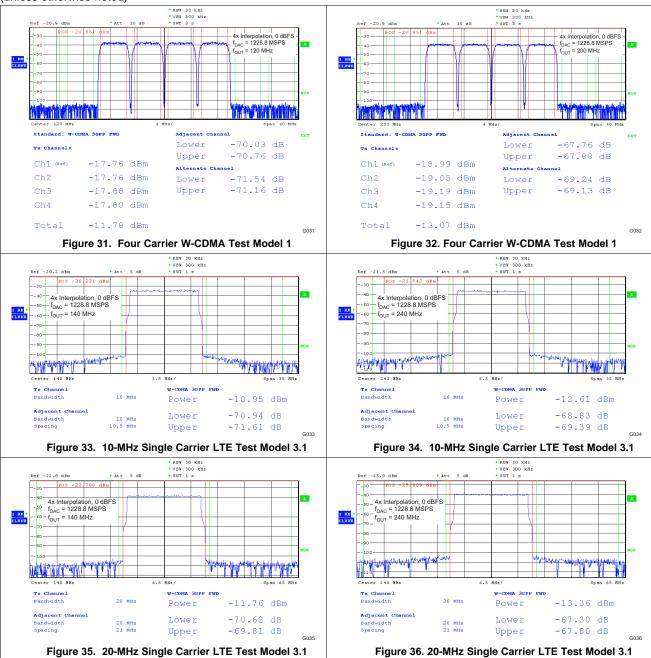
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### **Typical Characteristics (continued)**

All plots are at 25°C, nominal supply voltage,  $f_{DAC}$  = 1250 MSPS, 4x interpolation, NCO enabled, Mixer Gain disabled, QMC enabled with gain set at 1446 for both I/Q channels, 0 dBFS digital input, 20-mA full-scale output current with 4:1 transformer (unless otherwise noted)



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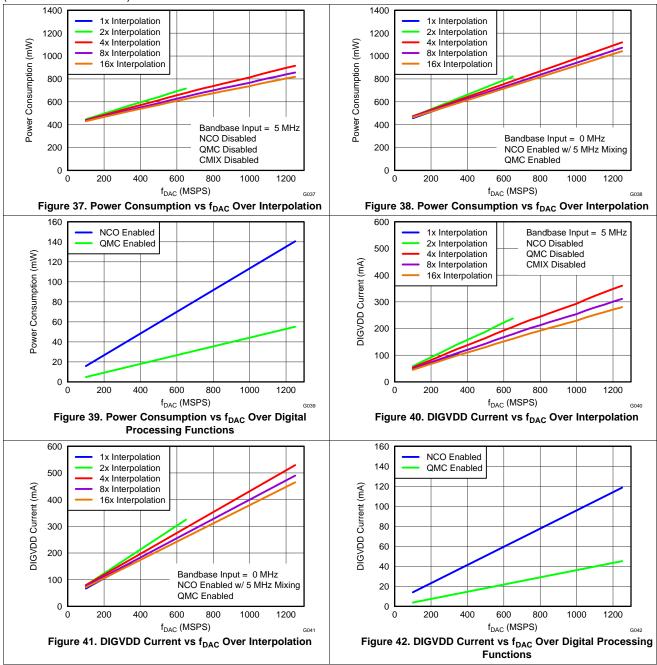
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### **Typical Characteristics (continued)**

All plots are at 25°C, nominal supply voltage,  $f_{DAC}$  = 1250 MSPS, 4x interpolation, NCO enabled, Mixer Gain disabled, QMC enabled with gain set at 1446 for both I/Q channels, 0 dBFS digital input, 20-mA full-scale output current with 4:1 transformer (unless otherwise noted)



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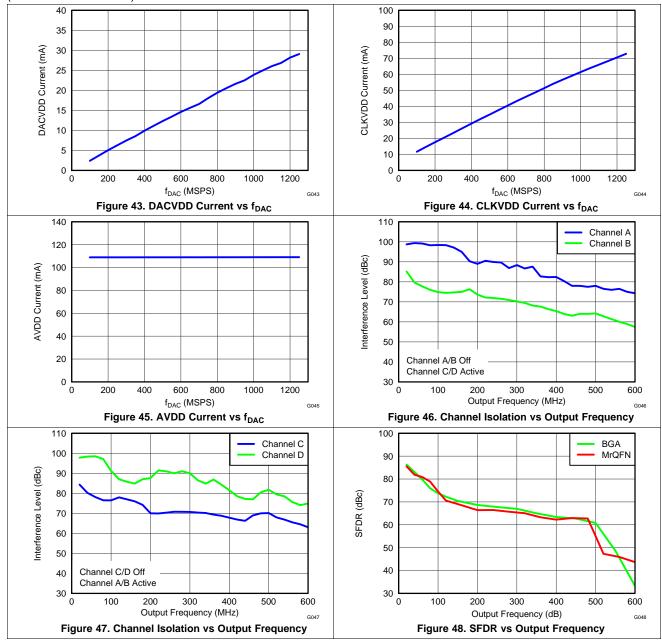


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# Typical Characteristics (continued)

All plots are at 25°C, nominal supply voltage,  $f_{DAC}$  = 1250 MSPS, 4x interpolation, NCO enabled, Mixer Gain disabled, QMC enabled with gain set at 1446 for both I/Q channels, 0 dBFS digital input, 20-mA full-scale output current with 4:1 transformer (unless otherwise noted)



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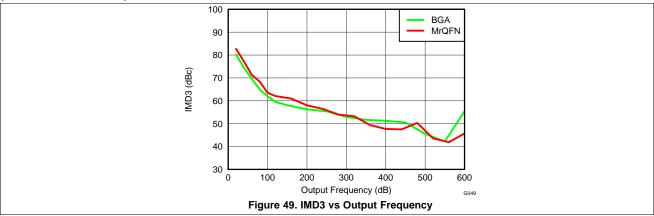
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### **Typical Characteristics (continued)**

All plots are at 25°C, nominal supply voltage,  $f_{DAC}$  = 1250 MSPS, 4x interpolation, NCO enabled, Mixer Gain disabled, QMC enabled with gain set at 1446 for both I/Q channels, 0 dBFS digital input, 20-mA full-scale output current with 4:1 transformer (unless otherwise noted)





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### 7 Detailed Description

#### 7.1 Overview

The DAC3484 includes a quad-channel, 16-bit digital-to-analog converter (DAC) with up to 1.25 GSPS sample rate, a 16-bit LVDS data bus with on-chip termination, FIFO, data pattern checker, and parity test. The device includes 2x to 16x digital interpolation filters with over 90dB of stop-band attenuation, reconstruction filters, independent complex mixers, a low jitter clock multiplier, and digital Quadrature Modulator Correction (QMC).

Full synchronization of multiple devices is possible with the DAC3484. It is an ideal device for next generation communication systems.



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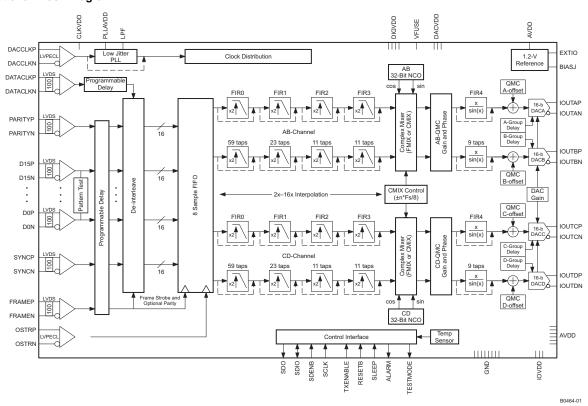


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### 7.2 Functional Block Diagram



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### 7.3 Feature Description

#### 7.3.1 Serial Interface

The serial port of the DAC3484 is a flexible serial interface which communicates with industry standard microprocessors and microcontrollers. The interface provides read/write access to all registers used to define the operating modes of DAC3484. It is compatible with most synchronous transfer formats and can be configured as a 3 or 4 pin interface by *sif4\_ena* in register *config2*. In both configurations, SCLK is the serial interface input clock and SDENB is serial interface enable. For 3 pin configuration, SDIO is a bidirectional pin for both data in and data out. For 4 pin configuration, SDIO is data in only and SDO is data out only. Data is input into the device with the rising edge of SCLK. Data is output from the device on the falling edge of SCLK.

Each read/write operation is framed by signal SDENB (Serial Data Enable Bar) asserted low. The first frame byte is the instruction cycle which identifies the following data transfer cycle as read or write as well as the 7-bit address to be accessed. Table 1 indicates the function of each bit in the instruction cycle and is followed by a detailed description of each bit. The data transfer cycle consists of two bytes.

Table 1. Instruction Byte of the Serial Interface

| BIT         | 7 (MSB) | 6  | 5  | 4  | 3  | 2  | 1  | 0 (LSB) |
|-------------|---------|----|----|----|----|----|----|---------|
| Description | R/W     | A6 | A5 | A4 | A3 | A2 | A1 | A0      |

R/W

Identifies the following data transfer cycle as a read or write operation. A high indicates a read operation from DAC3484 and a low indicates a write operation to DAC3484.

[A6: A0] Identifies the address of the register to be accessed during the read or write operation.

Figure 50 shows the serial interface timing diagram for a DAC3484 write operation. SCLK is the serial interface clock input to DAC3484. Serial data enable SDENB is an active low input to DAC3484. SDIO is serial data in. Input data to DAC3484 is clocked on the rising edges of SCLK.

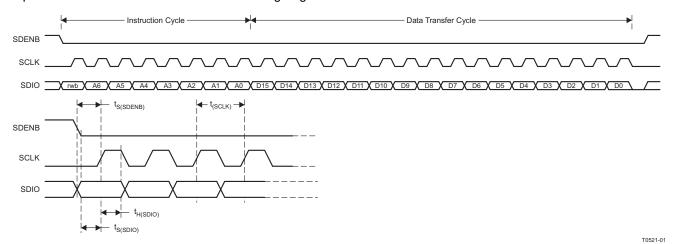


Figure 50. Serial Interface Write Timing Diagram

Figure 51 shows the serial interface timing diagram for a DAC3484 read operation. SCLK is the serial interface clock input to DAC3484. Serial data enable SDENB is an active low input to DAC3484. SDIO is serial data in during the instruction cycle. In 3 pin configuration, SDIO is data out from the DAC3484 during the data transfer cycle, while SDO is in a high-impedance state. In 4 pin configuration, SDO is data out from the DAC3484 during the data transfer cycle. At the end of the data transfer, SDIO and SDO will output low on the final falling edge of SCLK until the rising edge of SDENB when they will 3-state.

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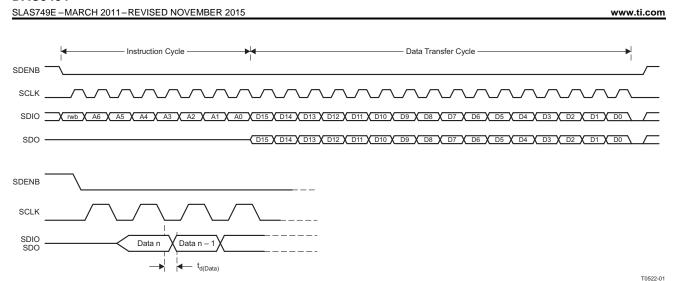


Figure 51. Serial Interface Read Timing Diagram

#### 7.3.2 Data Interface

The DAC3484 has a 16-bit LVDS bus that accepts quad, 16-bit data either in word-wide or dual byte-wide formats. The quad, 16-bit data can be input to the device using either a single-bus, 16-bit interface or a dual-bus, 8-bit interface. The selection between the two modes is done through 16bit\_in in the config2 register. The LVDS bus inputs in each mode are shown in Table 2.

**Table 2. LVDS Bus Input Assignment** 

| INPUT MODE | PINS   |
|------------|--|
| Word-wide  | D[150] → Data for paths A, B, C and D  |
| Byte-wide  | $D[158] \rightarrow Data$ for paths A and B $D[70] \rightarrow Data$ for paths C and D |

Data is sampled by the LVDS double data rate (DDR) clock DATACLK. Setup and hold requirements must be met for proper sampling.

For both input bus modes, a sync signal, either FRAME or SYNC, can sync the FIFO read and/or write pointers. In byte-wide mode the sync source is needed to establish the correct sample boundaries.

The sync signal, either FRAME or SYNC, can be either a pulse or a periodic signal where the sync period corresponds to multiples of 8 samples. FRAME or SYNC is sampled by a rising edge in DATACLK. The pulse-width  $t_{(FRAME\_SYNC)}$  needs to be at least equal to 1/2 of the DATACLK period.

For both input bus mode, the value in FRAME sampled by the next falling edge in DATACLK can be used as a block parity value. This feature is enabled by setting *frame\_parity\_ena* in register *config1* to 1b. Refer to Parity Check Test section for more detail

### 7.3.2.1 Word-Wide Format

The single-bus, 16-bit interface is selected by setting  $16bit\_in$  to 1b in the *config2* register. In this mode the 16-bit data for channels A, B, C and D is input word-wide interleaved in the form  $A_0$ ,  $B_0$ ,  $C_0$ ,  $D_0$ ,  $A_1$ ... into the D[15:0]P/N LVDS bus. Data into the DAC3484 is formatted according to the diagram shown in Figure 52 where index 0 is the data LSB and index 15 is the data MSB.



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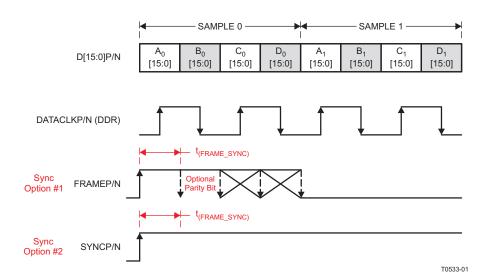


Figure 52. Word-wide Data Transmission Format

### 7.3.2.2 Byte-Wide Format

The dual-bus, 8-bit interface is selected by setting  $16bit\_in$  to 0b in the config2 register. In this mode the 16-bit data for channels A and B is interleaved in the form  $A_0[15:8]$ ,  $A_0[7:0]$ ,  $B_0[15:8]$ ,  $B_0[7:0]$ ,  $A_1[15:8]$ ... into the D[15:8]P/N LVDS inputs. Similarly data for channels C and D is interleaved into the D[7:0]P/N LVDS inputs. Data into the DAC3484 is formatted according to the diagram shown in Figure 53 where index 0 is the data LSB and index 15 is the data MSB.

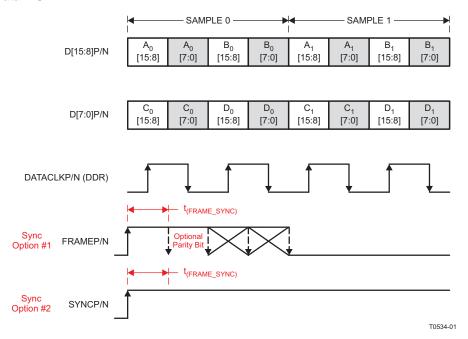


Figure 53. Byte-wide Data Transmission Format

### 7.3.3 Input FIFO

The DAC3484 includes a 4-channel, 16-bits wide, and 8-samples deep input FIFO which acts as an elastic buffer. The purpose of the FIFO is to absorb any timing variations between the input data and the internal DAC data rate clock such as the ones resulting from clock-to-data variations from the data source.

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Figure 54 shows a simplified block diagram of the FIFO. The following sections provide brief overviews of the FIFO, device synchronization, and device clocking. For more details of the topics, please refer to application note SLAA584.

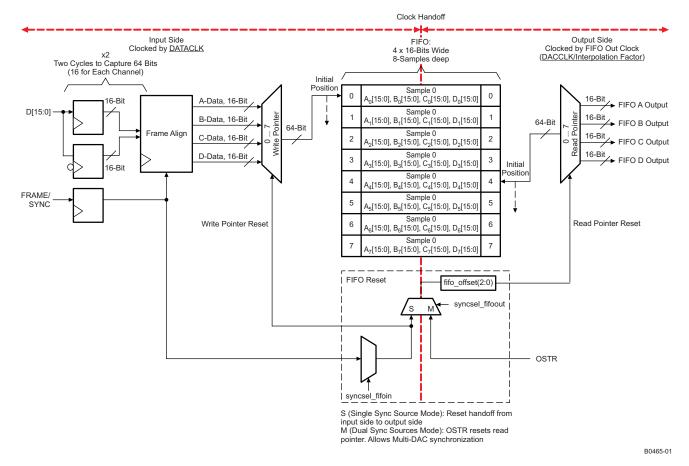


Figure 54. DAC3484 FIFO Block Diagram

Data is written to the device 16-bits at a time on the rising and falling edges of DATACLK. In order to form a complete 64-bit wide sample (16-bit A-data, 16-bit B-data, 16-bit C-data, and 16-bit D-data) two DATACLK periods are required. Each 64-bit wide sample is written into the FIFO at the address indicated by the write pointer. Similarly, data from the FIFO is read by the FIFO Out Clock 64-bits at a time from the address indicated by the read pointer. The FIFO Out Clock is generated internally from the DACCLK signal and its rate is equal to DACCLK/Interpolation. Each time a FIFO write or FIFO read is done the corresponding pointer moves to the next address.

The reset position for the FIFO read and write pointers is set by default to addresses 0 and 4 as shown in Figure 54. This offset gives optimal margin within the FIFO. The default read pointer location can be set to another value using fifo\_offset(2:0) in register config9 (address 4 by default). Under normal conditions data is written-to and read-from the FIFO at the same rate and consequently the write and read pointer gap remains constant. If the FIFO write and read rates are different, the corresponding pointers will be cycling at different speeds which could result in pointer collision. Under this condition the FIFO attempts to read and write data from the same address at the same time which will result in errors and thus must be avoided.

The write pointer sync source is selected by *syncsel\_fifoin(3:0)* in register *config32*. In most applications either FRAME or SYNC are used to reset the write pointer. Unlike DATA, the sync signal is latched only on the rising edges of DATACLK. A rising edge on the sync signal source causes the pointer to return to its original position.



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Similarly, the read pointer sync source is selected by <code>syncsel\_fifoout(3:0)</code>. The write pointer sync source can be set to reset the read pointer as well. In this case, FIFO Out clock will recapture the write pointer sync signal to reset the read pointer. This clock domain transfer (DATACLK to FIFO Out Clock) results in phase ambiguity of the reset signal, and will create latency variation based on the capture edge of the FIFO Out Clock. Since the reset signal also synchronizes the clock divider circuit for the FIFO Out Clock generation, the latency variation also includes the capture edge of the DACCLK cycle in the clock divider stage. Ultimately, the variation in capture edge of both the FIFO Out Clock and the DACCLK limits the precise control of the output timing latency. The full latency control of the DAC will be difficult and is not recommended in this setup.

#### NOTE

For full latency control of the DAC, refer to the Dual Sync Source mode section of the data sheet.

To alleviate this, the device offers the alternative of resetting the FIFO read pointer independently of the write pointer by using the OSTR signal. The OSTR signal is sampled by DACCLK and must satisfy the timing requirements in the specifications table. In order to minimize the skew it is recommended to use the same clock distribution device such as Texas Instruments CDCE62005 or LMK0480x family to provide the DACCLK and OSTR signals to all the DAC3484 devices in the system. Swapping the polarity of the DACCLK outputs with respect to the OSTR ones establishes proper phase relationship.

The FIFO pointers reset procedure can be done periodically or only once during initialization as the pointers automatically return to the initial position when the FIFO has been filled. To reset the FIFO periodically, it is necessary to have the FRAME, SYNC, and OSTR signals to repeat at multiples of 8 FIFO samples. To disable FIFO reset, set *syncsel\_fifoin(3:0)* and *syncsel\_fifoout(3:0)* to 0000b.

The frequency limitation for FRAME and SYNC signals are the following:

 $f_{sync} = f_{DATACLK}/(n \times 16)$  where n = 1, 2, ... for Word-Wide and Byte-Wide Mode

The frequency limitation for the OSTR signal is the following:

 $f_{OSTR} = f_{DAC}/(n \text{ x interpolation x 8})$  where n = 1, 2, ...

The frequencies above are at maximum when n = 1. This is when the FRAME, SYNC, or OSTR have a rising edge transition every 8 FIFO samples. The occurrence can be made less frequent by setting n > 1, for example, every  $n \times 8$  FIFO samples.

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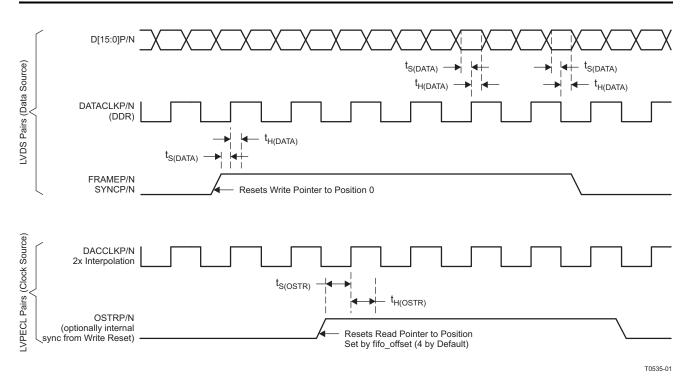


Figure 55. FIFO Write and Read Descriptions

#### 7.3.4 FIFO Modes of Operation

The DAC3484 input FIFO can be completely bypassed through registers *config0* and *config3*2. The register configuration for each mode is described in Table 3.

| Register | <b>Control Bits</b>  |  |  |
|----------|----------------------|--|--|
| config0  | fifo_ena             |  |  |
| config32 | syncsel_fifoout(3:0) |  |  |

**Table 3. FIFO Operation Modes** 

|                       | config0 and config32 FIFO Bits |                             |   |                                   |                                   |  |  |
|-----------------------|--------------------------------|-----------------------------|---|-----------------------------------|-----------------------------------|--|--|
| FIFO MODE             | fife and                       | syncsel_fifoout             |   |                                   |                                   |  |  |
|                       | fifo_ena                       | BIT 3: sif_sync BIT 2: OSTR |   | BIT 1: FRAME                      | BIT 0: SYNC                       |  |  |
| Dual Sync Sources     | 1                              | 0                           | 1 | 0                                 | 0                                 |  |  |
| Single Sync<br>Source | 1                              | 0                           | 0 | 1 or 0 Depends on the sync source | 1 or 0 Depends on the sync source |  |  |
| Bypass                | 0                              | Χ                           | Χ | X                                 | X                                 |  |  |

#### 7.3.4.1 Dual Sync Sources Mode

This is the recommended mode of operation for those applications that require precise control of the output timing. In Dual Sync Sources mode, the FIFO write and read pointers are reset independently. The FIFO write pointer is reset using the LVDS FRAME or SYNC signal, and the FIFO read pointer is reset using the LVPECL OSTR signal. This allows LVPECL OSTR signal to control the phase of the output for either a single chip or multiple chips. Multiple devices can be fully synchronized in this mode.

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### 7.3.4.2 Single Sync Source Mode

In Single Sync Source mode, the FIFO write and read pointers are reset from the same source, either LVDS FRAME or LVDS SYNC signal. As described in the Input FIFO section, this mode has latency variations in both the FIFO Out Clock and DAC Clock between the multiple DAC devices. Applications requiring exact output timing control will need Dual Sync Sources mode instead of Single Sync Source Mode. A rising edge for FIFO and clock divider sync is recommended. Periodic sync signal is not recommended due to non-deterministic latency of the sync signal through the clock domain transfer.

#### 7.3.4.3 Bypass Mode

In FIFO bypass mode, the FIFO block is not used. As a result the input data is handed off from the DATACLK to the DACCLK domain without any compensation. In this mode the relationship between DATACLK and DACCLK is critical and used as a synchronizing mechanism for the internal logic. Due to the this constraint this mode is not recommended. The effects of bypassing the FIFO are the following:

- The FIFO pointers have no effect on the data path or handoff.
- The FIFO will not be able to pass the controls signals from the LVDS FRAME and LVDS SYNC to digital circuits after the FIFO. These digital circuits mainly are quadrature modulation corrections circuits, complex mixer circuits, and numerical controlled oscillator circuits.

### 7.3.5 Clocking Modes

The DAC3484 has a dual clock setup in which a DAC clock signal is used to clock the DAC cores and internal digital logic and a separate DATA clock is used to clock the input LVDS receivers and FIFO input. The DAC3484 DAC clock signal can be sourced directly or generated through an on-chip low-jitter phase-locked loop (PLL).

In those applications requiring extremely low noise it is recommended to bypass the PLL and source the DAC clock directly from a high-quality external clock to the DACCLK input. In most applications system clocking can be simplified by using the on-chip PLL to generate the DAC core clock while still satisfying performance requirements. In this case the DACCLK pins are used as the reference frequency input to the PLL.

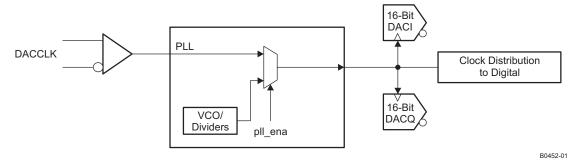


Figure 56. Top Level Clock Diagram

#### 7.3.5.1 PLL Bypass Mode

In PLL bypass mode a very high quality clock is sourced to the DACCLK inputs. This clock is used to directly clock the DAC3484 DAC sample rate clock. This mode gives the device best performance and is recommended for extremely demanding applications.

The bypass mode is selected by setting the following:

- 1. pll\_ena bit in register config24 to 0b to bypass the PLL circuitry.
- 2. pll\_sleep bit in register config26 to 1b to put the PLL and VCO into sleep mode.

#### 7.3.5.2 PLL Mode

In this mode the clock at the DACCLK input functions as a reference clock source to the on-chip PLL. The on-chip PLL will then multiply this reference clock to supply a higher frequency DAC sample rate clock. Figure 57 shows the block diagram of the PLL circuit.

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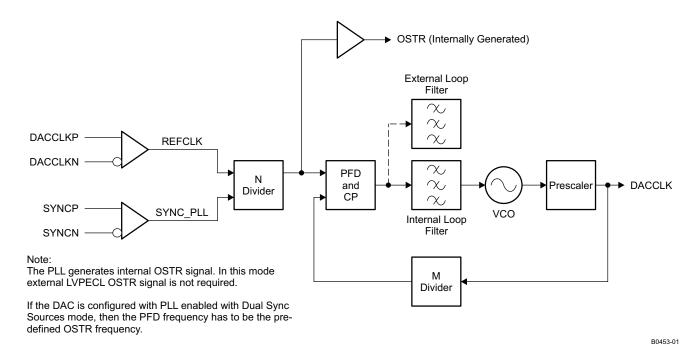


Figure 57. PLL Block Diagram

The DAC3484 PLL mode is selected by setting the following:

- 1. pll\_ena bit in register config24 to 1b to route to the PLL clock path.
- 2. pll\_sleep bit in register config26 to 0b to enable the PLL and VCO.

The output frequency of the VCO is designed to be the in the range from 3.3GHz to 4.0GHz. The prescaler value, pll\_p(2:0) in register config24, should be chosen such that the product of the prescaler value and DAC sample rate clock is within the VCO range. To maintain optimal PLL loop, the coarse tune bits, pll\_vco(5:0) in register config26, can adjust the center frequency of the VCO towards the product of the prescaler value and DAC sample rate clock. Figure 58 shows a typical relationship between coarse tune bits and VCO center frequency.

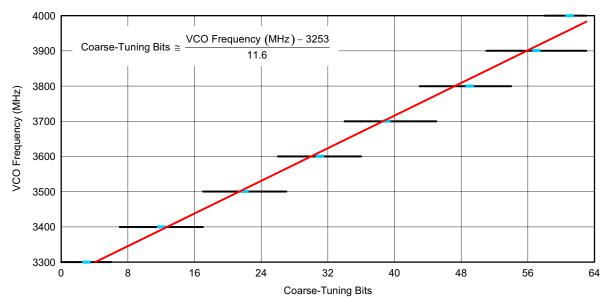


Figure 58. Typical PLL/VCO Lock Range vs Coarse Tuning Bits

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Common wireless infrastructure frequencies (614.4 MHz, 737.28 MHz, 1.2288 GHz, ...) are generated from this VCO frequency in conjunction with the pre-scaler setting as shown in Table 4.

**Table 4. VCO Operation** 

| VCO FREQUENCY<br>(MHz) | PRE-SCALE DIVIDER | DESIRED DACCLK (MHz) | pll_p(2:0) |
|------------------------|-------------------|----------------------|------------|
| 3440.64                | 7                 | 491.52               | 111        |
| 3686.4                 | 6                 | 614.4                | 110        |
| 3686.4                 | 5                 | 737.28               | 101        |
| 3686.4                 | 3                 | 1228.8               | 011        |

The M divider is used to determine the phase-frequency-detector (PFD) and charge-pump (CP) frequency.

Table 5. PFD and CP Operation

| DACCLK FREQUENCY<br>(MHz) | M DIVIDER | PDF UPDATE RATE (MHz) | pll_m(7:0) |
|---------------------------|-----------|-----------------------|------------|
| 491.52                    | 4         | 122.88                | 00000100   |
| 491.52                    | 8         | 61.44                 | 00001000   |
| 491.52                    | 16        | 30.72                 | 00010000   |
| 491.52                    | 32        | 15.36                 | 00100000   |

The N divider in the loop allows the PFD to operate at a lower frequency than the reference clock. Both M and N dividers can keep the PFD frequency below 155 MHz for peak operation.

The overall divide ratio inside the loop is the product of the Pre-Scale and M dividers (P \* M) and the following guidelines should be followed:

- The overall divide ratio range is from 24 to 480
- When the overall divide ratio is less than 120, the internal loop filter can guarantee a stable loop
- When the overall divide ratio is greater than 120, an external loop filter or double charge pump is required to ensure loop stability

The single- and double-charge-pump current option are selected by setting  $pll\_cp$  in register config24 to 01b and 11b, respectively. When using the double-charge-pump setting, an external loop filter is not required. If an external filter is required, the following filter should be connected to the LPF pin (A1 for RKD package and D12 for ZAY package):

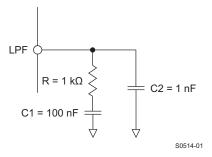


Figure 59. Recommended External Loop Filter

The PLL generates an internal OSTR signal and does not require the external LVPECL OSTR signal. The OSTR signal is buffered from the N-divider output in the PLL block, and the frequency of the signal is the same as the PFD frequency. Therefore, using PLL with Dual Sync Sources mode would require the PFD frequency to be the pre-defined OSTR frequency. This will allow the FIFO to be synced correctly by the internal OSTR.

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#### 7.3.6 FIR Filters

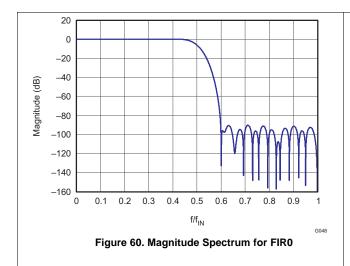
Figure 60 through Figure 63 show the magnitude spectrum response for the FIR0, FIR1, FIR2 and FIR3 interpolating filters where f<sub>IN</sub> is the input data rate to the FIR filter. Figure 64 to Figure 67 show the composite filter response for 2x, 4x, 8x and 16x interpolation. The transition band for all interpolation settings is from 0.4 to 0.6 x f<sub>DATA</sub> (the input data rate to the device) with <0.001dB of pass-band ripple and >90dB stop-band attenuation.

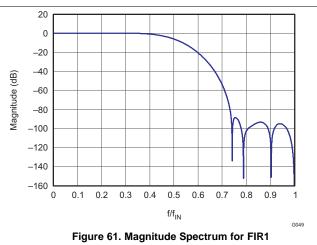
The DAC3484 also has a 9-tap inverse sinc filter (FIR4) that runs at the DAC update rate (f<sub>DAC</sub>) that can be used to flatten the frequency response of the sample-and-hold output. The DAC sample-and-hold output sets the output current and holds it constant for one DAC clock cycle until the next sample, resulting in the well-known sin(x)/x or sinc(x) frequency response (Figure 68, red line). The inverse sinc filter response (Figure 68, blue line) has the opposite frequency response from 0 to 0.4 x Fdac, resulting in the combined response (Figure 68, green line). Between 0 to 0.4 x f<sub>DAC</sub>, the inverse sinc filter compensates the sample-and-hold roll-off with less than 0.03dB error.

The inverse sinc filter has a gain >1 at all frequencies. Therefore, the signal input to FIR4 must be reduced from full scale to prevent saturation in the filter. The amount of back-off required depends on the signal frequency, and is set such that at the signal frequencies the combination of the input signal and filter response is less than 1 (0dB). For example, if the signal input to FIR4 is at 0.25 x f<sub>DAC</sub>, the response of FIR4 is 0.9dB, and the signal must be backed off from full scale by 0.9dB to avoid saturation. The gain function in the QMC blocks can be used to reduce the amplitude of the input signal. The advantage of FIR4 having a positive gain at all frequencies is that the user is then able to optimize the back-off of the signal based on its frequency.

The filter taps for all digital filters are listed in Table 6. Note that the loss of signal amplitude may result in lower SNR due to decrease in signal amplitude.

Product Folder Links: DAC3484





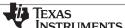
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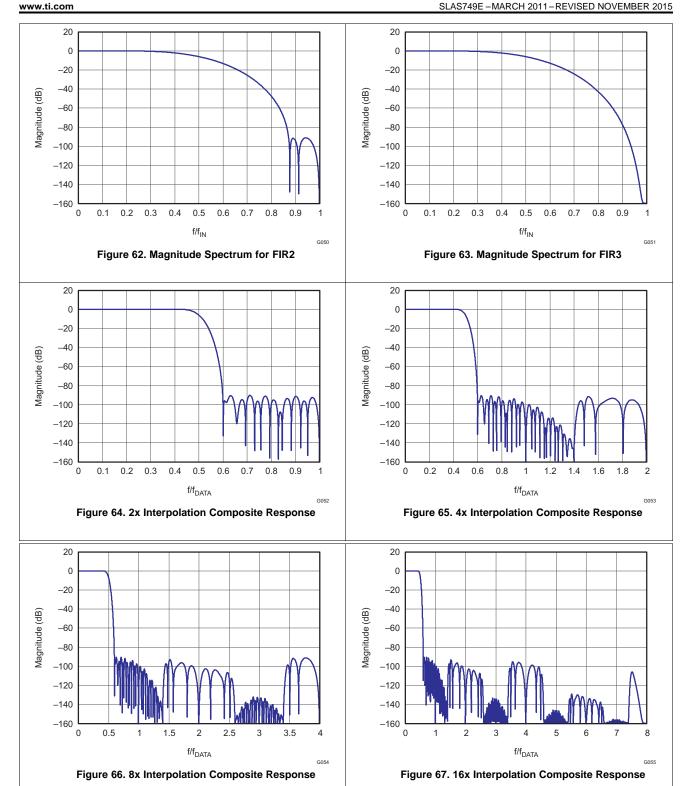
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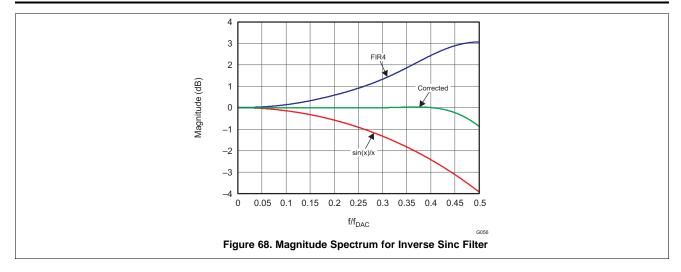
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#### **Table 6. FIR Filter Coefficients**

|                      |        | INTERI               | POLATING H | IALF-BAND FIL              | TERS |                           |     | NON-INTERPOLATING INVERSE-SINC FILTER |     |  |
|----------------------|--------|----------------------|------------|----------------------------|------|---------------------------|-----|---------------------------------------|-----|--|
| FI                   | R0     | FIF                  | ₹1         | FIF                        | ₹2   | FII                       | R3  | FIF                                   | R4  |  |
| 59 T                 | APS    | 23 T.                | APS        | 11 T.                      | APS  | 11 T                      | APS | 9 TA                                  | \PS |  |
| 6                    | 6      | -12                  | -12        | 29                         | 29   | 3                         | 3   | 1                                     | 1   |  |
| 0                    | 0      | 0                    | 0          | 0                          | 0    | 0                         | 0   | -4                                    | -4  |  |
| -19                  | -19    | 84                   | 84         | -214                       | -214 | -25                       | -25 | 13                                    | 13  |  |
| 0                    | 0      | 0                    | 0          | 0                          | 0    | 0                         | 0   | -50                                   | -50 |  |
| 47                   | 47     | -336                 | -336       | 1209                       | 1209 | 150                       | 150 | 592 <sup>(1)</sup>                    |     |  |
| 0                    | 0      | 0                    | 0          | <b>2048</b> <sup>(1)</sup> |      | <b>256</b> <sup>(1)</sup> |     |                                       |     |  |
| -100                 | -100   | 1006                 | 1006       |                            |      |                           |     |                                       |     |  |
| 0                    | 0      | 0                    | 0          |                            |      |                           |     |                                       |     |  |
| 192                  | 192    | -2691                | -2691      |                            |      |                           |     |                                       |     |  |
| 0                    | 0      | 0                    | 0          |                            |      |                           |     |                                       |     |  |
| -342                 | -342   | 10141                | 10141      |                            |      |                           |     |                                       |     |  |
| 0                    | 0      | 16384 <sup>(1)</sup> |            |                            |      |                           |     |                                       |     |  |
| 572                  | 572    |                      |            |                            |      |                           |     |                                       |     |  |
| 0                    | 0      |                      |            |                            |      |                           |     |                                       |     |  |
| -914                 | -914   |                      |            |                            |      |                           |     |                                       |     |  |
| 0                    | 0      |                      |            |                            |      |                           |     |                                       |     |  |
| 1409                 | 1409   |                      |            |                            |      |                           |     |                                       |     |  |
| 0                    | 0      |                      |            |                            |      |                           |     |                                       |     |  |
| -2119                | -2119  |                      |            |                            |      |                           |     |                                       |     |  |
| 0                    | 0      |                      |            |                            |      |                           |     |                                       |     |  |
| 3152                 | 3152   |                      |            |                            |      |                           |     |                                       |     |  |
| 0                    | 0      |                      |            |                            |      |                           |     |                                       |     |  |
| -4729                | -4729  |                      |            |                            |      |                           |     |                                       |     |  |
| 0                    | 0      |                      |            |                            |      |                           |     |                                       |     |  |
| 7420                 | 7420   |                      |            |                            |      |                           |     |                                       |     |  |
| 0                    | 0      |                      |            |                            |      |                           |     |                                       |     |  |
| -13334               | -13334 |                      |            |                            |      |                           |     |                                       |     |  |
| 0                    | 0      |                      |            |                            |      |                           |     |                                       |     |  |
| 41527                | 41527  |                      |            |                            |      |                           |     |                                       |     |  |
| 65536 <sup>(1)</sup> |        |                      |            |                            |      |                           |     |                                       |     |  |

(1) Center taps are highlighted in BOLD

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### 7.3.7 Complex Signal Mixer

The DAC3484 has two paths of complex signal mixer blocks that contain two full complex mixer (FMIX) blocks and power saving coarse mixer (CMIX) blocks. The signal path is shown in Figure 69.

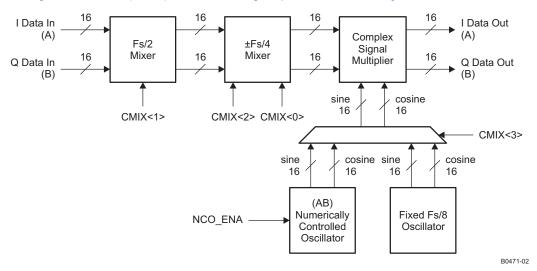


Figure 69. Path of Complex Signal Mixer

#### 7.3.7.1 Full Complex Mixer

The two FMIX blocks operate with independent Numerically Controlled Oscillators (NCOs) and enable flexible frequency placement without imposing additional limitations in the signal bandwidth. The NCOs have 32-bit frequency registers (phaseaddAB(31:0) and phaseaddCD(31:0)) and 16-bit phase registers (phaseoffsetAB(15:0) and phaseoffsetCD(15:0)) that generate the sine and cosine terms for the complex mixing. The NCO block diagram is shown in Figure 70.

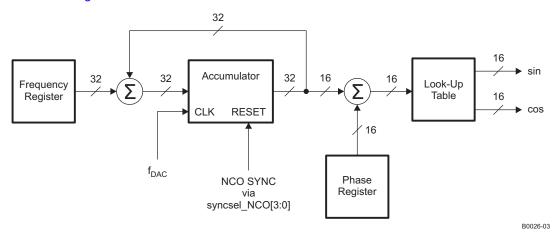


Figure 70. NCO Block Diagram

Synchronization of the NCOs occurs by resetting the NCO accumulators to zero. The synchronization source is selected by *syncsel\_NCO(3:0)* in *config31*. The frequency word in the *phaseaddAB(31:0)* and *phaseaddCD(31:0)* registers is added to the accumulators every clock cycle, f<sub>DAC</sub>. The output frequency of the NCO is:

$$f_{NCO} = \frac{freq \times f_{NCO\_CLK}}{2^{32}}$$
 (1)

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With the complex mixer enabled, the two channels in the mixer path are treated as complex vectors of the form  $I_{IN}(t) + j Q_{IN}(t)$ . The complex signal multiplier (shown in Figure 71) will multiply the complex channels with the sine and cosine terms generated by the NCO. The resulting output,  $I_{OUT}(t) + j Q_{OUT}(t)$ , of the complex signal multiplier is:

$$\begin{split} I_{OUT}(t) &= (I_{IN}(t)cos(2\pi f_{NCO}t + \delta) - Q_{IN}(t)sin(2\pi f_{NCO}t + \delta)) \times 2^{(mixer\_gain - 1)} \\ Q_{OUT}(t) &= (I_{IN}(t)sin(2\pi f_{NCO}t + \delta) + Q_{IN}(t)cos(2\pi f_{NCO}t + \delta)) \times 2^{(mixer\_gain - 1)} \end{split}$$

where t is the time since the last resetting of the NCO accumulator,  $\delta$  is the phase offset value and *mixer\_gain* is either 0 or 1.  $\delta$  is given by:

 $\delta = 2\pi \times phase\_offsetAB/CD(15:0)/2^{16}$ 

The *mixer\_gain* option allows the output signals of the multiplier to reduce by half (6dB). See Mixer Gain section for details.

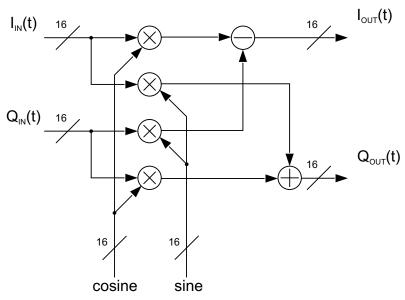


Figure 71. Complex Signal Multiplier

#### 7.3.7.2 Coarse Complex Mixer

In addition to the full complex mixer, the DAC3484 also has a coarse mixer block capable of shifting the input signal spectrum by the fixed mixing frequencies  $\pm n \times f_S/8$ . Using the coarse mixer instead of the full mixer lowers power consumption.

The output of the fs/2, fs/4, and -fs/4 mixer block is:

$$\begin{split} I_{OUT}(t) &= I(t)cos(2\pi f_{CMIX}t) - Q(t)sin(2\pi f_{CMIX}t) \\ Q_{OUT}(t) &= I(t)sin(2\pi f_{CMIX}t) + Q(t)cos(2\pi f_{CMIX}t) \end{split}$$

Since the sine and the cosine terms are a function of fs/2, fs/4, or –fs/4 mixing frequencies, the possible resulting value of the terms will only be 1, -1, or 0. The simplified mathematics allows the complex signal multiplier to be bypassed in any one of the modes, thus mixer gain is not available. The fs/2, fs/4, and –fs/4 mixer blocks performs mixing through negating and swapping of I/Q channel on certain sequence of samples. Table 7 shows the algorithm used for those mixer blocks.

Table 7. Fs/2, Fs/4, and -Fs/4 Mixing Sequence

| MODE                    | MIXING SEQUENCE             |  |  |  |  |  |
|-------------------------|-----------------------------|--|--|--|--|--|
| Normal (miyor bynagad)  | lout = {+11, +12, +13, +14} |  |  |  |  |  |
| Normal (mixer bypassed) | Qout = {+Q1, +Q2, +Q3, +Q4} |  |  |  |  |  |
| fo/2                    | lout = {+I1, -I2, +I3, -I4} |  |  |  |  |  |
| fs/2                    | Qout = {+Q1, -Q2, +Q3, -Q4} |  |  |  |  |  |

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Table 7. Fs/2, Fs/4, and –Fs/4 Mixing Sequence (continued)

| MODE  | MIXING SEQUENCE             |  |  |  |  |  |
|-------|-----------------------------|--|--|--|--|--|
| fs/4  | lout = {+l1, -Q2, -l3, +Q4} |  |  |  |  |  |
| 15/4  | Qout = {+Q1, +l2, -Q3, -l4} |  |  |  |  |  |
| -fs/4 | lout = {+11, +Q2, -13, -Q4} |  |  |  |  |  |
| -IS/4 | Qout = {+Q1, -l2, -Q3, +l4} |  |  |  |  |  |

The fs/8 mixer can be enabled along with various combinations of fs/2, fs/4, and –fs/4 mixer. Since the fs/8 mixer uses the complex signal multiplier block with fixed fs/8 sine and cosine term, the output of the multiplier is:

$$\begin{split} I_{OUT}(t) &= (I_{IN}(t)cos(2\pi f_{NCO}t + \delta) - Q_{IN}(t)sin(2\pi f_{NCO}t + \delta)) \times 2^{(mixer\_gain - 1)} \\ Q_{OUT}(t) &= (I_{IN}(t)sin(2\pi f_{NCO}t + \delta) + Q_{IN}(t)cos(2\pi f_{NCO}t + \delta)) \times 2^{(mixer\_gain - 1)} \end{split}$$

where  $f_{CMIX}$  is the fixed mixing frequency selected by cmix(3:0). The mixing combinations are described in Table 8. The  $mixer\_gain$  option allows the output signals of the multiplier to reduce by half (6dB). See Mixer Gain section for details.

**Table 8. Coarse Mixer Combinations** 

| cmix(3:0)  | Fs/8 MIXER cmix(3) | Fs/4 MIXER cmix(2) | Fs/2 MIXER cmix(1) | -Fs/4 MIXER cmix(0) | MIXING MODE     |
|------------|--------------------|--------------------|--------------------|---------------------|-----------------|
| 0000       | Disabled           | Disabled           | Disabled           | Disabled            | No mixing       |
| 0001       | Disabled           | Disabled           | Disabled           | Enabled             | -Fs/4           |
| 0010       | Disabled           | Disabled           | Enabled            | Disabled            | Fs/2            |
| 0100       | Disabled           | Enabled            | Disabled           | Disabled            | +Fs/4           |
| 1000       | Enabled            | Disabled           | Disabled           | Disabled            | +Fs/8           |
| 1010       | Enabled            | Disabled           | Enabled            | Disabled            | -3Fs/8          |
| 1100       | Enabled            | Enabled            | Disabled           | Disabled            | +3Fs/8          |
| 1110       | Enabled            | Enabled            | Enabled            | Disabled            | -Fs/8           |
| All others | _                  | _                  | -                  | _                   | Not recommended |

#### 7.3.7.3 Mixer Gain

The maximum output amplitude out of the complex signal multiplier (i.e., FMIX mode or CMIX mode with fs/8 mixer enabled) occurs if  $I_{IN}(t)$  and  $Q_{IN}(t)$  are simultaneously full scale amplitude and the sine and cosine arguments are equal to  $2\pi \times f_{MIX}t + \delta$  (2N-1)  $\times \pi/4$ , where N = 1, 2, 3, etc....

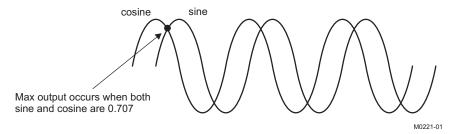


Figure 72. Maximum Output of the Complex Signal Multiplier

With  $mixer\_gain = 1$  and both  $I_{IN}(t)$  and  $Q_{IN}(t)$  are simultaneously full scale amplitude, the maximum output possible out of the complex signal multiplier is 0.707 + 0.707 = 1.414 (or 3dB). This configuration can cause clipping of the signal and should therefore be used with caution.

With  $mixer\_gain = 0$  in config2, the maximum output possible out of the complex signal multiplier is 0.5 x (0.707 + 0.707) = 0.707 (or -3dB). This loss in signal power is in most cases undesirable, and it is recommended that the gain function of the QMC block be used to increase the signal by 3dB to compensate.



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### 7.3.7.4 Real Channel Upconversion

The mixer in the DAC34H84 treats the A, B, C, and D inputs are complex input data and produces a complex output for most mixing frequencies. The real input data for each channel can be isolated only when the mixing frequency is set to normal mode or fs/2 mode. Refer to Table 7 for details.

### 7.3.8 Quadrature Modulation Correction (QMC)

#### 7.3.8.1 Gain and Phase Correction

The DAC3484 includes a Quadrature Modulator Correction (QMC) block. The QMC blocks provide a mean for changing the gain and phase of the complex signals to compensate for any I and Q imbalances present in an analog quadrature modulator. The block diagram for the QMC block is shown in Figure 73. The QMC block contains 3 programmable parameters.

Register *qmc\_gainA/B(10:0)* and *qmc\_gainC/D(10:0)* controls the I and Q path gains and is an 11-bit unsigned value with a range of 0 to 1.9990 and the default gain is 1.0000. The implied decimal point for the multiplication is between bit 9 and bit 10.

Register *qmc\_phaseAB/CD(11:0)* control the phase imbalance between I and Q and is a 12-bit values with a range of –0.5 to approximately 0.49975. The QMC phase term is not a direct phase rotation but a constant that is multiplied by each "Q" sample then summed into the "I" sample path. This is an approximation of a true phase rotation in order to keep the implementation simple. The corresponding phase rotation corresponds to approximately +26.5 to –26.5 degrees in 4096 steps.

LO feed-through can be minimized by adjusting the DAC offset feature described below.

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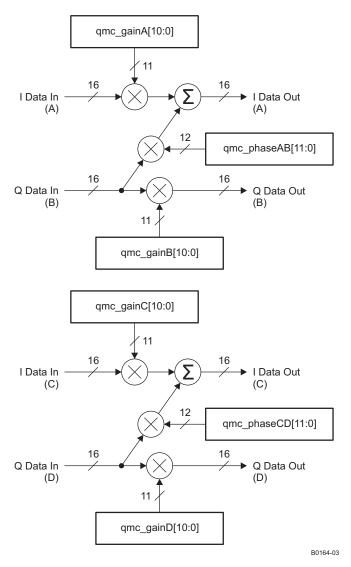


Figure 73. QMC Block Diagram

#### 7.3.8.2 Offset Correction

Registers  $qmc\_offsetA(12:0)$ ,  $qmc\_offsetB(12:0)$ ,  $qmc\_offsetC(12:0)$  and  $qmc\_offsetD(12:0)$  can be used to independently adjust the DC offsets of each channel. The offset values are in represented in 2s-complement format with a range from -4096 to 4095.

The offset value adds a digital offset to the digital data before digital-to-analog conversion. Since the offset is added directly to the data it may be necessary to back off the signal to prevent saturation. Both data and offset values are LSB aligned.



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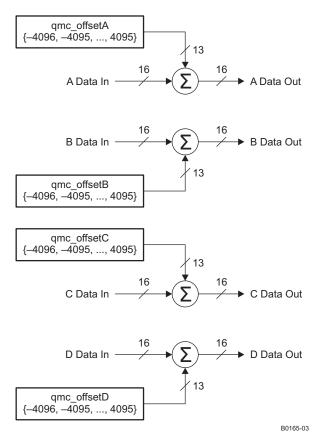


Figure 74. Digital Offset Block Diagram

#### 7.3.8.3 Group Delay Correction

A complex transmitter system typically is consisted of DACs, reconstruction filter network, and I/Q modulator. Besides the gain and phase mismatch contribution, there could also be timing mismatch contribution from each components. For instance, the timing mismatch could come from the PCB trace length variation between the I and Q channels and the group delay variation from the reconstruction filter.

This timing mismatch in the complex transmitter system creates phase mismatch that varies linearly with respect to frequency. To compensate for the I/Q imbalances due to this mismatch, the DAC3484 has group delay correction block for each DAC channel. Each DAC channel can adjust its delay through  $grp\_delayA(7:0)$ ,  $grp\_delayB(7:0)$ ,  $grp\_delayB(7:0)$ ,  $grp\_delayB(7:0)$ , and  $grp\_delayD(7:0)$  in register config46 and config47. The group delay correction, along with gain/phase correction, can be useful for correcting imbalances in wide-band transmitter system. The maximum delay ranges from 30 ps to 100 ps and is dependent on DAC sample clock. Contact TI for specific application information.

### 7.3.9 Temperature Sensor

The DAC3484 incorporates a temperature sensor block which monitors the temperature by measuring the voltage across 2 transistors. The voltage is converted to an 8-bit digital word using a successive-approximation (SAR) analog to digital conversion process. The result is scaled, limited and formatted as a twos complement value representing the temperature in degrees Celsius.

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The sampling is controlled by the serial interface signals SDENB and SCLK. If the temperature sensor is enabled (tsense\_sleep = 0b in register config26) a conversion takes place each time the serial port is written or read. The data is only read and sent out by the digital block when the temperature sensor is read in tempdata(7:0) in config6. The conversion uses the first eight clocks of the serial clock as the capture and conversion clock, the data is valid on the falling eighth SCLK. The data is then clocked out of the chip on the rising edge of the ninth SCLK. No other clocks to the chip are necessary for the temperature sensor operation. As a result the temperature sensor is enabled even when the device is in sleep mode.

In order for the process described above to operate properly, the serial port read from config6 must be done with an SCLK period of at least 1 µs. If this is not satisfied the temperature sensor accuracy is greatly reduced.

### 7.3.10 Data Pattern Checker

The DAC3484 incorporates a simple pattern checker test in order to determine errors in the data interface. The main cause of failures is setup/hold timing issues. The test mode is enabled by asserting *iotest\_ena* in register *config1*. In test mode the analog outputs are deactivated regardless of the state of TXENABLE or *sif\_texnable* in register *config3*.

The data pattern key used for the test is 8 words long and is specified by the contents of *iotest\_pattern[0:7]* in registers *config37* through *config44*. The data pattern key can be modified by changing the contents of these registers.

The first word in the test frame is determined by a rising edge transition in FRAME or SYNC, depending on the syncsel\_fifoin(4:0) setting in config32. At this transition, the pattern0 word should be input to the data pins. Patterns 1 through 7 should follow sequentially on each edge of DATACLK (rising and falling). The sequence should be repeated until the pattern checker test is disabled by setting iotest\_ena back to 0b. It is not necessary to have a rising FRAME or SYNC edge aligned with every pattern0 word, just the first one to mark the beginning of the series.

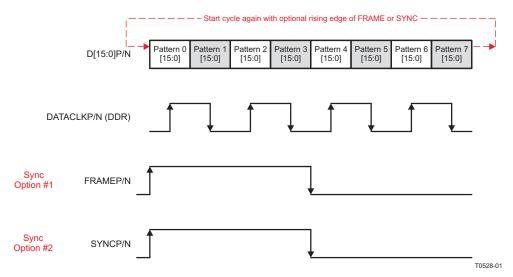


Figure 75. IO Pattern Checker Data Transmission Format

The test mode determines if the 16-bit LVDS data D[15:0]P/N of all the patterns were received correctly by comparing the received data against the data pattern key. If any of the 16-bit data D[15:0]P/N were received incorrectly, the corresponding bits in *iotest\_results(15:0)* in register *config4* will be set to 1b to indicate bit error location. Furthermore, the error condition will trigger the *alarm\_from\_iotest* bit in register *config5* to indicate a general error in the data interface. When data pattern checker mode is enabled, this alarm in register *config5*, bit 7 is the only valid alarm. Other alarms in register *config5* are not valid and can be disregarded.

For instance, pattern0 is programmed to the default of 0x7A7A. If the received Pattern 0 is 0x7A7B, then bit 0 in iotest\_results(15:0) will be set to 1b to indicate an error in bit 0 location. The alarm\_from\_iotest will also be set to 1b to report the data transfer error. The user can then narrow down the error from the bit location information and implement the fix accordingly.



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The alarms can be cleared by writing 0x0000 to <code>iotest\_results(15:0)</code> and 0b to <code>alarm\_from\_iotest</code> through the serial interface. The serial interface will read back 0s if there are no errors or if the errors are cleared. The corresponding alarm bit will remain a 1b if the errors remain.

It is recommended to enable the pattern checker and then run the pattern sequence for 100 or more complete cycles before clearing the *iotest\_results(15:0)* and *alarm\_from\_iotest*. This will eliminate the possibility of false alarms generated during the setup sequence.

Based on the pattern test result, the user can adjust the data source output timing, PCB traces delay, or DAC3484 CONFIG36 LVDS Programmable delay to help optimize the setup and hold time of the transmitter system.



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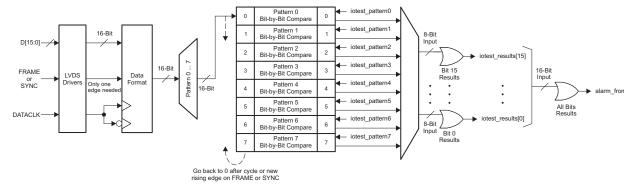


Figure 76. DAC3484 Pattern Check Block Diagram

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### 7.3.11 Parity Check Test

The DAC3484 has a parity check test that enables continuous validity monitoring of the data received by the DAC. Parity check testing in combination with the data pattern checker offer an excellent solution for detecting board assembly issues due to missing pad connections.

For the parity check test, an extra parity bit is added to the data bits to ensure that the total number of set bits (bits with value 1) is even or odd. This simple scheme is used to detect single or any other odd number of data transfer errors. Parity testing is implemented in the DAC3484 in two ways: word-by-word parity and block parity.

#### 7.3.11.1 Word-by-Word Parity

Word-by-word parity is the easiest mode to implement. In this mode the additional parity bit is sourced to the parity input (PARITYP/N) for each data word transfer into the D[15:0]P/N inputs. This mode is enabled by setting the *word\_parity\_ena* bit. The input parity value is defined to be the total number of logic 1s on the 17-bit data bus, the D[15:0]P/N inputs and the PARITYP/N input. This value, the total number of logic 1s, must match the parity test selected in the *oddeven\_parity* bit in register *config1*.

For example, if the oddeven\_parity bit is set to 1b for odd parity, then the number of 1s on the 17-bit data bus should be odd. The DAC will check the data transfer through the parity input. If the data received has odd number of 1s, then the parity is correct. If the data received has even number of 1s, then the parity is incorrect. The corresponding alarm for parity error will be set accordingly.

Figure 77 shows the simple XOR structure used to check word parity. Parity is tested independently for data captured on both rising and falling edges of DATACLK (*alarm\_rparity* and *alarm\_fparity*, respectively). Testing on both edges helps in determining a possible setup/hold issue. Both alarms are captured individually in register *config5*.

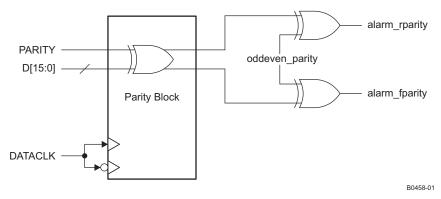


Figure 77. DAC3484 Word-by-Word Parity Check

#### 7.3.11.2 Block Parity

The block parity method uses the FRAME signal to determine the boundaries of the data block to compute parity. This mode is enabled by setting the *frame parity ena* bit in register *config1*.

A low-to-high transition of FRAME captured with the DATACLK rising edge determines the end point of the parity block and the beginning of the next one. In this method the parity bit of the completed block corresponds to the FRAME value captured on the DATACLK falling edge right after the STOP/START point.

The input parity value is defined to be the total number of logic 1s in the data block. A logic HIGH captured on the falling edge of DATACLK indicates odd parity or odd number of logic 1s, while a logic LOW indicates even parity or even number of logic 1s. If the expected parity does not match the number of logic 1s in the received data, then <code>alarm\_frame\_parity</code> in register <code>config5</code> will be set to 1b. The main advantage of the block parity mode is that there is no need for an additional parity LVDS input.

Since the FRAME signal is used for parity testing in addition to FIFO syncing and frame boundary assignment it is mandatory to take some extra steps to avoid device malfunction. If FRAME is used to reset the FIFO pointers continuously, the block size must be a multiple of 8 samples (each sample corresponding to 16-bits A, B, C and D data). In addition since FRAME is used to establish the frame boundary, the parity block must be aligned with the data frame boundaries.



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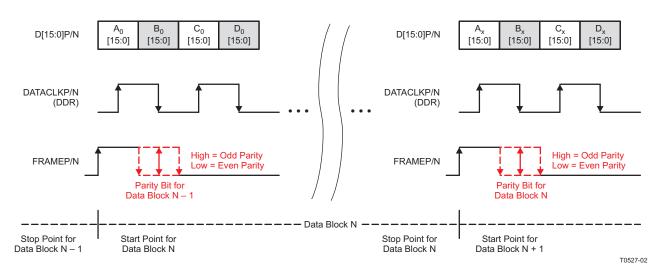
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Notes: Rising edge of FRAMEP/N indicates the beginning of data block.

Parity bit for the current data block is latched on falling edge of DATACLK after the start point for next data block.

Figure 78. DAC3484 Block Parity Check (Example shown with Word Wide Mode)

## 7.3.12 DAC3484 Alarm Monitoring

The DAC3484 includes a flexible set of alarm monitoring that can be used to alert of a possible malfunction scenario. All the alarm events can be accessed either through the *config5* register or through the ALARM pin. Once an alarm is set, the corresponding alarm bit in register *config5* must be reset through the serial interface to allow further testing. The set of alarms includes the following conditions:

#### Zero check alarm

Alarm\_from\_zerochk. Occurs when the FIFO write pointer has an all zeros pattern. Since the write pointer is a
shift register, all zeros will cause the input pointer to be stuck until the next sync event. When this happens a
sync to the FIFO block is required.

#### FIFO alarms

- alarm from fifo. Occurs when there is a collision in the FIFO pointers or a collision event is close.
  - alarm fifo 2away. Pointers are within two addresses of each other.
  - alarm\_fifo\_1away. Pointers are within one address of each other.
  - alarm\_fifo\_collision. Pointers are equal to each other.

#### Clock alarms

- clock gone. Occurs when either the DACCLK or DATACLOCK have been stopped.
  - alarm\_dacclk\_gone. Occurs when the DACCLK has been stopped.
  - alarm\_dataclk\_gone. Occurs when the DATACLK has been stopped.

#### Pattern checker alarm

alarm from iotest. Occurs when the input data pattern does not match the pattern key.

#### PLL alarm

alarm\_from\_pll. Occurs when the PLL is out of lock.

#### Parity alarms

- alarm\_rparity. Occurs when there is a parity error in the data captured by the rising edge of DATACLKP/N.
  The PARITYP/N input is the parity bit (word-by-word parity test).
- alarm\_fparity. Occurs when there is a parity error in the data captured by the falling edge of DATACLKP/N.
   The PARITYP/N input is the parity bit (word-by-word parity test).
- alarm\_frame\_parity\_err. Occurs when there is a frame parity error when using the FRAME as the parity bit (block parity test).

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To prevent unexpected DAC outputs from propagating into the transmit channel chain, the clock and alarm\_fifo\_collision alarms can be set in *config2* to shut-off the DAC output automatically regardless of the state of TXENABLE or *sif\_txenable*.

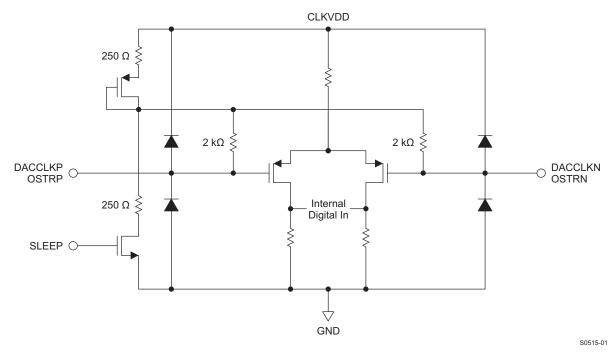
Alarm monitoring is implemented as follows:

- Power up the device using the recommended power-up sequence.
- Clear all the alarms in *config5* by setting them to 0.
- Unmask those alarms that will generate a hardware interrupt through the ALARM pin in config7.
- Enable automatic DAC shut-off in register config2 if required.
- In the case of an alarm event, the ALARM pin will trigger. If automatic DAC shut-off has been enabled the DAC outputs will be disabled.
- Read registers config5 to determine which alarm triggered the ALARM pin.
- Correct the error condition and re-synchronize the FIFO.
- Clear the alarms in config5.
- Re-read config5 to ensure the alarm event has been corrected.
- Keep clearing and reading config5 until no error is reported.

For details of alarm monitoring function and behavior, refer to SLAA585.

### 7.3.13 LVPECL Inputs

Figure 79 shows an equivalent circuit for the DAC input clock (DACCLKP/N) and the output strobe clock (OSTRP/N).



NOTE: Input common mode level is internally biased

Figure 79. DACCLKP/N and OSTRP/N Equivalent Input Circuit

Figure 80 shows the preferred configuration for driving the CLKIN/CLKINC input clock with a differential ECL/PECL source.

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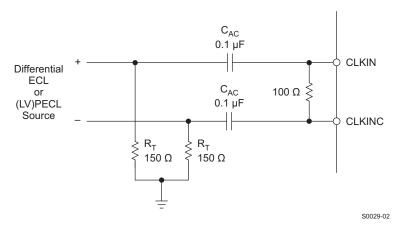
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NOTE: Actual R<sub>T</sub> value depends on differential clock driver output termination recommendation. It is driver type dependent.

Figure 80. Preferred Clock Input Configuration with a Differential ECL/PECL Clock Source

#### 7.3.14 LVDS Inputs

The D[15:0]P/N, DATACLKP/N, SYNCP/N, PARITYP/N, and FRAMEP/N LVDS pairs have the input configuration shown in Figure 81. Figure 82 shows the typical input levels and common-move voltage used to drive these inputs.

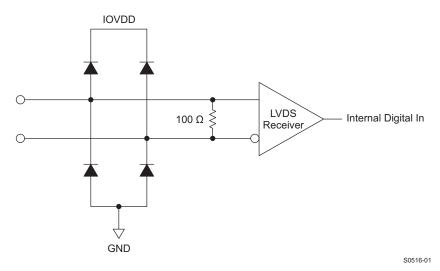


Figure 81. D[15:0]P/N, DATACLKP/N, FRAMEP/N, SYNCP/N and PARITYP/N LVDS Input Configuration

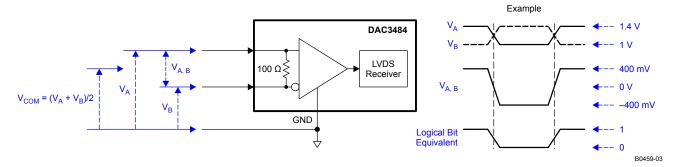


Figure 82. LVDS Data Input Levels

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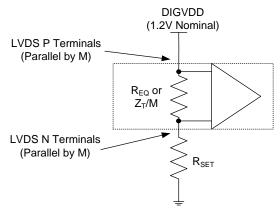
Table 9. Example LVDS Data Input Levels

| APPLIED VOLTAGES |                                 | RESULTING<br>DIFFERENTIAL<br>VOLTAGE | RESULTING COMMON-<br>MODE VOLTAGE | LOGICAL BIT<br>BINARY<br>EQUIVALENT |  |  |
|------------------|---------------------------------|--------------------------------------|-----------------------------------|-------------------------------------|--|--|
| V <sub>A</sub>   | V <sub>B</sub> V <sub>A,B</sub> |                                      | V <sub>COM</sub>                  | EQUIVALENT                          |  |  |
| 1.4 V            | 1.0 V                           | 400 mV                               | 1.2 V                             | 1                                   |  |  |
| 1.0 V            | 1.4 V                           | -400 mV                              | 1.2 V                             | 0                                   |  |  |
| 1.2 V            | 0.8 V                           | 400 mV                               | 1.0 V                             | 1                                   |  |  |
| 0.8 V            | 1.2 V                           | -400 mV                              | 1.0 V                             | 0                                   |  |  |

### 7.3.15 Unused LVDS Port Termination

Depending on the DAC3484 functionality required, additional unused LVDS ports such as FRAMEP/N, SYNCP/N, or PARITYP/N can be left unconnected (floating) or connected to a nominal, differential LVDS active HIGH or active LOW voltage. The usage of these ports depends mainly on the FIFO synchronization settings and parity checking settings. The unused FRAMEP/N, SYNCP/N, or PARITYP/N ports can be connected in parallel with the unused LVDS data port with adjustments to the  $R_{\rm SFT}$  resistor value.

The following example allows the termination of the unused LVDS ports to a known logic HIGH value. As shown in Figure 83, The design involves the connection to the DIGVDD rail and one  $R_{SET}$  resistor to bias the positive terminals of unused LVDS ports to be 1.2 V and negative terminals of unused LVDS ports to 1.0 V. The design keeps the minimum common mode input voltage of the LVDS input to be above 1.0 V, and keeps the differential LVDS voltage to be 200 mV. Since the design expects the differential voltage on the unused ports to be static, the differential LVDS voltage can be as low as 100 mV to maintain a logic HIGH. Refer to Electrical Characteristic – Digital Specifications Table for detail of LVDS Input requirements.



- M Unused LVDS Ports Connected in Parallel.
- Keep Positive Terminals at 1.2V.
- Keep Static Differential Voltages above 100mV.

Figure 83. Unused LVDS Ports Connected to Static Logic High Differential Voltage

- 1. Connect the positive terminals of unused LVDS ports in parallel to DIGVDD supply at 1.2 V nominal. For instance, connect SYNC and PARITY positive pins together to DIGVDD.
- 2. Connect the negative terminals of unused LVDS ports in parallel to a R<sub>SET</sub> resistor to ground.
- 3. The  $R_{EQ}$  value is the equivalent, parallel resistance of the on-chip termination for all the unused LVDS ports. With the SYNC and PARITY ports unused, the  $R_{EQ}$  is two parallel  $Z_T$ . Worst case  $Z_T$  value of 135  $\Omega$  is used in the design to account for the lowest possible current  $I_{EQ}$  and the worst case common mode on the negative LVDS terminals. Another analysis will be performed with  $Z_T$  value of 85  $\Omega$  for worst case differential LVDS voltages.
- With Ohm's Law, the following equation describes the relationship between R<sub>SET</sub> and R<sub>EQ</sub>.

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$$\frac{R_{SET}}{R_{SET} + R_{EQ}} = \frac{1.0}{1.2}$$

$$R_{SET} = 4.988R_{EQ} \tag{2}$$

- 5. With  $R_{EQ}$  of two parallel, 135  $\Omega$   $Z_T$  (or 67.5  $\Omega$  equivalent),  $R_{SET}$  is 332  $\Omega$  with standard 1% resistor value.  $I_{EQ}$  is approximately 3 mA. The expected voltage at negative terminals of LVDS ports is approximately 1.0 V. The differential LVDS voltage is 200 mV.
- 6. With same  $R_{SET}$  of 332  $\Omega$ , if the  $R_{EQ}$  has dropped to two parallel, 85  $\Omega$   $Z_T$  (or 42.5  $\Omega$  equivalent),  $I_{EQ}$  is approximately 3.2 mA. The expected voltage at negative terminals of LVDS port is approximately 1.06 V. The differential LVDS voltage is 136 mV. As long as the static LVDS differential voltage is above 100 mV, the LVDS port will register a logic HIGH value for the data.

### 7.3.16 CMOS Digital Inputs

Figure 84 shows a schematic of the equivalent CMOS digital inputs of the DAC3484. SDIO, SCLK, SLEEP and TXENABLE have pull-down resistors while SDENB and RESETB have pull-up resistors internal to the DAC3484. See the specification table for logic thresholds. The pull-up and pull-down circuitry is approximately equivalent to  $100k\Omega$ .

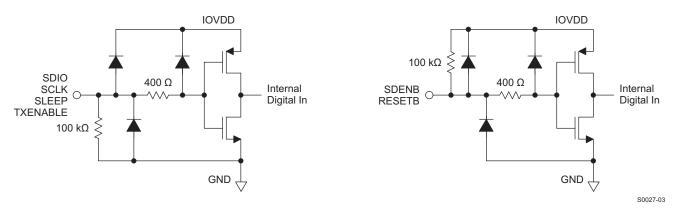


Figure 84. CMOS Digital Equivalent Input

#### 7.3.17 Reference Operation

The DAC3484 uses a bandgap reference and control amplifier for biasing the full-scale output current. The full-scale output current is set by applying an external resistor  $R_{BIAS}$  to pin BIASJ. The bias current  $I_{BIAS}$  through resistor  $R_{BIAS}$  is defined by the on-chip bandgap reference voltage and control amplifier. The default full-scale output current equals 64 times this bias current and can thus be expressed as:

$$IOUT_{FS} = 64 \times I_{BIAS} = 64 \times (V_{EXTIO} / R_{BIAS}) / 2$$

The DAC3484 has a 4-bit coarse gain control *coarse\_dac(3:0)* in the *config3* register. Using gain control, the IOUT<sub>FS</sub> can be expressed as:

$$IOUT_{FS} = (coarse\_dac + 1)/16 \times I_{BIAS} \times 64 = (coarse\_dac + 1)/16 \times (V_{EXTIO} / R_{BIAS}) / 2 \times 64$$

where  $V_{\text{EXTIO}}$  is the voltage at terminal EXTIO. The bandgap reference voltage delivers an accurate voltage of 1.2 V. This reference is active when  $extref\_ena = 0b$  in config27. An external decoupling capacitor  $C_{\text{EXT}}$  of 0.1  $\mu$ F should be connected externally to terminal EXTIO for compensation. The bandgap reference can additionally be used for external reference operation. In that case, an external buffer with high impedance input should be applied in order to limit the bandgap load current to a maximum of 100 nA. The internal reference can be disabled and overridden by an external reference by setting the  $extref\_ena$  control bit. Capacitor  $C_{\text{EXT}}$  may hence be omitted. Terminal EXTIO thus serves as either input or output node.

The full-scale output current can be adjusted from 30 mA down to 10 mA by varying resistor  $R_{\text{BIAS}}$  or changing the externally applied reference voltage.



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#### **NOTE**

With internal reference, the minimum Rbias resistor value is 1.28 k $\Omega$ . Resistor value below 1.28 k $\Omega$  is not recommended since it will program the full-scale current to go above 30mA and potentially damages the device.

#### 7.3.18 DAC Transfer Function

The CMOS DACs consist of a segmented array of PMOS current sources, capable of sourcing a full-scale output current up to 30 mA. Differential current switches direct the current to either one of the complementary output nodes IOUTP or IOUTN. Complementary output currents enable differential operation, thus canceling out common mode noise sources (digital feed-through, on-chip and PCB noise), dc offsets, even order distortion components, and increasing signal output power by a factor of two.

The full-scale output current is set using external resistor  $R_{BIAS}$  in combination with an on-chip bandgap voltage reference source (+1.2 V) and control amplifier. Current  $I_{BIAS}$  through resistor  $R_{BIAS}$  is mirrored internally to provide a maximum full-scale output current equal to 64 times  $I_{BIAS}$ .

The relation between IOUTP and IOUTN can be expressed as:

$$IOUT_{FS} = IOUTP + IOUTN$$

We will denote current flowing into a node as – current and current flowing out of a node as + current. Since the output stage is a current source the current flows from the IOUTP and IOUTN pins. The output current flow in each pin driving a resistive load can be expressed as:

```
\begin{aligned} &\text{IOUTP} = \text{IOUT}_{\text{FS}} \text{ x CODE} \text{ / } 65536 \\ &\text{IOUTN} = \text{IOUT}_{\text{FS}} \text{ x (} 65535 - \text{CODE)} \text{ / } 65536 \\ &\text{where CODE is the decimal representation of the DAC data input word} \end{aligned}
```

For the case where IOUTP and IOUTN drive resistor loads  $R_L$  directly, this translates into single ended voltages at IOUTP and IOUTN:

```
VOUTP = IOUT1 \times R_L
VOUTN = IOUT2 \times R_I
```

Assuming that the data is full scale (65535 in offset binary notation) and the  $R_L$  is 25  $\Omega$ , the differential voltage between pins IOUTP and IOUTN can be expressed as:

```
VOUTP = 20mA x 25 \Omega = 0.5 V
VOUTN = 0mA x 25 \Omega = 0 V
VDIFF = VOUTP - VOUTN = 0.5V
```

Note that care should be taken not to exceed the compliance voltages at node IOUTP and IOUTN, which would lead to increased signal distortion.

### 7.3.19 Analog Current Outputs

The DAC3484 can be easily configured to drive a doubly terminated  $50-\Omega$  cable using a properly selected RF transformer. Figure 85 and Figure 86 show the  $50-\Omega$  doubly terminated transformer configuration with 1:1 and 4:1 impedance ratio, respectively. Note that the center tap of the primary input of the transformer has to be grounded to enable a DC current flow. Applying a 20-mA full-scale output current would lead to a 0.5 Vpp for a 1:1 transformer and a 1 Vpp output for a 4:1 transformer. The low dc-impedance between IOUTP or IOUTN and the transformer center tap sets the center of the ac-signal to GND, so the 1 Vpp output for the 4:1 transformer results in an output between -0.5 V and 0.5 V.

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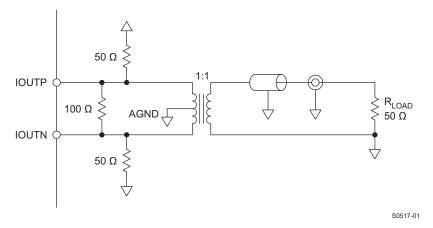


Figure 85. Driving a Doubly terminated 50-Ω Cable Using a 1:1 Impedance Ratio Transformer

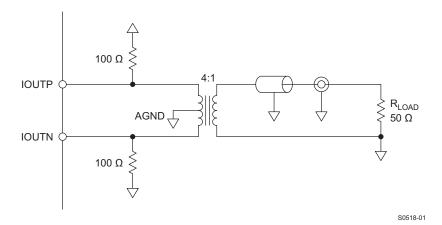


Figure 86. Driving a Doubly Terminated 50-Ω Cable Using a 4:1 Impedance Ratio Transformer

## 7.4 Device Functional Modes

### 7.4.1 Multi-Device Synchronization

In various applications, such as multi antenna systems where the various transmit channels information is correlated, it is required that multiple DAC devices are completely synchronized such that their outputs are phase aligned. The DAC3484 architecture supports this mode of operation.

### 7.4.1.1 Multi-Device Synchronization: PLL Bypassed with Dual Sync Sources Mode

For single or multi-device synchronization it is important that delay differences in the data are absorbed by the device so that latency through the device remains the same. Furthermore, to guarantee that the outputs from each DAC are phase aligned it is necessary that data is read from the FIFO of each device simultaneously. In the DAC3484 this is accomplished by operating the multiple devices in Dual Sync Sources mode. In this mode the additional OSTR signal is required by each DAC3484 to be synchronized.

Data into the device is input as LVDS signals from one or multiple baseband ASICs or FPGAs. Data into the multiple DAC devices can experience different delays due to variations in the digital source output paths or board level wiring. These different delays can be effectively absorbed by the DAC3484 FIFO so that all outputs are phase aligned correctly.

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## **Device Functional Modes (continued)**

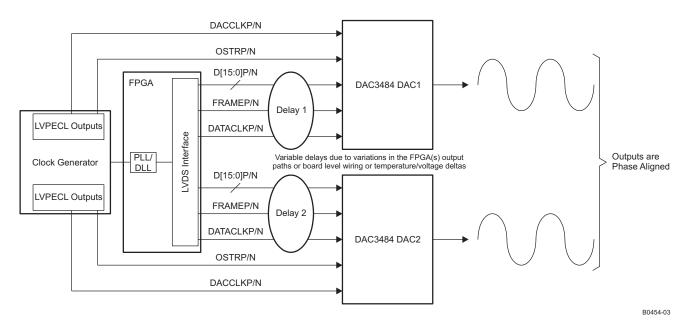


Figure 87. SynchronizationSystem in Dual Sync Sources Mode with PLL Bypassed

For correct operation both OSTR and DACCLK must be generated from the same clock domain. The OSTR signal is sampled by DACCLK and must satisfy the timing requirements in the specifications table. If the clock generator does not have the ability to delay the DACCLK to meet the OSTR timing requirement, the polarity of the DACCLK outputs can be swapped with respect to the OSTR ones to create 180 degree phase delay of the DACCLK. This may help establish proper setup and hold time requirement of the OSTR signal.

Careful board layout planning must be done to ensure that the DACCLK and OSTR signals are distributed from device to device with the lowest skew possible as this will affect the synchronization process. In order to minimize the skew across devices it is recommended to use the same clock distribution device to provide the DACCLK and OSTR signals to all the DAC devices in the system.

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### **Device Functional Modes (continued)**

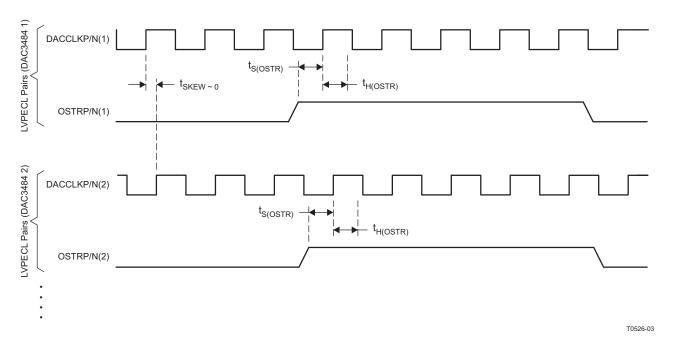


Figure 88. Timing Diagram for LVPECL Synchronization Signals

The following steps are required to ensure the devices are fully synchronized. The procedure assumes all the DAC3484 devices have a DACCLK and OSTR signal and must be carried out on each device.

- 1. Start-up the device as described in the power-up sequence. Set the DAC3484 in Dual Sync Sources mode and select OSTR as the clock divider sync source (*clkdiv\_sync\_sel* in register *config32*).
- 2. Sync the clock divider and FIFO pointers.
- 3. Verify there are no FIFO alarms either through register config5 or through the ALARM pin.
- 4. Disable clock divider sync by setting clkdiv sync ena to 0b in register config0.

After these steps all the DAC3484 outputs will be synchronized.

### 7.4.1.2 Multi-Device Synchronization: PLL Enabled with Dual Sync Sources Mode

The DAC3484 allows exact phase alignment between multiple devices even when operating with the internal PLL clock multiplier. In PLL clock mode, the PLL generates the DAC clock and an internal OSTR signal from the reference clock applied to the DACCLK inputs so there is no need to supply an additional LVPECL OSTR signal.

For this method to operate properly the SYNC signal should be set to reset the PLL N dividers to a known state by setting  $pll\_ndivsync\_ena$  in register config24 to 1b. The SYNC signal resets the PLL N dividers with a rising edge, and the timing relationship  $t_{s(SYNC\_PLL)}$  and  $t_{h(SYNC\_PLL)}$  are relative to the reference clock presented on the DACCLK pin.

Both SYNC and DACCLK can be set as low frequency signals to greatly simplifying trace routing (SYNC can be just a pulse as a single rising edge is required, if using a periodic signal it is recommended to clear the <code>pll\_ndivsync\_ena</code> bit after resetting the PLL dividers). Besides the <code>t\_s(SYNC\_PLL)</code> and <code>t\_h(SYNC\_PLL)</code> requirement between SYNC and DACCLK, there is no additional required timing relationship between the SYNC and FRAME signals or between DACCLK and DATACLK. The only restriction as in the PLL disabled case is that the DACCLK and SYNC signals are distributed from device to device with the lowest skew possible.

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### **Device Functional Modes (continued)**

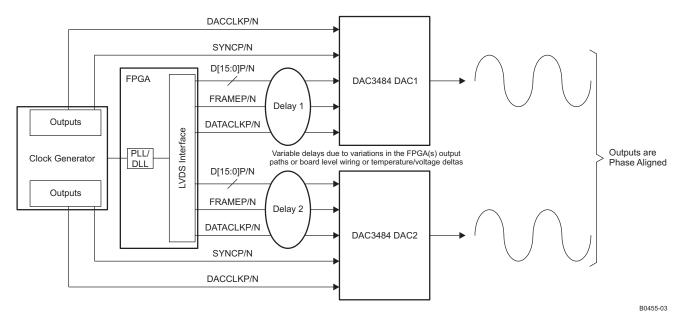


Figure 89. Synchronization System in Dual Sync Sources Mode with PLL Enabled

The following steps are required to ensure the devices are fully synchronized. The procedure assumes all the DAC3484 devices have a DACCLK and SYNC signal and the following steps must be carried out on each device.

- 1. Start-up the device as described in the power-up sequence. Set the DAC3484 in Dual Sync Sources mode and enable SYNC to reset the PLL dividers (set *pll\_ndivsync\_ena* in register *config24* to 1b).
- 2. Reset the PLL dividers with a rising edge on SYNC.
- 3. Disable PLL dividers resetting.
- 4. Sync the clock divider and FIFO pointers.
- 5. Verify there are no FIFO alarms either through register config5 or through the ALARM pin.
- 6. Disable clock divider sync by setting clkdiv\_sync\_ena to 0b in register config0.

After these steps all the DAC3484 outputs will be synchronized.

### 7.4.1.3 Multi-Device Operation: Single Sync Source Mode

In Single Sync Source mode the FIFO read pointer reset is handoff between the two clock domains (DATACLK and FIFO OUT CLOCK) by simply re-sampling the write pointer reset. Since the two clocks are asynchronous there is a small but distinct possibility of a meta-stability during the pointer handoff. As described in the Input FIFO section, this meta-stable situation can change the latency of the multiple DAC devices by both the FIFO Out clock cycles and DAC clock cycles.

When the PLL is enabled with Single Sync Source mode, the FIFO read pointer is not synchronized by the OSTR signal. Therefore, there is no restriction on the PLL PFD frequency as described in the previous section.

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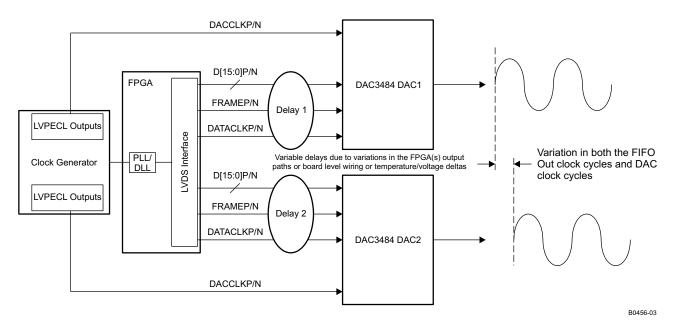


Figure 90. Multi-Device Operation in Single Sync Source Mode

### 7.5 Programming

### 7.5.1 Power-Up Sequence

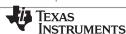
The following startup sequence is recommended to power-up the DAC3484:

- 1. Set TXENABLE low
- 2. Supply all 1.2-V voltages (DACVDD, DIGVDD, CLKVDD, and VFUSE) and all 3.3-V voltages (AVDD, IOVDD, and PLLAVDD). The 1.2-V and 3.3-V supplies can be powered up simultaneously or in any order. There are no specific requirements on the ramp rate for the supplies.
- 3. Provide all LVPECL inputs: DACCLKP/N and the optional OSTRP/N. These inputs can also be provided after the SIF register programming.
- 4. Toggle the RESETB pin for a minimum 25 ns active low pulse width.
- 5. Program the SIF registers.
- 6. Program fuse\_sleep (config27, bit<11>) to put the internal fuses to sleep. To enable dual channel mode, set Config1, bit <8> to 0b and Config16, bit<13:12> to 11b. This dual channel mode is functionally equivalent to the dual channel DAC3484 (channels B and C active). See the DAC3484 SLAS748 datasheet for details.
- 7. FIFO configuration needed for synchronization:
  - (a) Program syncsel\_fifoin(3:0) (config32, bits<15:12>) to select the FIFO input pointer sync source.
  - (b) Program syncsel\_fifoout(3:0) (config32, bits<11:8>) to select the FIFO output pointer sync source.
  - (c) Program syncsel\_dataformatter(1:0) (config31, bits<3:2>) to select the FIFO Data Formatter sync source.
- 8. Clock divider configuration needed for synchronization:
  - (a) Program clkdiv\_sync\_sel (config32, bit<0>) to select the clock divider sync source.
  - (b) Program clkdiv\_sync\_ena (config0, bit<2>) to 1b to enable clock divider sync.
  - (c) For multi-DAC synchronization in PLL mode, program pll\_ndivsync\_ena (config24, bit<11>) to 1b to synchronize the PLL N-divider.
- 9. Provide all LVDS inputs (D[15:0]P/N, DATACLKP/N, FRAMEP/N, SYNCP/N, and PARITYP/N) simultaneously. Synchronize the FIFO and clock divider by providing the pulse or periodic signals needed.
  - (a) For Single Sync Source Mode where either FRAMEP/N or SYNCP/N is used to sync the FIFO, a single rising edge for FIFO, FIFO data formatter, and clock divider sync is recommended. Periodic sync signal



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## **Programming (continued)**

is not recommended due to the non-deterministic latency of the sync signal through the clock domain transfer.

- (b) For Dual Sync Sources Mode, both single pulse or periodic sync signals can be used.
- (c) For multi-DAC synchronization in PLL mode, the LVDS SYNCP/N signal is used to sync the PLL N-divider and can be sourced from either the FPGA/ASIC pattern generator or clock distribution circuit as long as the t<sub>(SYNC\_PLL)</sub> setup and hold timing requirement is met with respect to the reference clock source at DACCLKP/N pins. The LVDS SYNCP/N signal can be provided at this point.
- 10. FIFO and clock divider configurations after all the sync signals have provided the initial sync pulses needed for synchronization:
  - (a) For Single Sync Source Mode where the clock divider sync source is either FRAMEP/N or SYNCP/N, clock divider syncing may be disabled after DAC3484 initialization and before the data transmission by setting *clkdiv\_sync\_ena* (config0, bit <2>) to 0b. This is to prevent accidental syncing of the clock divider when sending FRAMEP/N or SYNCP/N pulse to other digital blocks.
  - (b) For Dual Sync Sources Mode, where the clock divider sync source is from the OSTR signal (either from external OSTRP/N or internal PLL N divider output), the clock divider syncing may be enabled at all time.
  - (c) Optionally, to prevent accidental syncing of the FIFO and FIFO data formatter when sending the FRAMEP/N or SYNCP/N pulse to other digital blocks such as NCO, QMC, etc, disable FIFO syncing by setting syncsel\_fifoin(3:0) and syncsel\_fifoout(3:0) to 0000b after the FIFO input and output pointers are initialized. Also Disable the FIFO data formatter by setting syncsel\_dataformatter(1:0) to 10b or 11b. If the FIFO and FIFO data formatter sync remain enabled after initialization, the FRAMEP/N or SYNCP/N pulse must occur in ways to not disturb the FIFO operation. Refer to the INPUT FIFO section for detail.
  - (d) Disable PLL N-divider syncing by setting pll\_ndivsync\_ena (config24, bit<11>) to 0b.
- 11. Enable transmit of data by asserting the TXENABLE pin or set sif txenable to 1b.
- 12. At any time, if any of the clocks (i.e DATACLK or DACCLK) is lost or a FIFO collision alarm is detected, a complete resynchronization of the DAC is necessary. Set TXENABLE low and repeat steps 7 through 11. Program the FIFO configuration and clock divider configuration per steps 7 and 8 appropriately to accept the new sync pulse or pulses for the synchronization.

### 7.5.2 Example Start-Up Routine

#### 7.5.2.1 Device Configuration

 $f_{DATA} = 307.2 MSPS$ 

Interpolation = 4x

Input data = baseband data

 $f_{OUT} = 122.88 \text{ MHz}$ 

PLL = Enabled

Full Mixer = Enabled

**Dual Sync Sources Mode** 

### 7.5.2.2 PLL Configuration

f<sub>REFCLK</sub> = 614.4 MHz at the DACCLKP/N LVPECL pins

 $f_{DACCLK} = f_{DATA} x Interpolation = 1228.8 MHz$ 

 $f_{VCO} = 3 \times f_{DACCLK} = 3686.4 \text{ MHz}$  (keep  $f_{VCO}$  between 3.3 GHz to 4 GHz)

 $PFD = f_{OSTR} = 38.4 MHz$ 

N = 16, M = 32, P = 3, single charge pump

 $pII_vco(5:0) = 100100b (36)$ 

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### **Programming (continued)**

### 7.5.2.3 NCO Configuration

 $f_{NCO}$  = 122.88 MHz  $f_{NCO\_CLK}$  = 1228.8 MHz

freq =  $f_{NCO} \times 2^32 / 1228.8 = 429496730 = 0 \times 19999994$ 

phaseaddAB(31:0) or phaseaddCD(31:0) = 0x19999999A

NCO SYNC = rising edge of SYNC

### 7.5.2.4 Example Start-Up Sequence

### Table 10. Example Start-Up Sequence Description

| STEP | READ/WRITE | ADDRESS | VALUE  | DESCRIPTION   |
|------|------------|---------|--------|---|
| 1    | N/A        | N/A     | N/A    | Set TXENABLE Low  |
| 2    | N/A        | N/A     | N/A    | Power-up the device   |
| 3    | N/A        | N/A     | N/A    | Apply LVPECL DACCLKP/N for PLL reference clock  |
| 4    | N/A        | N/A     | N/A    | Toggle RESETB pin   |
| 5    | Write      | 0x00    | 0xF29F | QMC offset and correction enabled, 4x int, FIFO enabled, Alarm enabled, clock divider sync enabled, inverse sinc filter enabled.        |
| 6    | Write      | 0x01    | 0x050E | Single parity enabled, FIFO alarms enabled (2 away, 1 away, and collision).   |
| 7    | Write      | 0x02    | 0xF052 | Output shut-off when DACCLK gone, DATACLK gone, and FIFO collision. Mixer block with NCO enabled, twos complement. Word Wide Interface. |
| 8    | Write      | 0x03    | 0xA000 | Output current set to 20mAFS with internal reference and 1.28-k $\Omega$ $R_{\text{BIAS}}$ resistor.                                    |
| 9    | Write      | 0x07    | 0xD8FF | Un-mask FIFO collision, DACCLK-gone, and DATACLK-gone alarms to the Alarm output.   |
| 10   | Write      | 0x08    | N/A    | Program the desired channel A QMC offset value. (Causes Auto-Sync for QMC AB-Channels Offset Block)                                     |
| 11   | Write      | 0x09    | N/A    | Program the desired FIFO offset value and channel B QMC offset value.   |
| 12   | Write      | 0x0A    | N/A    | Program the desired channel C QMC offset value. (Causes Auto-Sync for QMC CD-Channels Offset Block)                                     |
| 13   | Write      | 0x0B    | N/A    | Program the desired channel D QMC offset value.   |
| 14   | Write      | 0x0C    | N/A    | Program the desired channel A QMC gain value.   |
| 15   | Write      | 0x0D    | N/A    | Coarse mixer mode not used. Program the desired channel B QMC gain value.   |
| 16   | Write      | 0x0E    | N/A    | Program the desired channel C QMC gain value.   |
| 17   | Write      | 0x0F    | N/A    | Program the desired channel D QMC gain value.   |
| 18   | Write      | 0x10    | N/A    | Program the desired channel AB QMC phase value. (Causes Auto-Sync QMC AB-Channels Correction Block)                                     |
| 19   | Write      | 0x11    | N/A    | Program the desired channel CD QMC phase value. (Causes Auto-Sync for the QMC CD-Channels Correction Block)                             |
| 20   | Write      | 0x12    | N/A    | Program the desired channel AB NCO phase offset value. (Causes Auto-Sync for Channel AB NCO Mixer)                                      |
| 21   | Write      | 0x13    | N/A    | Program the desired channel CD NCO phase offset value. (Causes Auto-Sync for Channel CD NCO Mixer)                                      |
| 22   | Write      | 0x14    | 0x999A | Program the desired channel AB NCO frequency value  |
| 23   | Write      | 0x15    | 0x1999 | Program the desired channel AB NCO frequency value  |
| 24   | Write      | 0x16    | 0x999A | Program the desired channel CD NCO frequency value  |
| 25   | Write      | 0x17    | 0x1999 | Program the desired channel CD NCO frequency value  |
| 26   | Write      | 0x18    | 0x2C58 | PLL enabled, PLL N-dividers sync enabled, single charge pump, prescaler = 3.  |
| 27   | Write      | 0x19    | 0x20F4 | M = 32, N = 16, PLL VCO bias tune = 01b   |



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## **Programming (continued)**

### **Table 10. Example Start-Up Sequence Description (continued)**

| STEP | READ/WRITE | ADDRESS | VALUE  | DESCRIPTION  |
|------|------------|---------|--------|--|
| 28   | Write      | 0x1A    | 0x9000 | PLL VCO coarse tune = 36   |
| 29   | Write      | 0x1B    | 0x0800 | Internal reference   |
| 30   | Write      | 0x1E    | 0x9999 | QMC offset AB, QMC offset CD, QMC correction AB, and QMC correction CD can be synced by sif_sync or auto-sync from register write                                  |
| 31   | Write      | 0x1F    | 0x4440 | Mixer AB and CD values synced by SYNCP/N. NCO accumulator synced by SYNCP/N.   |
| 32   | Write      | 0x20    | 0x2400 | FIFO Input Pointer Sync Source = ISTR FIFO Output Pointer Sync Source = OSTR (from PLL N-divider output) Clock Divider Sync Source = OSTR                          |
| 33   | N/A        | N/A     | N/A    | Provide all the LVDS DATA and DATACLK Provide rising edge FRAMEP/N and rising edge SYNCP/N to sync the FIFO input pointer and PLL N-dividers.                      |
| 34   | Read       | 0x18    | N/A    | Read back pll_lfvolt(2:0). If the value is not optimal, adjust pll_vco(5:0) in 0x1A.   |
| 35   | Write      | 0x05    | 0x0000 | Clear all alarms in 0x05.  |
| 36   | Read       | 0x05    | N/A    | Read back all alarms in 0x05. Check for PLL lock, FIFO collision, DACCLK-gone, DATACLK-gone, etc. Fix the error appropriately. Repeat step 34 and 35 as necessary. |
| 37   | Write      | 0x1F    | 0x4442 | Sync all the QMC blocks using sif_sync. These blocks can also be synced via auto-sync through appropriate register writes.   |
| 38   | Write      | 0x00    | 0xF29B | Disable clock divider sync.  |
| 39   | Write      | 0x1F    | 0x4448 | Set sif_sync to 0b for the next sif_sync event.  |
| 40   | Write      | 0x20    | 0x0000 | Disable FIFO input and output pointer sync.  |
| 41   | Write      | 0x18    | 0x2458 | Disable PLL N-dividers sync.   |
| 42   | N/A        | N/A     | N/A    | Set TXENABLE high. Enable data transmission.   |



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### 7.6 Register Map

### Table 11. Register Map<sup>(1)</sup>

| Name     | Address | Default | (MSB)<br>Bit 15            | Bit 14  | Bit 13                 | Bit 12  | Bit 11             | Bit 10                  | Bit 9                    | Bit 8                     | Bit 7                     | Bit 6               | Bit 5               | Bit 4               | Bit 3                   | Bit 2                      | Bit 1                       | (LSB)<br>Bit 0    |
|----------|---------|---------|----------------------------|---|------------------------|---|--------------------|-------------------------|--------------------------|---------------------------|---------------------------|---------------------|---------------------|---------------------|-------------------------|----------------------------|-----------------------------|-------------------|
| config0  | 0x00    | 0x049C  | qmc_<br>offsetAB_<br>ena   | qmc_<br>offsetCD_<br>ena                              | qmc_<br>corrAB_<br>ena | qmc_<br>corrCD_<br>ena  |                    | interp                  | 0(3:0)                   |                           | fifo_ena                  | reserved            | reserved            | alarm_out_<br>ena   | alarm_out<br>pol        | clkdiv_<br>sync_ ena       | invsincAB_<br>ena           | invsincCD_<br>ena |
| config1  | 0x01    | 0x050E  | iotest_ena                 | reserved  | reserved               | 64cnt_<br>ena   | oddeven_<br>parity | word_<br>parity_<br>ena | frame_<br>parity_<br>ena | quad_ena                  | dacA_<br>complement       | dacB_<br>complement | dacC_<br>complement | dacD_<br>complement | alarm_<br>2away_<br>ena | alarm_<br>1away_<br>ena    | alarm_<br>collision_<br>ena | reserved          |
| config2  | 0x02    | 0x7000  | 16bit_in                   | dacclk<br>gone_ena                                    | dataclk<br>gone_ena    | collision_<br>gone_ena  | reserved           | reserved                | reserved                 | reserved                  | sif4_ena                  | mixer_ena           | mixer_gain          | nco_ena             | revbus                  | reserved                   | twos                        | reserved          |
| config3  | 0x03    | 0xF000  |                            | coarse_   | dac(3:0)               |   |                    | rese                    | rved                     |                           |                           |                     |                     | reserved            |                         |                            |                             | sif_txenable      |
| config4  | 0x04    | NA      |                            |   |                        |   |                    |                         |                          | io                        | test_results(15           | :0)                 |                     |                     |                         |                            |                             |                   |
| config5  | 0x05    | 0x0000  | alarm_<br>from_<br>zerochk | reserved  | alar                   | alarms_from_fifo(2:0) alarm_<br>dacclk_<br>gone   |                    |                         |                          | alarm_<br>output_<br>gone | alarm_<br>from_<br>iotest | reserved            | alarm_<br>from_pll  | alarm_<br>rparity   | alarm_<br>fparity       | alarm_<br>frame_<br>parity | reserved                    | reserved          |
| config6  | 0x06    | NA      |                            |   |                        | tempda  | ata(7:0)           |                         |                          |                           |                           |                     | reserv              | ed                  |                         |                            | reserved                    | reserved          |
| config7  | 0x07    | 0xFFFF  |                            | alarms_mask(15:0)                                     |                        |   |                    |                         |                          |                           |                           |                     |                     |                     |                         |                            |                             |                   |
| config8  | 0x08    | 0x0000  | reserved                   | reserved reserved reserved reserved qmc_offsetA(12:0) |                        |   |                    |                         |                          |                           |                           |                     |                     |                     |                         |                            |                             |                   |
| config9  | 0x09    | 0x8000  | f                          | ifo_offset(2:0  | )                      | qmc_offsetB(12:0)   |                    |                         |                          |                           |                           |                     |                     |                     |                         |                            |                             |                   |
| config10 | 0x0A    | 0x0000  | reserved                   | reserved  | reserved               |   | qmc_offsetC(12:0)  |                         |                          |                           |                           |                     |                     |                     |                         |                            |                             |                   |
| config11 | 0x0B    | 0x0000  | reserved                   | reserved  | reserved               |   | qmc_offsetD(12:0)  |                         |                          |                           |                           |                     |                     |                     |                         |                            |                             |                   |
| config12 | 0x0C    | 0x0400  | reserved                   | reserved  | reserved               | reserved  | reserved           |                         |                          |                           |                           |                     | qmc_gainA(10        | :0)                 |                         |                            |                             |                   |
| config13 | 0x0D    | 0x0400  |                            | cmix  | (3:0)                  |   | reserved           |                         |                          |                           |                           |                     | qmc_gainB(10        | :0)                 |                         |                            |                             |                   |
| config14 | 0x0E    | 0x0400  | reserved                   | reserved  | reserved               | reserved  | reserved           |                         |                          |                           |                           |                     | qmc_gainC(10        | :0)                 |                         |                            |                             |                   |
| config15 | 0x0F    | 0x0400  | output_del                 | layAB (1:0)   | output_del             | ayCD (1:0)  | reserved           |                         |                          |                           |                           |                     | qmc_gainD(10        | :0)                 |                         |                            |                             |                   |
| config16 | 0x10    | 0x0000  | reserved                   | reserved  | dual_e                 | na (1:0)  |                    |                         |                          |                           |                           | qmc_pl              | naseAB(11:0)        |                     |                         |                            |                             |                   |
| config17 | 0x11    | 0x0000  | reserved                   | reserved  | reserved               | reserved  |                    |                         |                          |                           |                           | qmc_pl              | naseCD(11:0)        |                     |                         |                            |                             |                   |
| config18 | 0x12    | 0x0000  |                            |   |                        |   |                    |                         |                          | pha                       | ase_offsetAB(1            | 5:0)                |                     |                     |                         |                            |                             |                   |
| config19 | 0x13    | 0x0000  |                            |   |                        |   |                    |                         |                          | pha                       | ase_offsetCD(1            | 5:0)                |                     |                     |                         |                            |                             |                   |
| config20 | 0x14    | 0x0000  |                            |   |                        |   |                    |                         |                          | ph                        | ase_addAB(15              | :0)                 |                     |                     |                         |                            |                             |                   |
| config21 | 0x15    | 0x0000  |                            |   |                        |   |                    |                         |                          | ph                        | ase_addAB(31:             | 16)                 |                     |                     |                         |                            |                             |                   |
| config22 | 0x16    | 0x0000  |                            |   |                        |   |                    |                         |                          | ph                        | ase_addCD(15              | :0)                 |                     |                     |                         |                            |                             |                   |
| config23 | 0x17    | 0x0000  |                            |   |                        |   |                    |                         |                          | ph                        | ase_addCD(31:             | :16)                |                     |                     |                         |                            |                             |                   |
| config24 | 0x18    | NA      |                            | reserved  |                        | pll_reset ndivsync pll_ena reserved pll_cp(1:0) pll_p(2:0) pll_p(2:0) pll_lfvolt(2                      |                    |                         |                          |                           | pll_lfvolt(2:0            | )                   |                     |                     |                         |                            |                             |                   |
| config25 | 0x19    | 0x0440  |                            |   |                        | pll_m(7:0)  |                    |                         |                          |                           |                           | _llq                | n(3:0)              |                     | pll_vcoit               | tune(2:0)                  | rese                        | erved             |
| config26 | 0x1A    | 0x0020  |                            |   | pll_vc                 | l_vco(5:0) reserved reserved bias_ tsense_ sleep sleep pll_sleep clkrecv_ sleep sleep sleep sleep sleep |                    |                         |                          |                           | sleepC                    | sleepD              |                     |                     |                         |                            |                             |                   |
| config27 | 0x1B    | 0x0000  | extref_<br>ena             | reserved  | reserved               | reserved  | fuse_<br>sleep     | reserved                | reserved                 | reserved                  | reserved                  | reserved            |                     |                     | rese                    | erved                      |                             |                   |

(1) Unless otherwise noted, all reserved registers should be programmed to default values.

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### **Register Map (continued)**

### Table 11. Register Map<sup>(1)</sup> (continued)

| Name     | Address | Default | (MSB)<br>Bit 15   | Bit 14                   | Bit 13        | Bit 12   | Bit 11   | Bit 10     | Bit 9         | Bit 8  | Bit 7           | Bit 6      | Bit 5        | Bit 4     | Bit 3      | Bit 2        | Bit 1               | (LSB)<br>Bit 0 |
|----------|---------|---------|---|--------------------------|---------------|----------|----------|------------|---------------|--------|-----------------|------------|--------------|-----------|------------|--------------|---------------------|----------------|
| config28 | 0x1C    | 0x0000  |   |                          |               | rese     | rved     |            |               |        | reserved        |            |              |           |            |              |                     |                |
| config29 | 0x1D    | 0x0000  |   | reserved                 |               |          |          |            |               |        |                 |            |              | reserv    | ed         |              |                     |                |
| config30 | 0x1E    | 0x1111  |   | syncsel_qm               | offsetAB(3:0) |          |          | syncsel_qm | offsetCD(3:0) | 1      |                 | syncsel_qn | ncorrAB(3:0) |           |            | syncsel_     | qmcorCD(3:0)        |                |
| config31 | 0x1F    | 0x1140  |   | syncsel_m                | ixerAB(3:0)   |          |          | syncsel_m  | ixerCD(3:0)   |        |                 | syncsel    | _nco(3:0)    |           | syncsel_da | ataformatter | sif_sync            | reserved       |
| config32 | 0x20    | 0x2400  |   | syncsel_                 | fifoin(3:0)   |          |          | syncsel_f  | ifoout(3:0)   |        | reserved        |            |              |           |            |              | clkdiv_<br>sync_sel |                |
| config33 | 0x21    | 0x0000  |   | reserved                 |               |          |          |            |               |        |                 |            |              |           |            |              |                     |                |
| config34 | 0x22    | 0x1B1B  | pathA_in_sel(1:0)         pathB_in_sel(1:0)         pathC_in_sel(1:0)         pathD_in_sel(1:0)         DACA_out_sel(1:0)         DACB_out_sel(1:0)         DACC_out_sel(1:0) |                          |               |          |          |            | ut_sel(1:0)   | DACD_o | ut_sel(1:0)     |            |              |           |            |              |                     |                |
| config35 | 0x23    | 0xFFFF  |   | sleep_cntl(15:0)         |               |          |          |            |               |        |                 |            |              |           |            |              |                     |                |
| config36 | 0x24    | 0x0000  |   | datadly(2:0) clkdly(2:0) |               |          |          |            |               |        | reserved        |            |              |           |            |              |                     |                |
| config37 | 0x25    | 0x7A7A  |   |                          |               |          |          |            |               |        | iotest_pattern0 |            |              |           |            |              |                     |                |
| config38 | 0x26    | 0xB6B6  |   |                          |               |          |          |            |               |        | iotest_pattern1 |            |              |           |            |              |                     |                |
| config39 | 0x27    | 0xEAEA  |   |                          |               |          |          |            |               |        | iotest_pattern2 |            |              |           |            |              |                     |                |
| config40 | 0x28    | 0x4545  |   |                          |               |          |          |            |               |        | iotest_pattern3 |            |              |           |            |              |                     |                |
| config41 | 0x29    | 0x1A1A  |   |                          |               |          |          |            |               |        | iotest_pattern4 |            |              |           |            |              |                     |                |
| config42 | 0x2A    | 0x1616  |   |                          |               |          |          |            |               |        | iotest_pattern5 |            |              |           |            |              |                     |                |
| config43 | 0x2B    | 0xAAAA  |   |                          |               |          |          |            |               |        | iotest_pattern6 |            |              |           |            |              |                     |                |
| config44 | 0x2C    | 0xC6C6  |   |                          |               |          |          |            |               |        | iotest_pattern7 |            |              |           |            |              |                     |                |
| config45 | 0x2D    | 0x0004  | reserved  | ostrtodig_<br>sel        | ramp_ena      |          |          |            |               |        | 1               | reserved   |              |           |            |              |                     | sifdac_ena     |
| config46 | 0x2E    | 0x0000  | grp_delayA(7:0)   |                          |               |          |          |            |               |        | grp_delayB(7:0) |            |              |           |            |              |                     |                |
| config47 | 0x2F    | 0x0000  |   |                          |               | grp_dela | ayC(7:0) |            |               |        |                 |            |              | grp_delay | D(7:0)     |              |                     |                |
| config48 | 0x30    | 0x0000  |   | sifdac(15:0)             |               |          |          |            |               |        |                 |            |              |           |            |              |                     |                |
| version  | 0x7F    | 0x540C  |   |                          | rese          | rved     |          |            | reserved      | res    | served          | rese       | erved        | devicei   | d(1:0)     |              | versionid(2:0       | i)             |

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## 7.6.1 Register Descriptions

Table 12. Register Name: config0 - Address: 0x00, Default: 0x049C

| Register<br>Name | Address | Bit  | Name  | Funct   | on                              | Default<br>Value |  |  |  |
|------------------|---------|------|---|---|---------------------------------|------------------|--|--|--|
| config0          | 0x00    | 15   | qmc_offsetAB_ena  | When set, the digital Quadrature Mo correction for the AB data path is en   |                                 | 0                |  |  |  |
|                  |         | 14   | qmc_offsetCD_ena  | When set, the digital Quadrature Mo correction for the CD data path is en   |                                 | 0                |  |  |  |
|                  |         | 13   | qmc_corrAB_ena  | When set, the QMC phase and gain data path is enabled.  | correction circuitry for the AB | 0                |  |  |  |
|                  |         | 12   | qmc_corrCD_ena  | When set, the QMC phase and gain data path is enabled.  | correction circuitry for the CD | 0                |  |  |  |
|                  |         | 11:8 | interp(3:0)   | These bits define the interpolation fa  | ctor                            | 0100             |  |  |  |
|                  |         |      |   | interp  | Interpolation Factor            |                  |  |  |  |
|                  |         |      |   | 0000  | 1x                              |                  |  |  |  |
|                  |         |      |   | 0001  | 2x                              |                  |  |  |  |
|                  |         |      |   | 0010  | 4x                              |                  |  |  |  |
|                  |         |      |   | 0100  | 8x                              |                  |  |  |  |
|                  |         |      |   | 1000  | 16x                             |                  |  |  |  |
|                  |         | 7    | fifo_ena  | When set, the FIFO is enabled. Whe DACCCLKP/N and DATACLKP/N recommended).  | 1                               |                  |  |  |  |
|                  |         | 6    | Reserved  | Reserved for factory use.   |                                 | 0                |  |  |  |
|                  |         | 5    | Reserved  | Reserved for factory use.   |                                 | 0                |  |  |  |
|                  |         | 4    | alarm_out_ena   | When set, the ALARM pin becomes ALARM pin is 3-stated.  | an output. When cleared, the    | 1                |  |  |  |
|                  |         | 3    | alarm_out_pol   | This bit changes the polarity of the A 0: Negative logic 1: Positive logic  | LARM signal.                    | 1                |  |  |  |
|                  |         | 2    | clkdiv_sync_ena   | When set, enables the syncing of the source selected by register <i>config32</i> clocks will be phase aligned after sy <i>Sequence</i> section for more detail. | . The internal divided-down     | 1                |  |  |  |
|                  |         |      | 1 invsincAB_ena When set, the inverse sinc filter for the AB data is enabled. |   |                                 |                  |  |  |  |
|                  |         | 0    | invsincCD_ena   | When set, the inverse sinc filter for t   | he CD data is enabled.          | 0                |  |  |  |



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## Table 13. Register Name: config1 - Address: 0x01, Default: 0x050E

| Register<br>Name | Address | Bit | Name                | Function   | Default<br>Value |
|------------------|---------|-----|---------------------|--|------------------|
| config1          | 0x01    | 15  | iotest_ena          | When set, enables the data pattern checker test. The outputs are deactivated regardless of the state of TXENABLE and sif_txenable.   | 0                |
|                  |         | 14  | Reserved            | Reserved for factory use.  | 0                |
|                  |         | 13  | Reserved            | Reserved for factory use.  | 0                |
|                  |         | 12  | 64cnt_ena           | When set, enables resetting of the alarms after 64 good samples with the goal of removing unnecessary errors. For instance, when checking setup/hold through the pattern checker test, there may initially be errors. Setting this bit removes the need for a SIF write to clear the alarm register. | 0                |
|                  |         | 11  | oddeven_parity      | Selects between odd and even parity check 0: Even parity 1: Odd parity   | 0                |
|                  |         | 10  | word_parity_ena     | When set, enables parity checking of each input word using the PARITYP/N parity input. It should match the <b>oddeven_parity</b> register setting.   | 1                |
|                  |         | 9   | frame_parity_ena    | When set, enables parity checking using the FRAME signal to source the parity bit.   | 0                |
|                  |         | 8   | quad_ena            | When set, the device is in quad channel mode. To enable the dual channel mode, set Config1, bit <8> to 0b and Config16, bit<13:12> to 11b. This dual channel mode is functionally equivalent to the dual channel DAC3484 (channels B and C active). See the DAC3484 SLAS748 datasheet for details.   | 1                |
|                  |         | 7   | dacA_complement     | When set, the DACA output is complemented. This allows to effectively change the + and – designations of the LVDS data lines.  | 0                |
|                  |         | 6   | dacB_complement     | When set, the DACB output is complemented. This allows to effectively change the + and – designations of the LVDS data lines.  | 0                |
|                  |         | 5   | dacC_complement     | When set, the DACC output is complemented. This allows to effectively change the + and – designations of the LVDS data lines.  | 0                |
|                  |         | 4   | dacD_complement     | When set, the DACD output is complemented. This allows to effectively change the + and – designations of the LVDS data lines.  | 0                |
|                  |         | 3   | alarm_2away_ena     | When set, the alarm from the FIFO indicating the write and read pointers being 2 away is enabled.  | 1                |
|                  |         | 2   | alarm_1away_ena     | When set, the alarm from the FIFO indicating the write and read pointers being 1 away is enabled.  | 1                |
|                  |         | 1   | alarm_collision_ena | When set, the alarm from the FIFO indicating a collision between the write and read pointers is enabled.   | 1                |
|                  |         | 0   | Reserved            | Reserved for factory use.  | 0                |



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## Table 14. Register Name: config2 - Address: 0x02, Default: 0x7000

| Register<br>Name | Address | Bit | Name              | Function   | Default<br>Value |
|------------------|---------|-----|-------------------|--|------------------|
| config2          | 0x02    | 15  | 16bit_in          | When set, the input interface is set to word-wide mode. When cleared, the input interface is set to byte-wide mode.  | 0                |
|                  |         | 14  | dacclkgone_ena    | When set, the DACCLK-gone signal from the clock monitor circuit can be used to shut off the DAC outputs. The corresponding alarms, alarm_dacclk_gone and alarm_output_gone, must not be masked (i.e. Config7, bit <10> and bit <8> must set to 0b).    | 1                |
|                  |         | 13  | dataclkgone_ena   | When set, the DATACLK-gone signal from the clock monitor circuit can be used to shut off the DAC outputs. The corresponding alarms,<br>alarm_dataclk_gone and alarm_output_gone, must not be masked (i.e.Config7, bit <9> and bit <8> must set to 0b). | 1                |
|                  |         | 12  | collisiongone_ena | When set, the FIFO collision alarms can be used to shut off the DAC outputs. The corresponding alarms, <i>alarm_fifo_collision</i> and <i>alarm_output_gone</i> , must not be masked (i.e.Config7, bit <13> and bit <8> must set to 0b).               | 1                |
|                  |         | 11  | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 10  | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 9   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 8   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 7   | sif4_ena          | When set, the serial interface (SIF) is a 4 bit interface, otherwise it is a 3-bit interface.  | 0                |
|                  |         | 6   | mixer_ena         | When set, the mixer block is enabled.  | 0                |
|                  |         | 5   | mixer_gain        | When set, a 6dB gain is added to the mixer output.   | 0                |
|                  |         | 4   | nco_ena           | When set, the NCO is enabled. This is not required for coarse mixing.  | 0                |
|                  |         | 3   | revbus            | When set, the input bits for the data bus are reversed. MSB becomes LSB.   | 0                |
|                  |         | 2   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 1   | twos              | When set, the input data format is expected to be 2s complement. When cleared, the input is expected to be offset-binary.  | 0                |
|                  |         | 0   | Reserved          | Reserved for factory use.  | 0                |

### Table 15. Register Name: config3 - Address: 0x03, Default: 0xF000

| Register<br>Name | Address | Bit   | Name            | Function   | Default<br>Value |
|------------------|---------|-------|-----------------|--|------------------|
| config3          | 0x03    | 15:12 | coarse_dac(3:0) | Scales the output current in 16 equal steps. $I_{FS} = \frac{V_{EXTIO}}{R_{BIAS}} \times 2 \times \left(coarse\_dac + 1\right)$  | 1111             |
|                  |         | 11:8  | Reserved        | Reserved for factory use.  | 0000             |
|                  |         | 7:1   | Reserved        | Reserved for factory use.  | 0000000          |
|                  |         | 0     | sif_txenable    | When set, the internal value of TXENABLE is set to 1b.  To enable analog output data transmission, set <code>sif_txenable</code> to 1b <code>or</code> pull CMOS TXENABLE pin (A32 for DAC3484IRKD and N9 for DAC3484IZAY) to high. To disable analog output, set <code>sif_txenable</code> to 0b <code>and</code> pull CMOS TXENABLE pin (A32 for DAC3484IRKD and N9 for DAC3484IZAY) to low. | 0                |

### Table 16. Register Name: config4 - Address: 0x04, Default: No RESET Value (Write to Clear)

| Register<br>Name | Address | Bit  | Name                 | Function   | Default<br>Value  |
|------------------|---------|------|----------------------|--|-------------------|
| config4          | 0x04    | 15:0 | iotest_results(15:0) | This register is used with pattern checker test enabled ( <i>iotest_ena</i> in <i>config1</i> , <i>bit&lt;15</i> > set to 1b). It does not have a default RESET value.  The values of these bits tell which bit in the word failed during the pattern checker test. iotest_results(15:8) correspond to the data bits on D[15:8] and iotest_results(7:0) correspond to the data bits on D[7:0]. | No RESET<br>Value |

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# Table 17. Register Name: config5 – Address: 0x05, Default: Setup and Power-Up Conditions Dependent (Write to Clear)

| Register<br>Name | Address | Bit   | Name                  | Function  | Default<br>Value |
|------------------|---------|-------|-----------------------|---|------------------|
| config5          | 0x05    | 15    | alarm_from_zerochk    | This alarm indicates the 8-bit FIFO write pointer address has an all zeros patterns. Due to pointer address being a shift register, this is not a valid address and will cause the write pointer to be stuck until the next sync. This error is typically caused by timing error or improper power start-up sequence. If this alarm is asserted, resynchronization of FIFO is necessary. See Power-Up Sequence for more detail. | NA               |
|                  |         | 14    | Reserved              | Reserved for factory use.   | NA               |
|                  |         | 13:11 | alarms_from_fifo(2:0) | Alarm indicating FIFO pointer collisions and nearness: 000: All fine 001: Pointers are 2 away 01x: Pointers are 1 away 1xx: FIFO pointer collision If the FIFO pointer collision alarm is set when collisiongone_ena is enabled, the FIFO must be re-synchronized and the bits must be cleared to resume normal operation.  | NA               |
|                  |         | 10    | alarm_dacclk_gone     | Alarm indicating the DACCLK has been stopped. If the bit is set when dacclkgone_ena is enabled, the DACCLK must resume and the bit must be cleared to resume normal operation.  | NA               |
|                  |         | 9     | alarm_dataclk_gone    | Alarm indicating the DATACLK has been stopped. If the bit is set when dataclkgone_ena is enabled, the DATACLK must resume and the bit must be cleared to resume normal operation.   | NA               |
|                  |         | 8     | alarm_output_gone     | Alarm indicating either alarm_dacclk_gone, alarm_dataclk_gone, or alarm_fifo_collision are asserted. It controls the output. When high it will output 0x8000 for each output connected to the DAC. If the bit is set when dacclkgone_ena, dataclkgone_ena, or collisiongone_ena are enabled, then the corresponding errors must be fixed and the bits must be cleared to resume normal operation.                               | NA               |
|                  |         | 7     | alarm_from_iotest     | Alarm indicating the input data pattern does not match the pattern in the iotest_pattern registers. When data pattern checker mode is enabled, this alarm in register config5, bit7 is the only valid alarm. Other alarms in register config5 are not valid and can be disregarded.   | NA               |
|                  |         | 6     | Reserved              | Reserved for factory use.   | NA               |
|                  |         | 5     | alarm_from_pll        | Alarm indicating the PLL has lost lock. For version ID 100b or earlier, alarm_from_PLL may not indicate the correct status of the PLL. Refer to pll_lfvolt(2:0) in register config24 for proper PLL lock indication.  | NA               |
|                  |         | 4     | alarm_rparity         | Alarm indicating a parity error on data captured on the rising edge of DATACLKP/N.  | NA               |
|                  |         | 3     | alarm_fparity         | Alarm indicating a parity error on data captured on the falling edge of DATACLKP/N.   | NA               |
|                  |         | 2     | alarm_frame_parity    | Alarm indicating a parity error when using the FRAME as parity bit.   | NA               |
|                  |         | 1     | Reserved              | Reserved for factory use.   | NA               |
|                  |         | 0     | Reserved              | Reserved for factory use.   | NA               |

### Table 18. Register Name: config6 - Address: 0x06, Default: No RESET Value (Read Only)

| Register | A -  -  | Bit  | Name          | F  | Default              |
|----------|---------|------|---------------|--|----------------------|
| Name     | Address | BIT  | Name          | Function   | Value                |
| config6  | 0x06    | 15:8 | tempdata(7:0) | This is the output from the chip temperature sensor. The value of this register in two's complement format represents the temperature in degrees Celsius. This register must be read with a minimum SCLK period of 1 µs. | No<br>RESET<br>Value |
|          |         | 7:2  | Reserved      | Reserved for factory use.  | 000000               |
|          |         | 1    | Reserved      | Reserved for factory use.  | 0                    |
|          |         | 0    | Reserved      | Reserved for factory use.  | 0                    |



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## Table 19. Register Name: config7 - Address: 0x07, Default: 0xFFFF

| Register<br>Name | Address | Bit  | Name              |   | Function                            | Default<br>Value |
|------------------|---------|------|-------------------|---|-------------------------------------|------------------|
| config7          | 0x07    | 15:0 | alarms_mask(15:0) | These bits control the masking of the a | larms. (0 = not masked, 1 = masked) | 0xFFFF           |
|                  |         |      |                   | alarm_mask                              | Alarm that is Masked                |                  |
|                  |         |      |                   | 15                                      | alarm_from_zerochk                  |                  |
|                  |         |      |                   | 14                                      | not used                            |                  |
|                  |         |      |                   | 13                                      | alarm_fifo_collision                |                  |
|                  |         |      |                   | 12                                      | alarm_fifo_1away                    |                  |
|                  |         |      |                   | 11                                      | alarm_fifo_2away                    |                  |
|                  |         |      |                   | 10                                      | alarm_dacclk_gone                   |                  |
|                  |         |      |                   | 9                                       | alarm_dataclk_gone                  |                  |
|                  |         |      |                   | 8                                       | alarm_output_gone                   |                  |
|                  |         |      |                   | 7                                       | alarm_from_iotest                   |                  |
|                  |         |      |                   | 6                                       | not used                            |                  |
|                  |         |      |                   | 5                                       | alarm_from_pll                      |                  |
|                  |         |      |                   | 4                                       | alarm_rparity                       |                  |
|                  |         |      |                   | 3                                       | alarm_fparity                       |                  |
|                  |         |      |                   | 2                                       | alarm_frame_parity                  |                  |
|                  |         |      |                   | 1                                       | not used                            |                  |
|                  |         |      |                   | 0                                       | not used                            |                  |

### Table 20. Register Name: config8 - Address: 0x08, Default: 0x0000 (Causes Auto-Sync)

| Register<br>Name | Address | Bit  | Name              | Function  | Default<br>Value |
|------------------|---------|------|-------------------|---|------------------|
| config8          | 80x0    | 15   | Reserved          | Reserved for factory use.   | 0                |
|                  |         | 14   | Reserved          | Reserved for factory use.   | 0                |
|                  |         | 13   | Reserved          | Reserved for factory use.   | 0                |
|                  |         | 12:0 | qmc_offsetA(12:0) | DACA offset correction. The offset is measured in DAC LSBs. If enabled in config30 writing to this register causes an auto-sync to be generated. This loads the values of the QMC offset registers (config8-config9) into the offset block at the same time. When updating the offset values for AB channel config8 should be written last. Programming config9 will not affect the offset setting. | All zeros        |

## Table 21. Register Name: config9 - Address: 0x09, Default: 0x8000

| Register<br>Name | Address | Bit   | Name              | Function  | Default<br>Value |
|------------------|---------|-------|-------------------|---|------------------|
| config9          | 0x09    | 15:13 | fifo_offset(2:0)  | When the sync to the FIFO occurs, this is the value loaded into the FIFO read pointer. With this value the initial difference between write and read pointers can be controlled. This may be helpful in syncing multiple chips or controlling the delay through the device. | 100              |
|                  |         | 12:0  | qmc_offsetB(12:0) | DACB offset correction. The offset is measured in DAC LSBs.   | All zeros        |

### Table 22. Register Name: config10 - Address: 0x0A, Default: 0x0000 (Causes Auto-Sync)

| Register<br>Name | Address | Bit  | Name              | Function   | Default<br>Value |
|------------------|---------|------|-------------------|--|------------------|
| config10         | 0x0A    | 15   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 14   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 13   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 12:0 | qmc_offsetC(12:0) | DACC offset correction. The offset is measured in DAC LSBs. If enabled in config30 writing to this register causes an auto-sync to be generated. This loads the values of the CD-channel QMC offset registers (config10-config11) into the offset block at the same time. When updating the offset values for the CD-channel config10 should be written last. Programming config11 will not affect the offset setting. | All zeros        |

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## Table 23. Register Name: config11 - Address: 0x0B, Default: 0x0000

| Register<br>Name | Address | Bit  | Name              | Function  | Default<br>Value |
|------------------|---------|------|-------------------|---|------------------|
| config11         | 0x0B    | 15   | Reserved          | Reserved for factory use.                                   | 0                |
|                  |         | 14   | Reserved          | Reserved for factory use.                                   | 0                |
|                  |         | 13   | Reserved          | Reserved for factory use.                                   | 0                |
|                  |         | 12:0 | qmc_offsetD(12:0) | DACD offset correction. The offset is measured in DAC LSBs. | All zeros        |

### Table 24. Register Name: config12 - Address: 0x0C, Default: 0x0400

| Register<br>Name | Address | Bit  | Name            | Function  | Default<br>Value |
|------------------|---------|------|-----------------|---|------------------|
| config12         | 0x0C    | 15   | Reserved        | Reserved for factory use.   | 0                |
|                  |         | 14   | Reserved        | Reserved for factory use.   | 0                |
|                  |         | 13   | Reserved        | Reserved for factory use.   | 0                |
|                  |         | 12   | Reserved        | Reserved for factory use.   | 0                |
|                  |         | 11   | Reserved        | Reserved for factory use.   | 0                |
|                  |         | 10:0 | qmc_gainA(10:0) | QMC gain for DACA. The full 11-bit qmc_gainA(10:0) word is formatted as UNSIGNED with a range of 0 to 1.9990. The implied decimal point for the multiplication is between bit 9 and bit 10. | 10000000         |

### Table 25. Register Name: config13 – Address: 0x0D, Default: 0x0400

| Register<br>Name | Address | Bit  | Name            | Function   | Default<br>Value |
|------------------|---------|------|-----------------|--|------------------|
| config13         | 0x0D    | 15   | cmix_mode(3:0)  | Sets the mixing function of the coarse mixer.  Bit 15: Fs/8 mixer  Bit 14: Fs/4 mixer  Bit 13: Fs/2 mixer  Bit 12: -Fs/4 mixer  The various mixers can be combined together to obtain a ±n×Fs/8 total mixing factor. | 0000             |
|                  |         | 11   | Reserved        | Reserved for factory use.  | 0                |
|                  |         | 10:0 | qmc_gainB(10:0) | QMC gain for DACB. The full 11-bit qmc_gainB(10:0) word is formatted as UNSIGNED with a range of 0 to 1.9990. The implied decimal point for the multiplication is between bit 9 and bit 10.                          | 10000000<br>000  |

### Table 26. Register Name: config14 – Address: 0x0E, Default: 0x0400

| Register<br>Name | Address | Bit  | Name            | Function   | Default<br>Value |
|------------------|---------|------|-----------------|--|------------------|
| config14         | 0x0E    | 15   | Reserved        | Reserved for factory use.  | 0                |
|                  |         | 14   | Reserved        | Reserved for factory use.  | 0                |
|                  |         | 13   | Reserved        | Reserved for factory use.  | 0                |
|                  |         | 12   | Reserved        | Reserved for factory use.  | 0                |
|                  |         | 11   | Reserved        | Reserved for factory use.  | 0                |
|                  |         | 10:0 | qmc_gainC(10:0) | QMC gain for DACC. The 11-bit qmc_gainC(10:0) word is formatted as UNSIGNED with a range of 0 to 1.9990. The implied decimal point for the multiplication is between bit 9 and bit 10. | 10000000         |

### Table 27. Register Name: config15 – Address: 0x0F, Default: 0x0400

| Register<br>Name | Address | Bit   | Name                    | Function  | Default<br>Value |
|------------------|---------|-------|-------------------------|---|------------------|
| config15         | 0x0F    | 15:14 | output_<br>delayAB(1:0) | Delays the AB data path outputs from 0 to 3 DAC clock cycles.   | 00               |
|                  |         | 13:12 | output_<br>delayCD(1:0) | Delays the CD data path outputs from 0 to 3 DAC clock cycles.   | 00               |
|                  |         | 11    | Reserved                | Reserved for factory use.   | 0                |
|                  |         | 10:0  | qmc_gainD(10:0)         | QMC gain for DACD. The full 11-bit qmc_gainD(10:0) word is formatted as UNSIGNED with a range of 0 to 1.9990. The implied decimal point for the multiplication is between bit 9 and bit 10. | 10000000         |



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### Table 28. Register Name: config16 - Address: 0x10, Default: 0x0000 (Causes Auto-Sync)

| Register<br>Name | Address | Bit   | Name              | Function   | Default<br>Value |
|------------------|---------|-------|-------------------|--|------------------|
| config16         | 0x10    | 15    | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 14    | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 13:12 | dual_ena (1:0)    | To enable the dual channel mode, set Config1, bit <8> to 0b and Config16, bit<13:12> to 11b. This dual channel mode is functionally equivalent to the dual channel DAC3484 (channels B and C active). See the DAC3482 SLAS748 data sheet for details.  | 0                |
|                  |         | 11:0  | qmc_phaseAB(11:0) | QMC correction phase for the AB data path. The 12-bit qmc_phaseAB(11:0) word is formatted as 2s complement and scaled to occupy a range of –0.5 to 0.49975 and a default phase correction of 0.00. To accomplish QMC phase correction, this value is multiplied by the current B sample, then summed into the A sample. If enabled in config30 writing to this register causes an auto-sync to be generated. If enabled in config16 into the QMC correction registers (config12, config13, and config16) into the QMC block at the same time. When updating the QMC values for the AB channel config16 should be written last. Programming config12 and config13 will not affect the QMC settings. | All zeros        |

### Table 29. Register Name: config17 - Address: 0x11, Default: 0x0000 (Causes Auto-Sync)

| Register<br>Name | Address | Bit  | Name              | Function   | Default<br>Value |
|------------------|---------|------|-------------------|--|------------------|
| config17         | 0x11    | 15   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 14   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 13   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 12   | Reserved          | Reserved for factory use.  | 0                |
|                  |         | 11:0 | qmc_phaseCD(11:0) | QMC correction phase for the CD data path. The 12-bit qmc_phaseCD(11:0) word is formatted as 2s complement and scaled to occupy a range of –0.5 to 0.49975 and a default phase correction of 0.00. To accomplish QMC phase correction, this value is multiplied by the current D sample, then summed into the C sample. If enabled in <i>config30</i> writing to this register causes an auto-sync to be generated. This loads the values of the CD-channel QMC block registers (config14, config15, and config17) into the QMC block at the same time. When updating the QMC values for the CD-channel config17 should be written last. Programming config14 and config15 will not affect the QMC settings. | All zeros        |

### Table 30. Register Name: config18 - Address: 0x12, Default: 0x0000 (Causes Auto-Sync)

| Register<br>Name | Address | Bit  | Name                 | Function   | Default<br>Value |
|------------------|---------|------|----------------------|--|------------------|
| config18         | 0x12    | 15:0 | phase_offsetAB(15:0) | Phase offset added to the AB data path NCO accumulator before the generation of the SIN and COS values. The phase offset is added to the upper 16 bits of the NCO accumulator results and these 16 bits are used in the sin/cos lookup tables. If enabled in config31 writing to this register causes an auto-sync to be generated. This loads the values of the fine mixer block registers (config18, config20, and config21) at the same time. When updating the mixer values the config18 should be written last. Programming config20 and config21 will not affect the mixer settings. | 0x0000           |

### Table 31. Register Name: config19 - Address: 0x13, Default: 0x0000 (Causes Auto-Sync)

| Register<br>Name | Address | Bit  | Name                  | Function  | Default<br>Value |
|------------------|---------|------|-----------------------|---|------------------|
| config19         | 0x13    | 15:0 | phase_ offsetCD(15:0) | Phase offset added to the CD data path NCO accumulator before the generation of the SIN and COS values. The phase offset is added to the upper 16 bits of the NCO accumulator results and these 16 bits are used in the sin/cos lookup tables. If enabled in config31 writing to this register causes an auto-sync to be generated. This loads the values of the CD-channel fine mixer block registers (config19, config22 and config23) at the same time. When updating the mixer values for the CD-channel config19 should be written last. Programming config22 and config23 will not affect the mixer settings. | 0x0000           |

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## Table 32. Register Name: config20 - Address: 0x14, Default: 0x0000

| Register<br>Name | Address | Bit  | Name               | Function   | Default<br>Value |
|------------------|---------|------|--------------------|--|------------------|
| config20         | 0x14    | 15:0 | phase_ addAB(15:0) | The phase_addAB(15:0) value is used to determine the NCO frequency. The 2s complement formatted value can be positive or negative. Each LSB represents Fs/(2^32) frequency step. | 0x0000           |

### Table 33. Register Name: config21 - Address: 0x15, Default: 0x0000

| Register<br>Name | Address | Bit  | Name                | Function            | Default<br>Value |
|------------------|---------|------|---------------------|---------------------|------------------|
| config21         | 0x15    | 15:0 | phase_ addAB(31:16) | See config20 above. | 0x0000           |

## Table 34. Register Name: config22 - Address: 0x16, Default: 0x0000

| Register<br>Name | Address | Bit  | Name               | Function   | Default<br>Value |
|------------------|---------|------|--------------------|--|------------------|
| config22         | 0x16    | 15:0 | phase_ addCD(15:0) | The phase_addCD(15:0) value is used to determine the NCO frequency. The 2s complement formatted value can be positive or negative. Each LSB represents Fs/(2^32) frequency step. | 0x0000           |

### Table 35. Register Name: config23 - Address: 0x17, Default: 0x0000

| Register<br>Name | Address | Bit  | Name                | Function            | Default<br>Value |
|------------------|---------|------|---------------------|---------------------|------------------|
| config23         | 0x17    | 15:0 | phase_ addCD(31:16) | See config22 above. | 0x0000           |

### Table 36. Register Name: config24 - Address: 0x18, Default: NA

| Register<br>Name | Address | Bit   | Name             | Function   | Default<br>Value |
|------------------|---------|-------|------------------|--|------------------|
| config24         | 0x18    | 15:13 | Reserved         | Reserved for factory use.  | 001              |
|                  |         | 12    | pll_reset        | When set, the PLL loop filter (LPF) is pulled down to 0 V. Toggle from 1b to 0b to restart the PLL if an over-speed lock-up occurs. Over-speed can happen when the process is fast, the supplies are higher than nominal, etc. resulting in the feedback dividers missing a clock. | 0                |
|                  |         | 11    | pll_ndivsync_ena | When set, the LVDS SYNC input is used to sync the PLL N dividers.  | 1                |
|                  |         | 10    | pll_ena          | When set, the PLL is enabled. When cleared, the PLL is bypassed.   | 0                |
|                  |         | 9:8   | Reserved         | Reserved for factory use.  | 00               |
|                  |         | 7:6   | pll_cp(1:0)      | PLL pump charge select 00: No charge pump 01: Single pump charge 10: Not used 11: Dual pump charge   | 00               |
|                  |         | 5:3   | pll_p(2:0)       | PLL pre-scaler dividing module control. 010: 2 011: 3 100: 4 101: 5 110: 6 111: 7 000: 8   | 001              |
|                  |         | 2:0   | pll_lfvolt(2:0)  | PLL loop filter voltage. This three bit read-only indicator has step size of 0.4125 V. The entire range covers from 0 V to 3.3 V. The optimal lock range of the PLL will be from 010 to 101 (0.825 V to 2.063 V). Adjust pll_vco(5:0) for optimal lock range.                      | NA               |



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## Table 37. Register Name: config25 - Address: 0x19, Default: 0x0440

| Register<br>Name | Address | Bit  | Name              | Function  | Default<br>Value |
|------------------|---------|------|-------------------|---|------------------|
| config25         | 0x19    | 15:8 | pll_m(7:0)        | M portion of the M/N divider of the PLL. If $pll_m<7>=0$ , the M divider value has the range of $pll_m<6:0>$ , spanning from 4 to 127. (0, 1, 2, and 3 are not valid.) If $pll_m<7>=1$ , the M divider value has the range of $2 \times pll_m<6:0>$ , spanning from 8 to 254. (0, 2, 4, and 6 are not valid. M divider has even values only.) | 0x04             |
|                  |         | 7:4  | pll_n(3:0)        | N portion of the M/N divider of the PLL.  0000: 1  0001: 2  0010: 3  0011: 4  0100: 5  0101: 6  0110: 7  0111: 8  1000: 9  1001: 10  1010: 11  1011: 12  1100: 13  1110: 14  1110: 15  1111: 16   | 0100             |
|                  |         | 3:2  | pll_vcoitune(1:0) | PLL VCO bias tuning bits. Set to 01b for normal PLL operation.  | 00               |
|                  |         | 1:0  | Reserved          | Reserved for factory use.   | 00               |

## Table 38. Register Name: config26 - Address: 0x1A, Default: 0x0020

| Register<br>Name | Address | Bit   | Name          | Function   | Default<br>Value |
|------------------|---------|-------|---------------|--|------------------|
| config26         | 0x1A    | 15:10 | pll_vco(5:0)  | VCO frequency coarse tuning bits.  | 000000           |
|                  |         | 9     | Reserved      | Reserved for factory use.  | 0                |
|                  |         | 8     | Reserved      | Reserved for factory use.  | 0                |
|                  |         | 7     | bias_sleep    | When set, the bias amplifier is put into sleep mode.   | 0                |
|                  |         | 6     | tsense_sleep  | Turns off the temperature sensor when asserted.  | 0                |
|                  |         | 5     | pll_sleep     | When set, the PLL is put into sleep mode.  | 1                |
|                  |         | 4     | clkrecv_sleep | When asserted the clock input receiver gets put into sleep mode. This affects the OSTR receiver as well. | 0                |
|                  |         | 3     | sleepA        | When set, the DACA is put into sleep mode.   | 0                |
|                  |         | 2     | sleepB        | When set, the DACB is put into sleep mode.   | 0                |
|                  |         | 1     | sleepC        | When set, the DACC is put into sleep mode.   | 0                |
|                  |         | 0     | sleepD        | When set, the DACD is put into sleep mode.   | 0                |

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## Table 39. Register Name: config27 - Address: 0x1B, Default: 0x0000

| Register<br>Name | Address | Bit | Name       |   | Function  |   | Defaul<br>Value |
|------------------|---------|-----|------------|---|---|---|-----------------|
| config27         | 0x1B    | 15  | extref_ena | Allows the device to use an e<br>0: Internal reference<br>1: External reference   | external reference or the in  | nternal reference.  | 0               |
|                  |         | 14  | Reserved   | Reserved for factory use.   |   |   | 0               |
|                  |         | 13  | Reserved   | Reserved for factory use.   |   |   | 0               |
|                  |         | 12  | Reserved   | Reserved for factory use.   |   |   | 0               |
|                  |         | 11  | fuse_sleep | Put the fuses to sleep when s<br>If SLEEP pin is set to logic HI<br>initialization, the fuse_sleep b<br>register 0x23 during device in<br>Note: Default value is '0'. M                               | IGH before and during de<br>bit in register 0x1B, bit 11<br>bitialization register setup.                               | must be written after   | 0               |
|                  |         | 10  | Reserved   | Reserved for factory use.   |   |   | 0               |
|                  |         | 9   | Reserved   | Reserved for factory use.   |   |   | 0               |
|                  |         | 8   | Reserved   | Reserved for factory use.   |   |   | 0               |
|                  |         | 7   | Reserved   | Reserved for factory use.   |   |   | 0               |
|                  |         | 6   | Reserved   | Reserved for factory use.   |   |   | 0               |
|                  |         |     |            | ATEST mode allows the user supply voltages are within the internal die voltages can be n (A32) must be floating withou In ATEST mode, the TXENAE output will be active at all time Config27, bit<5:0> | e range. When ATEST mo<br>neasured at the TXENABI<br>t any pull-up or pull-down<br>BLE and sif_txenable logio           | de is programmed, the LE pin. The TXENABLE pin resistors.                           |                 |
|                  |         |     |            | Connig27, bit<5.0>  | Description   |   |                 |
|                  |         |     |            |   |   | Voltage   |                 |
|                  |         |     |            | 001110  | DACA AVSS   |   |                 |
|                  |         |     |            | 001110<br>001111  | DACA AVSS<br>DACA DVDD  | Voltage   |                 |
|                  |         |     |            |   |   | Voltage<br>0 V  |                 |
|                  |         |     |            | 001111  | DACA DVDD   | 0 V<br>1.2 V  |                 |
|                  |         |     |            | 001111<br>010000  | DACA DVDD<br>DACA AVDD  | 0 V 1.2 V 3.3 V   |                 |
|                  |         |     |            | 001111<br>010000<br>010110  | DACA DVDD<br>DACA AVDD<br>DACB AVSS   | 0 V 1.2 V 3.3 V 0 V   |                 |
|                  |         |     |            | 001111<br>010000<br>010110<br>010111  | DACA DVDD DACA AVDD DACB AVSS DACB DVDD   | 0 V 1.2 V 3.3 V 0 V 1.2 V   |                 |
|                  |         |     |            | 001111<br>010000<br>010110<br>010111<br>011000  | DACA DVDD  DACA AVDD  DACB AVSS  DACB DVDD  DACB AVDD   | 0 V 1.2 V 3.3 V 0 V 1.2 V 3.3 V   |                 |
|                  |         |     |            | 001111<br>010000<br>010110<br>010111<br>011000<br>011110  | DACA DVDD  DACA AVDD  DACB AVSS  DACB DVDD  DACB AVDD  DACC AVSS  | 0 V 1.2 V 3.3 V 0 V 1.2 V 3.3 V 0 V 1.2 V 0 V 0 V                                   |                 |
|                  |         |     |            | 001111<br>010000<br>010110<br>010111<br>011000<br>011110<br>011111  | DACA DVDD  DACA AVDD  DACB AVSS  DACB DVDD  DACB AVDD  DACC AVSS  DACC DVDD   | Voltage  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V  0 V               |                 |
|                  |         |     |            | 001111<br>010000<br>010110<br>010111<br>011000<br>011110<br>011111<br>100000  | DACA DVDD DACA AVDD DACB AVSS DACB DVDD DACB AVDD DACC AVSS DACC DVDD DACC AVDD   | Voltage  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V  3.3 V             |                 |
|                  |         |     |            | 001111<br>010000<br>010110<br>010111<br>011000<br>011110<br>011111<br>100000<br>100110  | DACA DVDD  DACA AVDD  DACB AVSS  DACB DVDD  DACB AVDD  DACC AVSS  DACC DVDD  DACC AVDD  DACC AVDD  DACD AVSS            | Voltage  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V  0 V  1.2 V  0 V   |                 |
|                  |         |     |            | 001111<br>010000<br>010110<br>010111<br>011000<br>011110<br>011111<br>100000<br>100110  | DACA DVDD  DACA AVDD  DACB AVSS  DACB DVDD  DACB AVDD  DACC AVSS  DACC DVDD  DACC AVDD  DACC AVDD  DACD AVSS  DACD DVDD | Voltage  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V  0 V  1.2 V  3.3 V |                 |

## Table 40. Register Name: config28 - Address: 0x1C, Default: 0x0000

| Register<br>Name | Address | Bit  | Name     | Function                  | Default<br>Value |
|------------------|---------|------|----------|---------------------------|------------------|
| config28         | 0x1C    | 15:8 | Reserved | Reserved for factory use. | 0x00             |
|                  |         | 7:0  | Reserved | Reserved for factory use. | 0x00             |

## Table 41. Register Name: config29 - Address: 0x1D, Default: 0x0000

| Register<br>Name | Address | Bit  | Name     | Function                  | Default<br>Value |
|------------------|---------|------|----------|---------------------------|------------------|
| config29         | 0x1D    | 15:8 | Reserved | Reserved for factory use. | 0x00             |
|                  |         | 7:0  | Reserved | Reserved for factory use. | 0x00             |



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## Table 42. Register Name: config30 - Address: 0x1E, Default: 0x1111

| Register<br>Name | Address | Bit   | Name                     | Function  | Default<br>Value |
|------------------|---------|-------|--------------------------|---|------------------|
| config30         | 0x1E    | 15:12 | syncsel_qmoffsetAB(3:0)  | Selects the syncing source(s) of the AB data path double buffered QMC offset registers. A 1b in the bit enables the signal as a sync source. More than one sync source is permitted.  Bit 15: sif_sync (via config31) Bit 14: SYNC Bit 13: OSTR Bit 12: Auto-sync from register write     | 0001             |
|                  |         | 11:8  | syncsel_ qmoffsetCD(3:0) | Selects the syncing source(s) of the CD data path double buffered QMC offset registers. A 1b in the bit enables the signal as a sync source. More than one sync source is permitted.  Bit 11: sif_sync (via config31) Bit 10: SYNC Bit 9: OSTR Bit 8: Auto-sync from register write       | 0001             |
|                  |         | 7:4   | syncsel_ qmccorrAB(3:0)  | Selects the syncing source(s) of the AB data path double buffered QMC correction registers. A '1' in the bit enables the signal as a sync source. More than one sync source is permitted.  Bit 7: sif_sync (via config31)  Bit 6: SYNC  Bit 5: OSTR  Bit 4: Auto-sync from register write | 0001             |
|                  |         | 3:0   | syncsel_qmccorrCD(3:0)   | Selects the syncing source(s) of the CD data path double buffered QMC correction registers. A 1b in the bit enables the signal as a sync source. More than one sync source is permitted.  Bit 3: sif_sync (via config31) Bit 2: SYNC Bit 1: OSTR Bit 0: Auto-sync from register write     | 0001             |

## Table 43. Register Name: config31 - Address: 0x1F, Default: 0x1140

| Register<br>Name | Address | Bit   | Name                        | Function   | Default<br>Value |
|------------------|---------|-------|-----------------------------|--|------------------|
| config31         | 0x1F    | 15:12 | syncsel_mixerAB(3:0)        | Selects the syncing source(s) of the AB data path double buffered mixer registers. A 1b in the bit enables the signal as a sync source. More than one sync source is permitted.  Bit 15: sif_sync (via config31) Bit 14: SYNC Bit 13: OSTR Bit 12: Auto-sync from register write | 0001             |
|                  |         | 11:8  | syncsel_ mixerCD(3:0)       | Selects the syncing source(s) of the CD data path double buffered mixer registers. A 1b in the bit enables the signal as a sync source. More than one sync source is permitted.  Bit 11: sif_sync (via config31) Bit 10: SYNC Bit 9: OSTR Bit 8: Auto-sync from register write   | 0001             |
|                  |         | 7:4   | syncsel_nco(3:0)            | Selects the syncing source(s) of the two NCO accumulators. A 1b in the bit enables the signal as a sync source. More than one sync source is permitted.  Bit 7: sif_sync (via config31)  Bit 6: SYNC  Bit 5: OSTR  Bit 4: FRAME  | 0100             |
|                  |         | 3:2   | syncsel_dataformatter(1: 0) | Selects the syncing source of the data formatter. Unlike the other syncs only one sync source is allowed.  00: FRAME  01: SYNC  10: No sync  11: No sync   | 00               |
|                  |         | 1     | sif_sync                    | SIF created sync signal. Set to 1b to cause a sync and then clear to 0b to remove it.  | 0                |
|                  |         | 0     | Reserved                    | Reserved for factory use.  | 0                |

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## Table 44. Register Name: config32 - Address: 0x20, Default: 0x2400

| Register<br>Name | Address | Bit   | Name                 |                              | Function   | Default<br>Value |
|------------------|---------|-------|----------------------|------------------------------|--|------------------|
| config32         | 0x20    | 15:12 | syncsel_fifoin(3:0)  |                              | e(s) of the FIFO input side. A '1' in the bit enables the lore than one sync source is permitted. onlig31) | 0010             |
|                  |         | 11:8  | syncsel_fifoout(3:0) |                              | Sync Sources Mode<br>e Sync Source mode  | 0100             |
|                  |         | 7:1   | Reserved             | Reserved for factory use.    |  | 0000             |
|                  |         | 0     | clkdiv_sync_sel      | Selects the signal source to | or clock divider synchronization.  | 0                |
|                  |         |       |                      | clkdiv_sync_sel              | Sync Source  |                  |
|                  |         |       |                      | 0                            | OSTR   |                  |
|                  |         |       |                      | 1                            | FRAME or SYNC, based on syncsel_fifoin source selection (config32, bit<15:12>)                             |                  |

### Table 45. Register Name: config33 - Address: 0x21, Default: 0x0000

| Register<br>Name | Address | Bit  | Name     | Function                  | Default<br>Value |
|------------------|---------|------|----------|---------------------------|------------------|
| config33         | 0x21    | 15:0 | Reserved | Reserved for factory use. | 0x0000           |

### Table 46. Register Name: config34 - Address: 0x22, Default: 0x1B1B

| Register<br>Name | Address | Bit   | Name              | Function                                      | Default<br>Value |
|------------------|---------|-------|-------------------|---|------------------|
| config34         | 0x22    | 15:14 | pathA_in_sel(1:0) | Selects the word used for the A channel path. | 00               |
|                  |         | 13:12 | pathB_in_sel(1:0) | Selects the word used for the B channel path. | 01               |
|                  |         | 11:10 | pathC_in_sel(1:0) | Selects the word used for the C channel path. | 10               |
|                  |         | 9:8   | pathD_in_sel(1:0) | Selects the word used for the D channel path. | 11               |
|                  |         | 7:6   | DACA_out_sel(1:0) | Selects the word used for the DACA output.    | 00               |
|                  |         | 5:4   | DACB_out_sel(1:0) | Selects the word used for the DACB output.    | 01               |
|                  |         | 3:2   | DACC_out_sel(1:0) | Selects the word used for the DACC output.    | 10               |
|                  |         | 1:0   | DACD_out_sel(1:0) | Selects the word used for the DACD output.    | 11               |



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## Table 47. Register Name: config35 - Address: 0x23, Default: 0xFFFF

| Register<br>Name | Address | Bit  | Name             |                                     | Function   | Default<br>Value |
|------------------|---------|------|------------------|-------------------------------------|--|------------------|
| config35         | 0x23    | 15:0 | sleep_cntl(15:0) | pin B8 for the DAC3484IZAY) to dif  | SLEEP signal (pin B40 for the DAC3484IRKD and ferent blocks. When a bit in this register is set, the rresponding block. The block will only be disabled I the correspond bit is set to 1b. | 0xFFFF           |
|                  |         |      |                  | These bits do not override SIF bits | in config26 that control the same sleep function.  |                  |
|                  |         |      |                  | sleep_cntl(bit)                     | Function   |                  |
|                  |         |      |                  | 15                                  | DACA sleep   |                  |
|                  |         |      |                  | 14                                  | DACB sleep   |                  |
|                  |         |      |                  | 13                                  | DACC sleep   |                  |
|                  |         |      |                  | 12                                  | DACD sleep   |                  |
|                  |         |      |                  | 11                                  | Clock receiver sleep   |                  |
|                  |         |      |                  | 10                                  | PLL sleep  |                  |
|                  |         |      |                  | 9                                   | LVDS data sleep  |                  |
|                  |         |      |                  | 8                                   | LVDS control sleep   |                  |
|                  |         |      |                  | 7                                   | Temp sensor sleep  |                  |
|                  |         |      |                  | 6                                   | reserved   |                  |
|                  |         |      |                  | 5                                   | Bias amplifier sleep   |                  |
|                  |         |      |                  | All others                          | not used   |                  |

### Table 48. Register Name: config36 - Address: 0x24, Default: 0x0000

| Register<br>Name | Address | Bit   | Name         | Function   | Default<br>Value |
|------------------|---------|-------|--------------|--|------------------|
| config36         | 0x24    | 15:13 | datadly(2:0) | Controls the delay of the data inputs through the LVDS receivers. Each LSB adds approximately 50 ps. Refer to Digital Input Timing Specifications Table for details.  0: Minimum | 000              |
|                  |         | 12:10 | clkdly(2:0)  | Controls the delay of the data clock through the LVDS receivers. Each LSB adds approximately 50 ps. Refer to Digital Input Timing Specifications Table for details.  0: Minimum  | 000              |
|                  |         | 9:0   | Reserved     | Reserved for factory use.  | 0x000            |

## Table 49. Register Name: config37 - Address: 0x25, Default: 0x7A7A

| Register<br>Name | Address | Bit  | Name            | Function  | Default<br>Value |
|------------------|---------|------|-----------------|---|------------------|
| config37         | 0x25    | 15:0 | iotest_pattern0 | Dataword0 in the IO test pattern. It is used with the seven other words to test the input data. At the start of the IO test pattern, this word should be aligned with rising edge of FRAME or SYNC signal to indicate sample 0. | 0x7A7A           |

## Table 50. Register Name: config38 - Address: 0x26, Default: 0xB6B6

| Registe<br>Name | Address | Bit  | Name            | Function  | Default<br>Value |
|-----------------|---------|------|-----------------|---|------------------|
| config38        | 0x26    | 15:0 | iotest_pattern1 | Dataword1 in the IO test pattern. It is used with the seven other words to test the input data. | 0xB6B6           |

## Table 51. Register Name: config39 - Address: 0x27, Default: 0xEAEA

| Register<br>Name | Address | Bit  | Name            | Function  | Default<br>Value |
|------------------|---------|------|-----------------|---|------------------|
| config39         | 0x27    | 15:0 | iotest_pattern2 | Dataword2 in the IO test pattern. It is used with the seven other words to test the input data. | 0xEAEA           |

### Table 52. Register Name: config40 - Address: 0x28, Default: 0x4545

| Register<br>Name | Address | Bit  | Name            | Function  | Default<br>Value |
|------------------|---------|------|-----------------|---|------------------|
| config40         | 0x28    | 15:0 | iotest_pattern3 | Dataword3 in the IO test pattern. It is used with the seven other words to test the input data. | 0x4545           |

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## Table 53. Register Name: config41 - Address: 0x29, Default: 0x1A1A

| Register<br>Name | Address | Bit  | Name            | Function  | Default<br>Value |
|------------------|---------|------|-----------------|---|------------------|
| config41         | 0x29    | 15:0 | iotest_pattern4 | Dataword4 in the IO test pattern. It is used with the seven other words to test the input data. | 0x1A1A           |

### Table 54. Register Name: config42 - Address: 0x2A, Default: 0x1616

| Register<br>Name | Address | Bit  | Name            | Function  | Default<br>Value |
|------------------|---------|------|-----------------|---|------------------|
| config42         | 0x2A    | 15:0 | iotest_pattern5 | Dataword5 in the IO test pattern. It is used with the seven other words to test the input data. | 0x1616           |

### Table 55. Register Name: config43 - Address: 0x2B, Default: 0xAAAA

| Register<br>Name | Address | Bit  | Name            | Function  | Default<br>Value |
|------------------|---------|------|-----------------|---|------------------|
| config43         | 0x2B    | 15:0 | iotest_pattern6 | Dataword6 in the IO test pattern. It is used with the seven other words to test the input data. | 0xAAAA           |

### Table 56. Register Name: config44 - Address: 0x2C, Default: 0xC6C6

| Register<br>Name | Address | Bit  | Name            | Function  |        |  |  |  |
|------------------|---------|------|-----------------|---|--------|--|--|--|
| config44         | 0x2C    | 15:0 | iotest_pattern7 | Dataword7 in the IO test pattern. It is used with the seven other words to test the input data. | 0xC6C6 |  |  |  |

### Table 57. Register Name: config45 - Address: 0x2D, Default: 0x0004

| Register<br>Name | Address | Bit  | Name          | Function   | Default<br>Value     |
|------------------|---------|------|---------------|--|----------------------|
| config45         | 0x2D    | 15   | reserved      | Reserved for factory use   | 0                    |
|                  |         | 14   | ostrtodig_sel | When set, the OSTR signal is passed directly to the digital block. This is the signal that is used to clock the dividers.                                      | 0                    |
|                  |         | 13   | ramp_ena      | When set, a ramp signal is inserted in the input data at the FIFO input.   | 0                    |
|                  |         | 12:1 | Reserved      | Reserved for factory use.  | 0000<br>0000<br>0010 |
|                  |         | 0    | sifdac_ena    | When set, the DAC output is set to the value in sifdac(15:0) in register <i>config48</i> . In this mode, sif_txena in config3 and TXENABLE inputs are ignored. | 0                    |

## Table 58. Register Name: config46 - Address: 0x2E, Default: 0x0000

| Register<br>Name | Address Bit Name |      | Name            | Function   |      |  |  |
|------------------|------------------|------|-----------------|--|------|--|--|
| config46         | 0x2E             | 15:8 | grp_delayA(7:0) | Sets the group delay function for DACA. The maximum delay ranges from 30 ps to 100 ps and is dependent on DAC sample clock. Contact TI for specific application information. | 0x00 |  |  |
|                  |                  | 7:0  | grp_delayB(7:0) | Sets the group delay function for DACB. The maximum delay ranges from 30 ps to 100 ps and is dependent on DAC sample clock. Contact TI for specific application information. | 0x00 |  |  |

### Table 59. Register Name: config47 - Address: 0x2F, Default: 0x0000

| Register<br>Name | Address | Bit  | Name            | Function   |      |  |  |
|------------------|---------|------|-----------------|--|------|--|--|
| config47         | 0x2F    | 15:8 | grp_delayC(7:0) | Sets the group delay function for DACC. The maximum delay ranges from 30 ps to 100 ps and is dependent on DAC sample clock. Contact TI for specific application information. | 0x00 |  |  |
|                  |         | 7:0  | grp_delayD(7:0) | Sets the group delay function for DACD. The maximum delay ranges from 30 ps to 100 ps and is dependent on DAC sample clock. Contact TI for specific application information. | 0x00 |  |  |



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## Table 60. Register Name: config48 - Address: 0x30, Default: 0x0000

| Register<br>Name | Address | Bit  | Name         | Function  |        |  |
|------------------|---------|------|--------------|---|--------|--|
| config48         | 0x30    | 15:0 | sifdac(15:0) | Value sent to the DACs when <code>sifdac_ena</code> is asserted. DATACLK must be running to latch this value into the DACs. The format would be based on <code>twos</code> in register <code>config2</code> . | 0x0000 |  |

### Table 61. Register Name: Version – Address: 0x7F, Default: 0x540C (Read Only)

| Register<br>Name | Address            | Bit   | Name           | Function  | Default<br>Value |
|------------------|--------------------|-------|----------------|---|------------------|
| version          | 0x7F               | 15:10 | Reserved       | Reserved for factory use.                                   | 010101           |
|                  | 9 Reserved Reserve |       | Reserved       | Reserved for factory use.                                   | 0                |
|                  |                    | 8:7   | Reserved       | Reserved for factory use.                                   | 00               |
|                  |                    | 6:5   | Reserved       | Reserved for factory use.                                   | 00               |
|                  |                    | 4:3   | deviceid(1:0)  | Returns 01b for DAC3484.                                    | 01               |
|                  |                    | 2:0   | versionid(2:0) | A hardwired register that contains the version of the chip. | 100              |



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### 8 Application and Implementation

#### **NOTE**

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

## 8.1 Application Information

The DAC3484 is a quad 16-bit DAC with max input data rate of up to 312.5 MSPS per DAC and max DAC update rate of 1.25 GSPS after the final, selectable interpolation stages. With build-in interpolation filter of 2x, 4x, 8x, and 16x options, the lower input data rate can be interpolated all the way to 1.25 GSPS. This allows the DAC to update the samples at higher rate, and pushes the DAC images further away to relax anti-image filer specification due to the increased Nyquist bandwidth. With integrated coarse and fine mixers, baseband signal can be upconverted to an intermediate frequency (IF) signal between the baseband processor and post-DAC analog signal chains.

The DAC can output baseband or IF when connected to post-DAC analog signals chain components such as transformers or IF amplifiers. When used in conjunction with TI RF quadrature modulator such as the TRF3705, the DAC and RF modulator can function as a set of baseband or IF upconverter. With integrated QMC circuits, the LO offset and the sideband artifacts can be properly corrected in the direct up-conversion applications. The DAC3484 provides the bandwidth, performance, small footprint, and lower power consumption needed for multimode 2G/3G/4G cellular base stations to migrate to more advanced technologies, such as LTE-Advanced and carrier aggregation on multiple antennas.

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## 8.2 Typical Applications

### 8.2.1 IF Based LTE Transmitter

Figure 91 shows an example block diagram for a direct conversion radio. The design requires a single carrier, 20-MHz LTE signal. The system has digital-predication (DPD) to correct up to 5th order distortion so the total DAC output bandwidth is 100 MHz. Interpolation is used to output the signal at highest sampling rate possible to simplify the analog filter requirements and move high order harmonics out of band (due to wider Nyquist zone). The internal PLL is used to generate the final DAC output clock from a reference clock of 491.52 MHz.

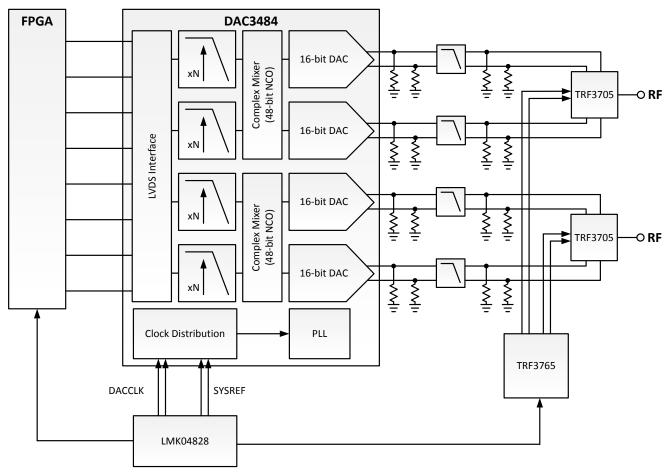


Figure 91. Dual Low-IF Wideband LTE Transmitter Diagram

#### 8.2.1.1 Design Requirements

For this design example, use the parameters listed in Table 62 as the input parameters.

**Table 62. Design Parameters** 

| DESIGN PARAMETER                                  | EXAMPLE VALUE |
|---|---------------|
| Signal Bandwidth (BW <sub>signal</sub> )          | 20 MHz        |
| Total DAC Output Bandwidth (BW <sub>total</sub> ) | 100 MHz       |
| DAC PLL   | On            |
| DAC PLL Reference Frequency                       | 491.52 MHz    |
| Maximum FPGA LVDS Rate                            | 491.52 Mbps   |

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### 8.2.1.2 Detailed Design Procedure

#### 8.2.1.2.1 Data Input Rate

Nyquist theory states that the data rate must be at least two times the highest signal frequency. The data will be sent to the DAC as complex baseband data. Due to the quadrature nature of the signal, each in-phase (I component) and quadrature (Q component) need to have 50 MHz of bandwidth to construct 100 MHz of complex bandwidth. Since the interpolation filter design is not the ideal half-band filter design with infinite roll-off at FDATA/2 (refer to FIR Filters section for more detail), the filter limits the useable input bandwidth to about 40 percent of FDATA. Therefore, the minimum data input rate is 125 MSPS. Since the standard telecom data rate is typically multiples of 30.72 MSPS, the DAC input data rate is chosen to be eight times of 30.72 MSPS, which is 245.76 MSPS.

#### 8.2.1.2.2 Interpolation

It is desired to use the highest DAC output rate as possible to move the DAC images further from the signal of interest to ease analog filter requirement. The DAC output rate must be greater than two times the highest output frequency of 200 MHz, which is greater than 400 MHz. Table 63 shows the possible DAC output rates based on the data input rate and available interpolation settings. The DAC image frequency is also listed.

**LOWEST IMAGE DISTANCE FROM BAND OF** INTERPOLATION POSSIBLE? F<sub>DATA</sub> FDAC **FREQUENCY INTEREST** 245.76 MSPS 245.76 MSPS No N/A N/A 245.76 MSPS 2 491.52 MSPS 318.64 MHz 145.76 MHz Yes 245.76 MSPS 4 983.04 MSPS Yes 810.16 MHz 637.28 MHz 245.76 MSPS 8 1966.08 MSPS No N/A N/A 245.76 MSPS 16 3932.16 MSPS No N/A N/A

**Table 63. Interpolation** 

### 8.2.1.2.3 LO Feedthrough and Sideband Correction

For typical IF based systems, the IF location is selected such that the image location and the LO feedthrough location is far from the signal location. The minimum distance is based on the bandpass filter roll-off and attenuation level at the LO feedthrough and image location. If sufficient attenuation level of these two artifacts meets the system requirement, then further digital cancellation of these artifacts may not be needed.

Although the I/Q modulation process will inherently reduce the level of the RF sideband signal, an IF based transmitter without sufficient RF image rejection capabilities or an zero-IF based system (detail in the next section) will likely need additional sideband suppression to maximize performance. Further, any mixing process will result in some feedthrough of the LO source. The DAC3484 has build-in digital features to cancel both the LO feedthrough and sideband signal. The LO feedthrough is corrected by adding a DC offset to the DAC outputs until the LO feedthrough power is suppressed. The sideband suppression can be improved by correcting the gain and phase differences between the I and Q analog outputs through the digital QMC block. Besides gain and phase differences between the I and Q analog outputs, group delay differences may also be present in the signal path and are typically contributed by group delay variations of post DAC image reject analog filters and PCB trace variations. Since delay in time translates to higher order linear phase variation, the sideband of a wideband system may not be completely suppressed by typical digital QMC block. The DAC3484 has integrated group delay correction feature to provide delay adjustments. (The maximum group delay correction ranges from 30 ps to 100 ps and is dependent on DAC sample clock. Contact TI for specific application information.) Moreover, system designer may implement additional linear group delay compensation in the host processor to the DAC to perform higher order sideband suppression.

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### 8.2.1.3 Application Curves

The ACPR performance for LTE 20 MHz TM1.1 are shown in Figure 92, Figure 93, Figure 93, and Figure 93. The figures provide comparisons between two major LTE bands such as 2.14 GHz and 2.655 GHz, and also comparisons between two different DAC clocking options such as DAC on-chip PLL mode and external clocking mode.

Product Folder Links: DAC3484

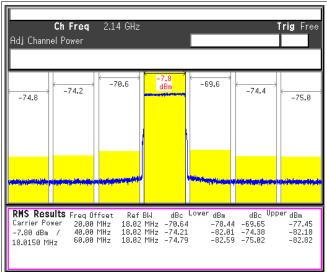
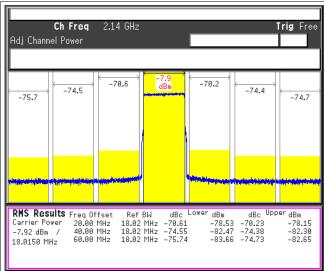


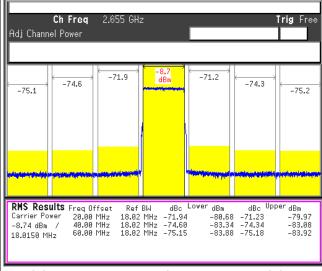


Figure 92. 20MHz TM1.1 LTE Carrier at 2.14GHz



DAC Output IF = 122.88 MHz, LO = 2017.12 MHz, DAC Clock = DAC3484 On-Chip PLL

Figure 93. 20MHz TM1.1 LTE Carrier at 2.14GHz



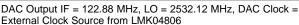
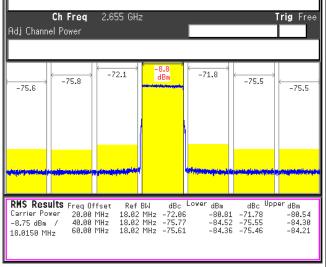


Figure 94. 20MHz TM1.1 LTE Carrier at 2.655GHz



DAC Output IF = 122.88 MHz, LO = 2532.12 MHz, DAC Clock = DAC3484 On-Chip PLL

Figure 95. 20MHz TM1.1 LTE Carrier at 2.655GHz

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### 8.2.2 Direct Upconversion (Zero IF) LTE Transmitter

Figure 91 shows an example block diagram for a direct conversion radio. The design specification requires that the desired output bandwidth is 40 MHz, which could be, for instance, a typical LTE signal. The system has DPD to correct up to 5th order distortion so the total DAC output bandwidth is 200 MHz. Interpolation is used to output the signal at the highest sampling rate possible to simplify the analog filtering requirements and move high order harmonics out of band (due to wider Nyquist zone). The DAC sampling clock is provided by high quality clock synthesizer such as the LMK0480x family.

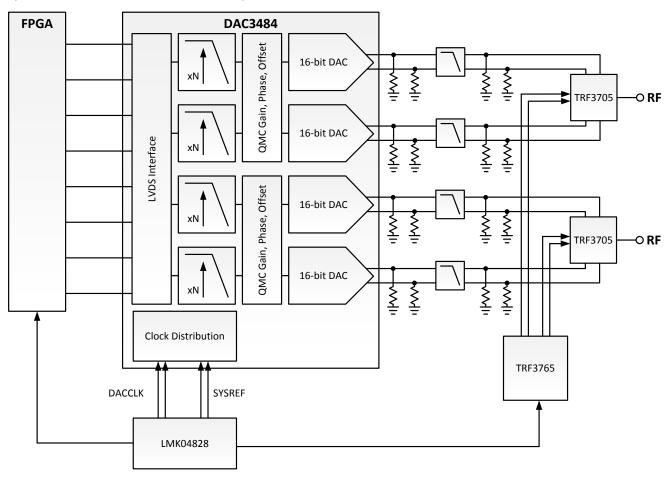


Figure 96. Zero LTE Transmitter Diagram

### 8.2.2.1 Design Requirements

For this design example, use the parameters listed in Table 64 as the input parameters.

**Table 64. Design Parameters** 

| DESIGN PARAMETER                                  | EXAMPLE VALUE |
|---|---------------|
| Signal Bandwidth (BW <sub>signal</sub> )          | 40 MHz        |
| Total DAC Output Bandwidth (BW <sub>total</sub> ) | 200 MHz       |
| DAC PLL   | Off           |
| Maximum FPGA LVDS Rate                            | 1228.8 Mbps   |

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## 8.2.2.2 Detailed Design Procedure

#### 8.2.2.2.1 Data Input Rate

Nyquist theory states that the data rate must be at least two times the highest signal frequency. The data will be sent to the DAC as complex baseband data. Due to the quadrature nature of the signal, each in-phase (I component) and quadrature (Q component) need to have 100 MHz of bandwidth to construct 200 MHz of complex bandwidth. Since the interpolation filter design is not the ideal half-band filter design with infinite roll-off at FDATA/2 (refer to *FIR Filters* section for more detail), the filter limits the useable input bandwidth to about 44 percent of FDATA with less than 0.1dB of FIR filter roll-off. Therefore, the minimum data input rate is 228 MSPS. Since the standard telecom data rate is typically multiples of 30.72 MSPS, the DAC input data rate is chosen to be 10 times of 30.72 MSPS, which is 307.2 MSPS.

#### 8.2.2.2.2 Interpolation

It is desired to use the highest DAC output rate as possible to move the DAC images further from the signal of interest to ease analog filter requirement. The DAC output rate must be greater than two times the highest output frequency of 100 MHz, which is greater than 200 MHz. The table below shows the possible DAC output rates based on the data input rate and available interpolation settings. The DAC image frequency is also listed.

**Table 65. Interpolation** 

| F <sub>DATA</sub> | INTERPOLATION | F <sub>DAC</sub> | POSSIBLE? | LOWEST IMAGE<br>FREQUENCY | DISTANCE FROM BAND OF INTEREST |
|-------------------|---------------|------------------|-----------|---------------------------|--------------------------------|
| 307.2 MSPS        | 1             | 307.2 MSPS       | Yes       | 287.2 MHz                 | 267.2 MHz                      |
| 307.2 MSPS        | 2             | 614.4 MSPS       | Yes       | 594.4 MHz                 | 574.4 MHz                      |
| 307.2 MSPS        | 4             | 1228.8 MSPS      | Yes       | 1208.8                    | 1188.8                         |
| 307.2 MSPS        | 8             | 2457.6 MSPS      | No        | N/A                       | N/A                            |
| 307.2 MSPS        | 16            | 4915.2 MSPS      | No        | N/A                       | N/A                            |

### 8.2.2.2.3 LO Feedthrough and Sideband Correction

Refer to LO Feedthrough and Sideband Correction section of IF based LTE Transmitter design.

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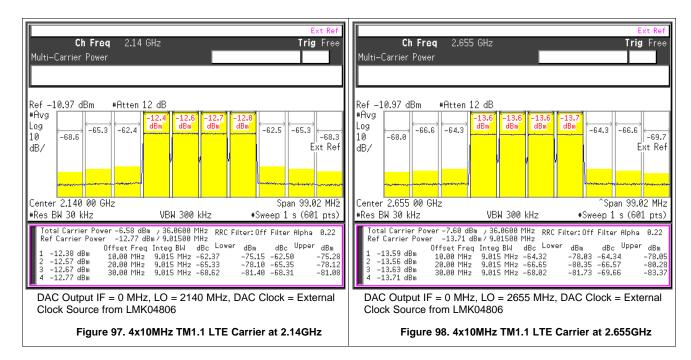


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## 8.2.2.3 Application Curves

The ACPR performance for LTE 20MHz TM1.1 are shown in Figure 97 and Figure 98. The figures provide comparisons between two major LTE bands such as 2.14 GHz and 2.655 GHz with DAC clocking option set to external clocking mode.



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### 9 Power Supply Recommendations

As shown in Figure 99, the DAC3484 device has various power rails and has two primary voltages of 1.2 V and 3.3 V. Some of the DAC power rails such as CLKVDD and AVDD are more noise sensitive than other rails because they are mainly powering the switch drivers for the current switch array and the current bias circuits, respectively. These circuits are the main analog DAC core. Any power supply noises such as switching power supply ripple may be modulated directly onto the signal of interest. These two power rails should be powered by low noise power supplies such as LDO. Powering the rail directly with switching power supplies is not recommended for these two rails.

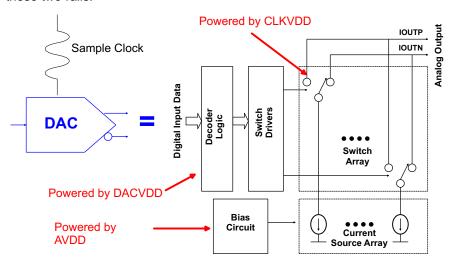


Figure 99. Interpolation Filters, NCOs, and QMC Blocks Powered by DIGVDD

With the DAC3484 being a mixed signal device, the device contains circuits that bridges the digital section and the analog section. The DACVDD powers these sections. System designer can design this rail in secondary priority. Powering the rail with LDO is recommended. Unless system designer pays special care to supply filtering and power supply routing/placement, powering the rail directly with switching power supplies is not recommended for this rail.

Since digital circuits have more inherent noise immunity than analog circuits, the power supply noise requirements for DIGVDD of the digital section of the device may be relaxed and placed at a lower priority. Depending on the spur level requirement, routing and placement of the power supply, power the rail directly with switching power supplies can be possible. With the digital logics running, the DIGVDD rail may draw significant current. If the power supply traces and filtering network have significant DC resistance loss (for example, DCR), then the final supply voltage seen by the DIGVDD rail may not be sufficient to meet the minimum power supply level. For instance, with 450 mA of DIGVDD current and about 0.1  $\Omega$  of DCR from the ferrite bead, the final supply voltage at the DIGVDD pins may be 1.2 V - 0.045 V = 1.155 V. This is fairly close to the minimum supply voltage range of 1.14 V. System designer may need to elevate the power supply voltage according to the DCR level or design a feedback network for the power supply to account for associated voltage drop. To ensure power supply accuracy and to account for power supply filter network loss at operating conditions, the use of the ATEST function in register config27 to check the internal power supply nodes is recommended.

The table below is a summary of the various power supply nodes of the DAC. Care should be taken to keep clean power supplies routing away from noisy digital supplies. It is recommended to use at least two power layers. Power supplies for digital circuits tend to have more switching activities and are typically noisier, and system designer should avoid sharing the digital power rail (for example, power supplies for FPGA or DIGVDD of DAC3484) with the analog power rail (for example, CLKVDD and AVDD of DAC3484). Avoid placing noisy supplies and clean supplies on adjacent board layers and use a ground layer between these two supplies if possible. All supply pins should be decoupled as close to the pins as possible by using small value capacitors, with larger bulk capacitors placed further away and near the power supply source.

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#### Table 66. Power Rails

| POWER<br>RAILS | TYPICAL<br>VOLTAGE | NOISE<br>SENSITIVITY | RECOMMENDATIONS  | POWER<br>SUPPLY<br>DESIGN<br>PRIORITY |
|----------------|--------------------|----------------------|--|---------------------------------------|
| CLKVDD         | 1.2 V              | High                 | Provide clean supply to the rail. Avoid spurious noise or coupling from other supplies | High                                  |
| AVDD           | 3.3 V              | High                 | Provide clean supply to the rail. Avoid spurious noise or coupling from other supplies | High                                  |
| DACVDD         | 1.2 V              | Medium               | Provide clean supply to the rail. Avoid spurious noise or coupling from other supplies | Medium                                |
| DIGVDD         | 1.2 V              | Low                  | Keep Away from other noise sensitive nodes in placement and routing.                   | Low                                   |

## 10 Layout

### 10.1 Layout Guidelines

The design of the PCB is critical to achieve the full performance of the DAC3484 device. Defining the PCB stackup should be the first step in the board design. Experience has shown that at least six layers are required to adequately route all required signals to and from the device. Each signal routing layer must have an adjacent solid ground plane to control signal return paths to have minimal loop areas and to achieve controlled impedances for microstrip and stripline routing. Power planes must also have adjacent solid ground planes to control supply return paths. Minimizing the space between supply and ground planes improves performance by increasing the distributed decoupling.

Although the DAC3484 device consists of both analog and digital circuitry, TI highly recommends solid ground planes that encompass the device and its input and output signal paths. TI does not recommend split ground planes that divide the analog and digital portions of the device. Split ground planes may improve performance if a nearby, noisy, digital device is corrupting the ground reference of the analog signal path. When split ground planes are employed, one must carefully control the supply return paths and keep the paths on top of their respective ground reference planes.

Quality analog output signals and input conversion clock signal path layout is required for full dynamic performance. Symmetry of the differential signal paths and discrete components in the path is mandatory, and symmetrical shunt-oriented components should have a common grounding via. The high frequency requirements of the analog output and clock signal paths necessitate using differential routing with controlled impedances and minimizing signal path stubs (including vias) when possible.

Coupling onto or between the clock and output signals paths should be avoided using any isolation techniques available including distance isolation, orientation planning to prevent field coupling of components like inductors and transformers, and providing well coupled reference planes. Via stitching around the clock signal path and the input analog signal path provides a quiet ground reference for the critical signal paths and reduces noise coupling onto these paths. Sensitive signal traces must not cross other signal traces or power routing on adjacent PCB layers, rather a ground plane must separate the traces. If necessary, the traces should cross at 90° angles to minimize crosstalk.

The substrate (dielectric) material requirements of the PCB are largely influenced by the speed and length of the high speed serial lanes. Affordable and common FR4 varieties are adequate in most cases.

Coupling of ambient signals into the signal path is reduced by providing quiet, close reference planes and by maintaining signal path symmetry to ensure the coupled noise is common-mode. Faraday caging may be used in very noise environment and high dynamic range applications to isolate the signal path.

The following layout guidelines correspond to the layout shown in Figure 100.

- 1. DAC output termination resistors should be placed as close to the output pins as possible to provide a DC path to ground and set the source impedance matching.
- 2. For DAC on-chip PLL clocking mode, if the external loop filter is not used, leave the loop filter pin floating without any board routing nearby. Signals coupling to this node may cause clock mixing spurs in the DAC output.
- 3. Route the high speed LVDS lanes as impedance-controlled, tightly-coupled, differential traces.

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### **Layout Guidelines (continued)**

- 4. Maintain a solid ground plane under the LVDS lanes without any ground plane splits.
- 5. Simulation of the LVDS channel with DAC3484 IBIS model is recommended to verify good eye opening of the data patterns.
- 6. Keep the OSTR signal routing away from the DACCLK routing to reduce coupling.
- 7. Keep routing for RBIAS short, for instance a resistor can be placed on the board directly connecting the RBIAS pin to the ground layer.

The following layout guidelines correspond to the layouts shown in Figure 101 and Figure 102.

- 1. Noise power supplies should be routed away from clean supplies. Use two power plane layers, preferably with a ground layer in between.
- 2. As shown in Figure 101 and Figure 102, both layers three and four are designated for power supply planes. The DAC analog powers are all in the same layer to avoid coupling with each other, and the planes are copied from layer three to layer four for double the copper coverage area.
- 3. Decoupling capacitors should be placed as close to the supply pins as possible. For instance, a capacitor can be placed on the bottom of the board directly connecting the supply pin to a ground layer.

### 10.1.1 Assembly

Information regarding the package and assembly of the WQFN-MR package version of the DAC3484 can be found at the end of the data sheet and also on the following application note: SZZA059

Information regarding the package and assembly of the ZAY package version of the DAC3484 can be found at the end of the data sheet and also on the following application note: SPRAA99

### 10.2 Layout Examples

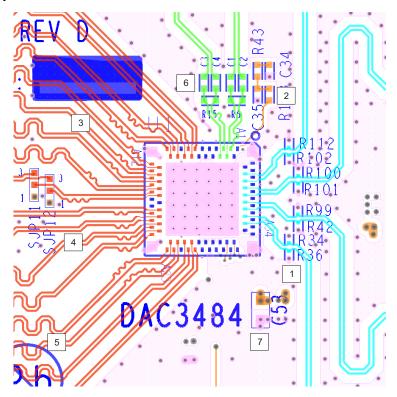


Figure 100. Top Layer of DAC3484 Layout Showing High Speed Signals such as LVDS Bus, DACCLK, OSTR, and DAC Outputs. Layout Example from TSW3085EVM Rev D

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## **Layout Examples (continued)**

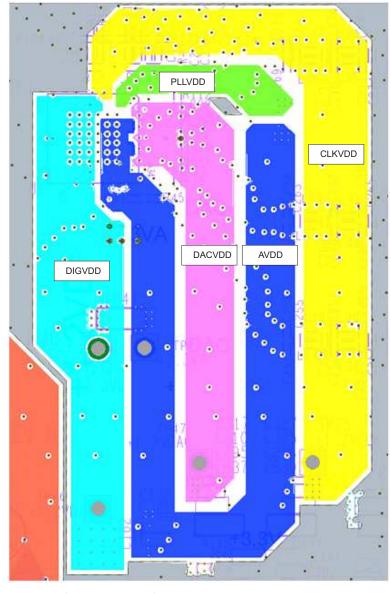


Figure 101. Third Layer of DAC3484 Layout Showing Power Layers. Layout Example from DAC3484EVM Rev H

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## **Layout Examples (continued)**



Figure 102. Fourth Layer of DAC3484 Layout Showing Power Layers. Layout Example from DAC3484EVM Rev H

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### 11 Device and Documentation Support

### 11.1 Device Support

#### 11.1.1 Third-Party Products Disclaimer

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#### 11.1.2 Device Nomenclature

#### 11.1.2.1 Definition of Specifications

**Adjacent Carrier Leakage Ratio (ACLR):** Defined for a 3.84Mcps 3GPP W-CDMA input signal measured in a 3.84-MHz bandwidth at a 5-MHz offset from the carrier with a 12dB peak-to-average ratio.

Analog and Digital Power Supply Rejection Ratio (APSSR, DPSSR): Defined as the percentage error in the ratio of the delta IOUT and delta supply voltage normalized with respect to the ideal IOUT current.

**Differential Nonlinearity (DNL):** Defined as the variation in analog output associated with an ideal 1 LSB change in the digital input code.

**Gain Drift:** Defined as the maximum change in gain, in terms of ppm of full-scale range (FSR) per °C, from the value at ambient (25°C) to values over the full operating temperature range.

**Gain Error:** Defined as the percentage error (in FSR%) for the ratio between the measured full-scale output current and the ideal full-scale output current.

**Integral Nonlinearity (INL):** Defined as the maximum deviation of the actual analog output from the ideal output, determined by a straight line drawn from zero scale to full scale.

**Intermodulation Distortion (IMD3):** The two-tone IMD3 is defined as the ratio (in dBc) of the 3rd-order intermodulation distortion product to either fundamental output tone.

**Offset Drift:** Defined as the maximum change in DC offset, in terms of ppm of full-scale range (FSR) per °C, from the value at ambient (25°C) to values over the full operating temperature range.

**Offset Error:** Defined as the percentage error (in FSR%) for the ratio between the measured mid-scale output current and the ideal mid-scale output current.

**Output Compliance Range:** Defined as the minimum and maximum allowable voltage at the output of the current-output DAC. Exceeding this limit may result reduced reliability of the device or adversely affecting distortion performance.

**Reference Voltage Drift:** Defined as the maximum change of the reference voltage in ppm per degree Celsius from value at ambient (25°C) to values over the full operating temperature range.

**Spurious Free Dynamic Range (SFDR):** Defined as the difference (in dBc) between the peak amplitude of the output signal and the peak spurious signal within the first Nyquist zone.

**Noise Spectral Density (NSD):** Defined as the difference of power (in dBc) between the output tone signal power and the noise floor of 1-Hz bandwidth within the first Nyquist zone.

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### 11.2 Documentation Support

#### 11.2.1 Related Documentation

- Design Summary Multi-row Quad Flat No-lead (MRQFN) Application Report (SZZA059)
- nFBGA Packaging Application Report (SPRAA99)
- DAC348x Device Configuration and Synchronization Application Report (SLAA584)
- Semiconductor and IC Package Thermal Metrics Application Report (SPRA953)
- Using DAC348x with Fault Detection and Auto Output Shut-off Feature Application Report (SLAA585)

### 11.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.4 Trademarks

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

## 11.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 11.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

### 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



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PACKAGE OPTION ADDENDUM

29-Oct-2015

#### PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package<br>Drawing | Pins | Package<br>Qty |                            | Lead/Ball Finish | MSL Peak Temp              | Op Temp (°C) | Device Marking    | Samples |
|------------------|--------|--------------|--------------------|------|----------------|----------------------------|------------------|----------------------------|--------------|-------------------|---------|
| DAC3484IRKD25    | ACTIVE | WQFN-MR      | RKD                | 88   | 25             | Green (RoHS<br>& no Sb/Br) | (6)<br>CU NIPDAU | (3)<br>Level-3-260C-168 HR | -40 to 85    | (4/5)<br>DAC3484I | Samples |
| DAC3484IRKDR     | ACTIVE | WQFN-MR      | RKD                | 88   | 2000           | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-3-260C-168 HR        | -40 to 85    | DAC3484I          | Samples |
| DAC3484IRKDT     | ACTIVE | WQFN-MR      | RKD                | 88   | 250            | Green (RoHS<br>& no Sb/Br) | CU NIPDAU        | Level-3-260C-168 HR        | -40 to 85    | DAC3484I          | Samples |
| DAC3484IZAY      | ACTIVE | NFBGA        | ZAY                | 196  | 160            | Green (RoHS<br>& no Sb/Br) | SNAGCU           | Level-3-260C-168 HR        | -40 to 85    | DAC3484I          | Samples |
| DAC3484IZAYR     | ACTIVE | NFBGA        | ZAY                | 196  | 1000           | Green (RoHS<br>& no Sb/Br) | SNAGCU           | Level-3-260C-168 HR        | -40 to 85    | DAC3484I          | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based filip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): Ti defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device

Addendum-Page 1



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PACKAGE OPTION ADDENDUM

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(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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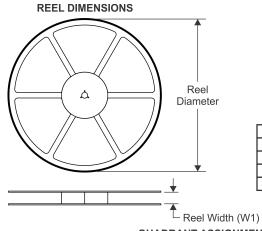
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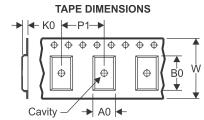


## **PACKAGE MATERIALS INFORMATION**

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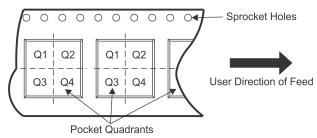
### TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width     |
|----|---|
| B0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device       | Package<br>Type | Package<br>Drawing |    |      | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|--------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| DAC3484IRKDR | WQFN-<br>MR     | RKD                | 88 | 2000 | 330.0                    | 16.4                     | 9.3        | 9.3        | 1.5        | 12.0       | 16.0      | Q2               |
| DAC3484IRKDT | WQFN-<br>MR     | RKD                | 88 | 250  | 330.0                    | 16.4                     | 9.3        | 9.3        | 1.5        | 12.0       | 16.0      | Q2               |



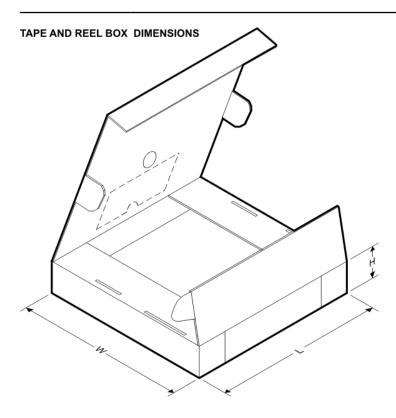
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#### \*All dimensions are nominal

| The difference are the final |              |     |          |      |             |            |             |  |  |  |
|------------------------------|--------------|-----|----------|------|-------------|------------|-------------|--|--|--|
| Device                       | Package Type |     | Pins SPQ |      | Length (mm) | Width (mm) | Height (mm) |  |  |  |
| DAC3484IRKDR                 | WQFN-MR      | RKD | 88       | 2000 | 336.6       | 336.6      | 28.6        |  |  |  |
| DAC3484IRKDT                 | WQFN-MR      | RKD | 88       | 250  | 336.6       | 336.6      | 28.6        |  |  |  |

**ZAY0196A** 

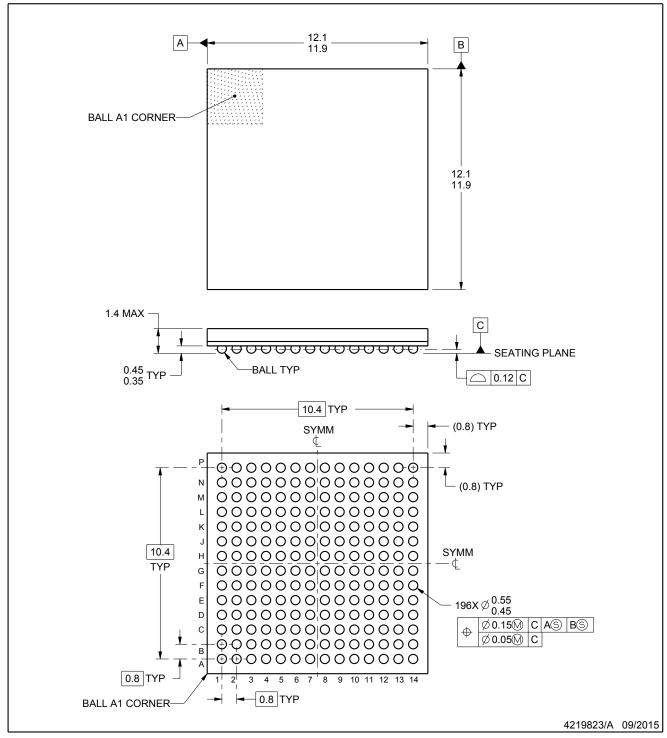
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## **PACKAGE OUTLINE**

## NFBGA - 1.4 mm max height

PLASTIC BALL GRID ARRAY



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.



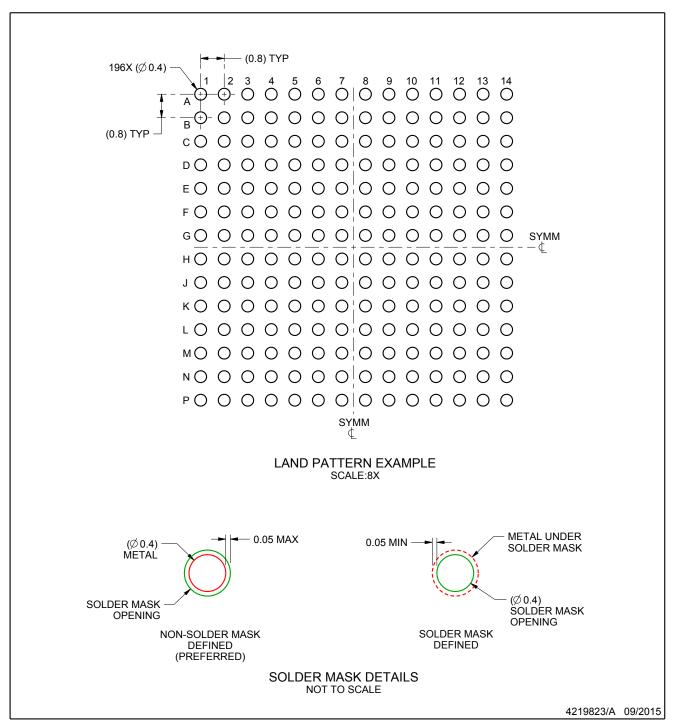


## **EXAMPLE BOARD LAYOUT**

## **ZAY0196A**

NFBGA - 1.4 mm max height

PLASTIC BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For information, see Texas Instruments literature number SPRAA99 (www.ti.com/lit/spraa99).



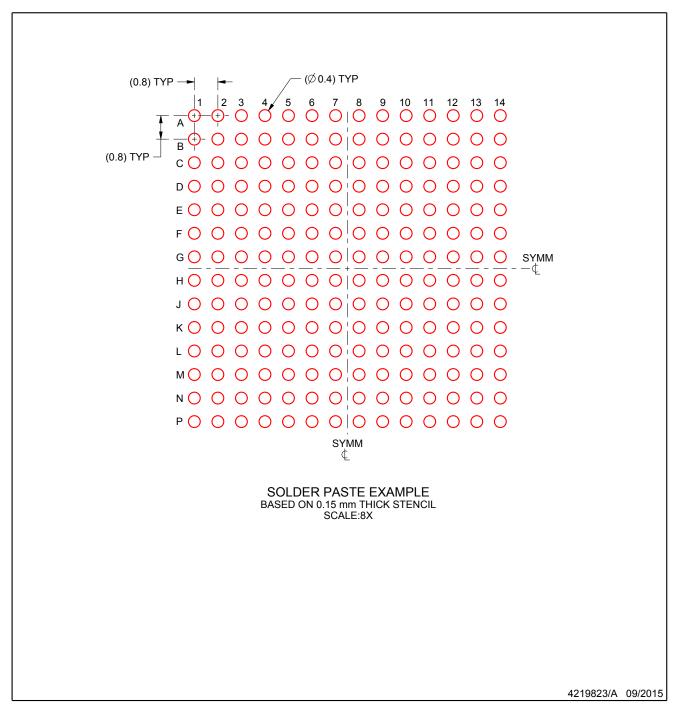


## **EXAMPLE STENCIL DESIGN**

## **ZAY0196A**

NFBGA - 1.4 mm max height

PLASTIC BALL GRID ARRAY



NOTES: (continued)

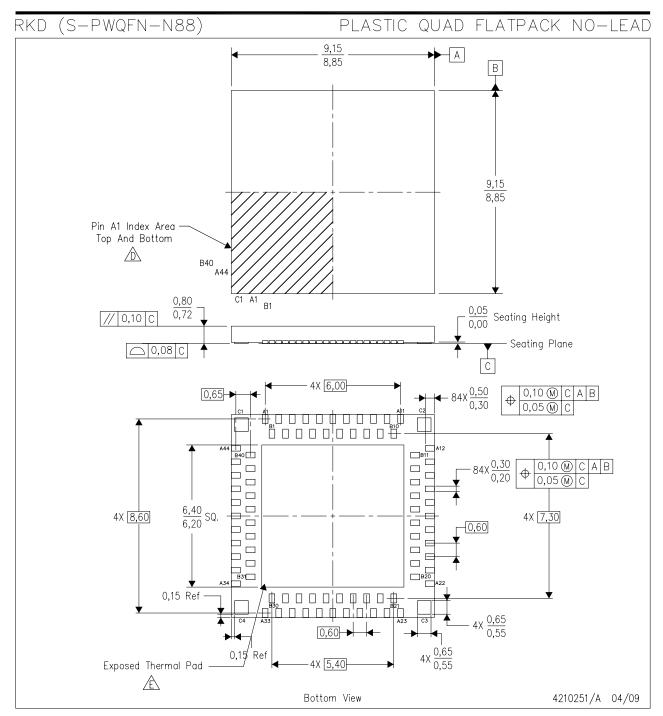
4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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MECHANICAL DATA



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) staggered multi-row package configuration.
- Pin A1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin A1 identifiers are either a molded, marked, or metal feature.
- The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.





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### THERMAL PAD MECHANICAL DATA

## RKD (S-MRQFN-N88)

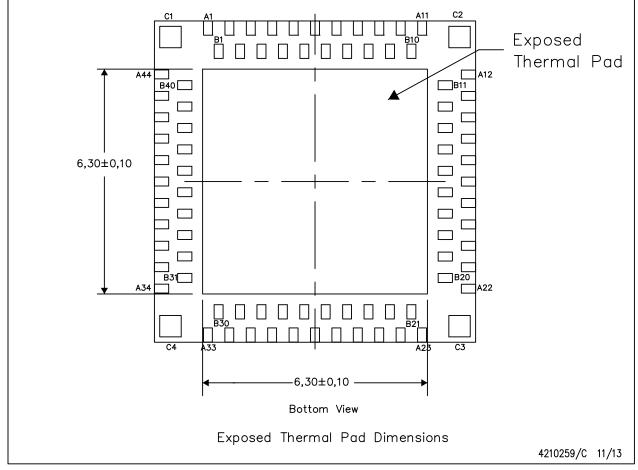
## PLASTIC QUAD FLATPACK NO-LEAD

### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

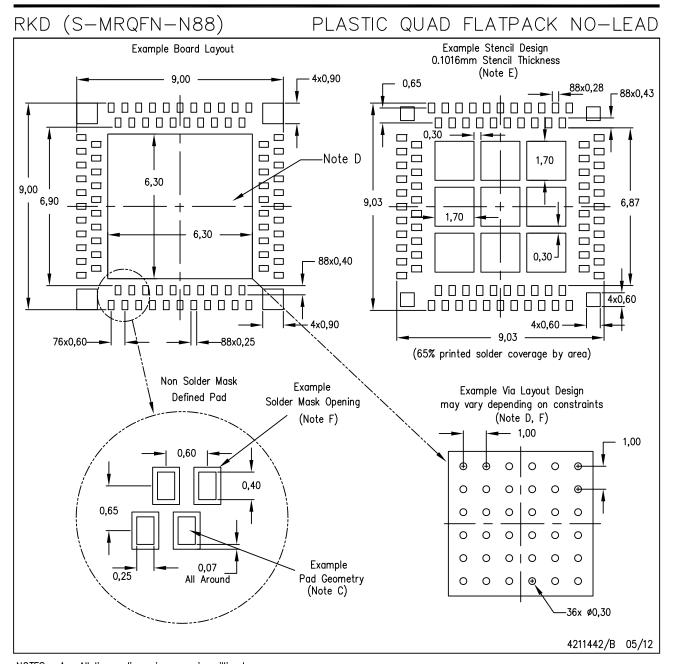


NOTE: All linear dimensions are in millimeters





### LAND PATTERN DATA



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.





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